



MACRONIX  
INTERNATIONAL Co., LTD.

**MX25L12850F**

---

# **MX25L12850F**

**3V, 128M-BIT [x 1/x 2/x 4]  
CMOS MXSMIO<sup>®</sup> (SERIAL MULTI I/O)  
RPMC FLASH MEMORY**





## 3V 128M-BIT [x 1/x 2/x 4] CMOS MXSMIO® (SERIAL MULTI I/O) RPMC FLASH MEMORY

### 1. FEATURES

#### GENERAL

- Supports Serial Peripheral Interface -- Mode 0 and Mode 3
- Single Power Supply Operation
  - 2.7 to 3.6 volt for read, erase, and program operations
- 128Mb: 134,217,728 x 1 bit structure or 67,108,864 x 2 bits (two I/O mode) structure or 33,554,432 x 4 bits (four I/O mode) structure
- Protocol Support
  - Single I/O, Dual I/O and Quad I/O
- Latch-up protected to 100mA from -1V to Vcc +1V
- Fast read for SPI mode
  - Support fast clock frequency for read operation as 104MHz
  - Support Fast Read, 2READ, DREAD, 4READ, QREAD instructions
- Default Quad I/O enable (QE bit=1), and can not be change
- Equal Sectors with 4K byte each, or Equal Blocks with 32K byte each or Equal Blocks with 64K byte each
  - Any Block can be erased individually
- Programming :
  - 256byte page buffer
  - Quad Input/Output page program(4PP) to enhance program performance
- Typical 100,000 erase/program cycles
- 20 years data retention

#### RPMC FEATURES

- **Support Replay Protection Monotonic Counter (RPMC)**
  - Four 32-bit Monotonic counters
  - Volatile HMAC Key register
  - Non-volatile Root Key registerRPMC related information is available at  
[https://downloadcenter.intel.com/Detail\\_Desc.aspx?agr=Y&DwnldID=22646](https://downloadcenter.intel.com/Detail_Desc.aspx?agr=Y&DwnldID=22646)

#### SOFTWARE FEATURES

- Input Data Format
  - 1-byte Command code
- Block lock protection
  - The BP0-BP3 and T/B status bit defines the size of the area to be protection against program and erase instructions
- Additional 4K bit security OTP
  - Features unique identifier
  - factory locked identifiable, and customer lockable
- Command Reset
- Program/Erase Suspend and Resume operation
- Electronic Identification
  - JEDEC 1-byte manufacturer ID and 2-byte device ID
  - RES command for 1-byte Device ID
  - REMS command for 1-byte manufacturer ID and 1-byte device ID
- Support Serial Flash Discoverable Parameters (SFDP) mode



**HARDWARE FEATURES**

- SCLK Input
  - Serial clock input
- SI/SIO0
  - Serial Data Input/Output
- SO/SIO1
  - Serial Data Input/Output
- SIO2
  - Serial Data Input/Output
- SIO3
  - Serial Data input/Output
- PACKAGE
  - 8-pin SOP (200mil)
  - 8-land WSON (6x5mm)
  - 8-pin PDIP (300mil)
  - **All devices are RoHS Compliant and Halogen-free**

## 2. GENERAL DESCRIPTION

MX25L12850F is 128Mb bits serial Flash memory, which is configured as 16,777,216 x 8 internally. When it is in two or four I/O mode, the structure becomes 67,108, 864 bits x 2 or 33,554,432 bits x 4. MX25L12850F feature a serial peripheral interface and software protocol allowing operation on a simple 3-wire bus while it is in single I/O mode. The three bus signals are a clock input (SCLK), a serial data input (SI), and a serial data output (SO). Serial access to the device is enabled by CS# input.

When it is in two I/O read mode, the SI pin and SO pin become SIO0 pin and SIO1 pin for address/dummy bits input and data output. When it is in four I/O read mode, the SI pin, SO pin become SIO0 pin, SIO1 pin, SIO2 pin and SIO3 pin for address/dummy bits input and data output.

The MX25L12850F MXSMIO® (Serial Multi I/O) provides sequential read operation on whole chip.

After program/erase command is issued, auto program/erase algorithms which program/erase and verify the specified page or sector/block locations will be executed. Program command is executed on byte basis, or page (256 bytes) basis, or word basis for erase command is executed on sector (4K-byte), block (32K-byte), or block (64K-byte), or whole chip basis.

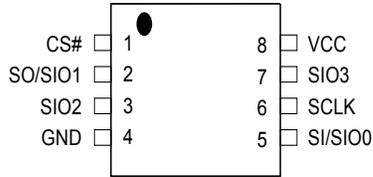
To provide user with ease of interface, a status register is included to indicate the status of the chip. The status read command can be issued to detect completion status of a program or erase operation via WIP bit.

When the device is not in operation and CS# is high, it is put in standby mode.

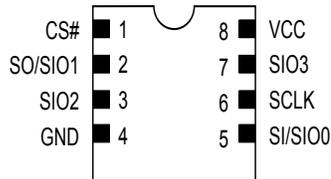
The MX25L12850F utilizes Macronix's proprietary memory cell, which reliably stores memory contents even after 100,000 program and erase cycles.

### 3. PIN CONFIGURATIONS

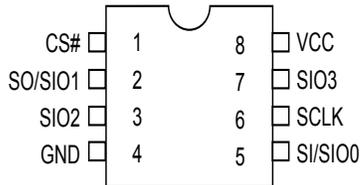
#### 8-PIN SOP (200mil)



#### 8-WSON (6x5mm)

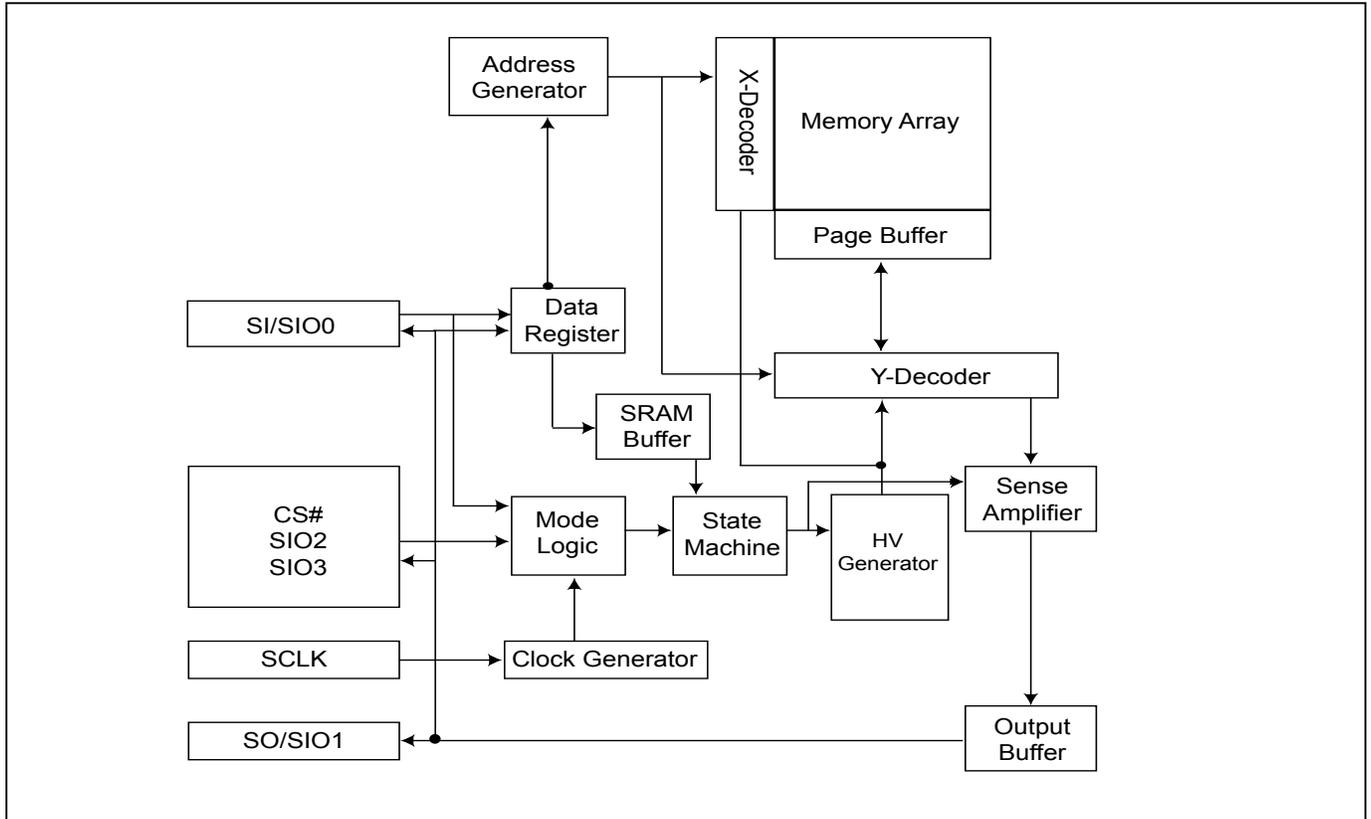


#### 8-PIN PDIP (300mil)



### 4. PIN DESCRIPTION

| SYMBOL  | DESCRIPTION                |
|---------|----------------------------|
| CS#     | Chip Select                |
| SI/SIO0 | Serial Data Input & Output |
| SO/SIO1 | Serial Data Input & Output |
| SCLK    | Clock Input                |
| SIO2    | Serial Data Input & Output |
| SIO3    | Serial Data Input & Output |
| VCC     | + 3V Power Supply          |
| GND     | Ground                     |

**5. BLOCK DIAGRAM**

## 6. DATA PROTECTION

During power transition, there may be some false system level signals which result in inadvertent erasure or programming. The device is designed to protect itself from these accidental write cycles.

The state machine will be reset as standby mode automatically during power up. In addition, the control register architecture of the device constrains that the memory contents can only be changed after specific command sequences have completed successfully.

In the following, there are several features to protect the system from the accidental write cycles during VCC power-up and power-down or from system noise.

- Valid command length checking: The command length will be checked whether it is at byte base and completed on byte boundary.
- Write Enable (WREN) command: WREN command is required to set the Write Enable Latch bit (WEL) before other command to change data.
- Deep Power Down Mode: By entering deep power down mode, the flash device also is under protected from writing all commands except Release from deep power down mode command (RDP) and Read Electronic Signature command (RES), and softreset command.

**I. Block lock protection**

- The Software Protected Mode (SPM) use (BP3, BP2, BP1, BP0 and T/B) bits to allow part of memory to be protected as read only. The protected area definition is shown as "Table 1. Protected Area Sizes", the protected areas are more flexible which may protect various area by setting value of BP0-BP3 bits.

**Table 1. Protected Area Sizes**

**Protected Area Sizes (T/B bit = 0)**

| Status bit |     |     |     | Protect Level                      |
|------------|-----|-----|-----|------------------------------------|
| BP3        | BP2 | BP1 | BP0 | 128Mb                              |
| 0          | 0   | 0   | 0   | 0 (none)                           |
| 0          | 0   | 0   | 1   | 1 (1 block, protected block 255th) |
| 0          | 0   | 1   | 0   | 2 (2 blocks, block 254th-255th)    |
| 0          | 0   | 1   | 1   | 3 (4 blocks, block 252nd-255th)    |
| 0          | 1   | 0   | 0   | 4 (8 blocks, block 248th-255th)    |
| 0          | 1   | 0   | 1   | 5 (16 blocks, block 240th-255th)   |
| 0          | 1   | 1   | 0   | 6 (32 blocks, block 224th-255th)   |
| 0          | 1   | 1   | 1   | 7 (64 blocks, block 192nd-255th)   |
| 1          | 0   | 0   | 0   | 8 (128 blocks, block 128th-255th)  |
| 1          | 0   | 0   | 1   | 9 (256 blocks, protected all)      |
| 1          | 0   | 1   | 0   | 10 (256 blocks, protected all)     |
| 1          | 0   | 1   | 1   | 11 (256 blocks, protected all)     |
| 1          | 1   | 0   | 0   | 12 (256 blocks, protected all)     |
| 1          | 1   | 0   | 1   | 13 (256 blocks, protected all)     |
| 1          | 1   | 1   | 0   | 14 (256 blocks, protected all)     |
| 1          | 1   | 1   | 1   | 15 (256 blocks, protected all)     |

**Protected Area Sizes (T/B bit = 1)**

| Status bit |     |     |     | Protect Level                             |
|------------|-----|-----|-----|---|
| BP3        | BP2 | BP1 | BP0 | 128Mb                                     |
| 0          | 0   | 0   | 0   | 0 (none)                                  |
| 0          | 0   | 0   | 1   | 1 (1 block, protected block 0th)          |
| 0          | 0   | 1   | 0   | 2 (2 blocks, protected block 0th~1th)     |
| 0          | 0   | 1   | 1   | 3 (4 blocks, protected block 0th~3rd)     |
| 0          | 1   | 0   | 0   | 4 (8 blocks, protected block 0th~7th)     |
| 0          | 1   | 0   | 1   | 5 (16 blocks, protected block 0th~15th)   |
| 0          | 1   | 1   | 0   | 6 (32 blocks, protected block 0th~31st)   |
| 0          | 1   | 1   | 1   | 7 (64 blocks, protected block 0th~63rd)   |
| 1          | 0   | 0   | 0   | 8 (128 blocks, protected block 0th~127th) |
| 1          | 0   | 0   | 1   | 9 (256 blocks, protected all)             |
| 1          | 0   | 1   | 0   | 10 (256 blocks, protected all)            |
| 1          | 0   | 1   | 1   | 11 (256 blocks, protected all)            |
| 1          | 1   | 0   | 0   | 12 (256 blocks, protected all)            |
| 1          | 1   | 0   | 1   | 13 (256 blocks, protected all)            |
| 1          | 1   | 1   | 0   | 14 (256 blocks, protected all)            |
| 1          | 1   | 1   | 1   | 15 (256 blocks, protected all)            |

**II. Additional 4K-bit secured OTP** for unique identifier: to provide 4K-bit one-time program area for setting device unique serial number - Which may be set by factory or system customer.

- Security register bit 0 indicates whether the chip is locked by factory or not.

- To program the 4K-bit secured OTP by entering 4K-bit secured OTP mode (with Enter Security OTP command), and going through normal program procedure, and then exiting 4K-bit secured OTP mode by writing Exit Security OTP command.

- Customer may lock-down the customer lockable secured OTP by writing WRSCUR(write security register) command to set customer lock-down bit1 as "1". Please refer to ["Table 8. Security Register Definition"](#) for security register bit definition and ["Table 2. 4K-bit Secured OTP Definition"](#) for address range definition.

- Note: Once lock-down whatever by factory or customer, it cannot be changed any more. While in 4K-bit secured OTP mode, array access is not allowed.

**Table 2. 4K-bit Secured OTP Definition**

| Address range | Size     | Standard Factory Lock          | Customer Lock          |
|---------------|----------|--------------------------------|------------------------|
| xxx000~xxx00F | 128-bit  | ESN (electrical serial number) | Determined by customer |
| xxx010~xxx1FF | 3968-bit | N/A                            |                        |

## 7. Memory Organization

Table 3. Memory Organization

| Block(64K-byte) | Block(32K-byte) | Sector | Address Range |         |
|-----------------|-----------------|--------|---------------|---------|
|                 |                 |        |               |         |
| 255             | 511             | 4095   | FFF000h       | FFFFFFh |
|                 |                 | ⋮      |               |         |
|                 |                 | 4088   | FF8000h       | FF8FFFh |
|                 | 510             | 4087   | FF7000h       | FF7FFFh |
|                 |                 | ⋮      |               |         |
|                 |                 | 4080   | FF0000h       | FF0FFFh |
| 254             | 509             | 4079   | FEF000h       | FEFFFFh |
|                 |                 | ⋮      |               |         |
|                 |                 | 4072   | FE8000h       | FE8FFFh |
|                 | 508             | 4071   | FE7000h       | FE7FFFh |
|                 |                 | ⋮      |               |         |
|                 |                 | 4064   | FE0000h       | FE0FFFh |
| 253             | 507             | 4063   | FDF000h       | FDFFFFh |
|                 |                 | ⋮      |               |         |
|                 |                 | 4056   | FD8000h       | FD8FFFh |
|                 | 506             | 4055   | FD7000h       | FD7FFFh |
|                 |                 | ⋮      |               |         |
|                 |                 | 4048   | FD0000h       | FD0FFFh |

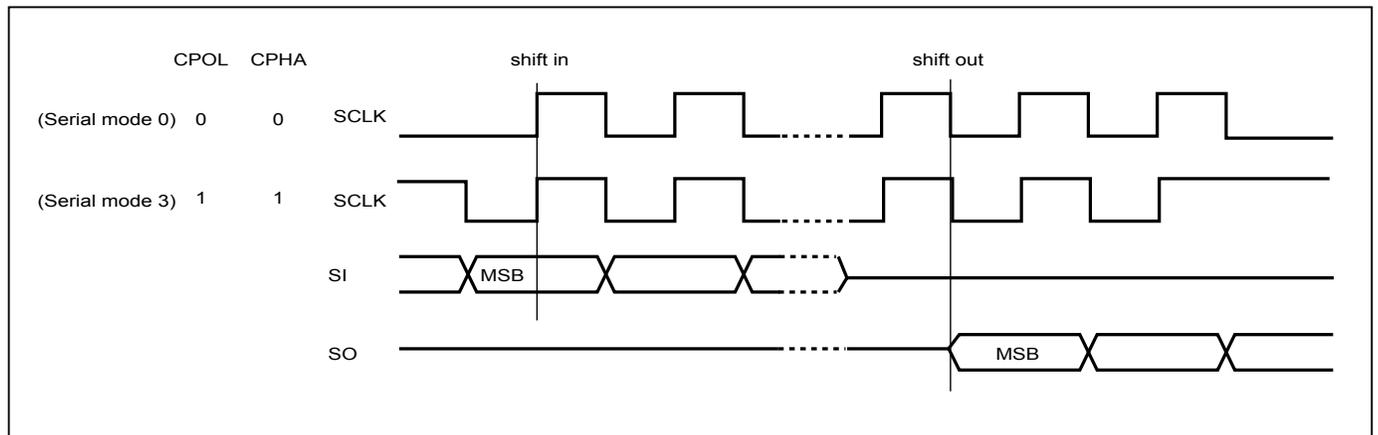


|   |   |    |         |         |
|---|---|----|---------|---------|
| 2 | 5 | 47 | 02F000h | 02FFFFh |
|   |   | ⋮  |         |         |
|   |   | 40 | 028000h | 028FFFh |
| 4 | 4 | 39 | 027000h | 027FFFh |
|   |   | ⋮  |         |         |
|   |   | 32 | 020000h | 020FFFh |
| 1 | 3 | 31 | 01F000h | 01FFFFh |
|   |   | ⋮  |         |         |
|   |   | 24 | 018000h | 018FFFh |
| 2 | 2 | 23 | 017000h | 017FFFh |
|   |   | ⋮  |         |         |
|   |   | 16 | 010000h | 010FFFh |
| 0 | 1 | 15 | 00F000h | 00FFFFh |
|   |   | ⋮  |         |         |
|   |   | 8  | 008000h | 008FFFh |
| 0 | 0 | 7  | 007000h | 007FFFh |
|   |   | ⋮  |         |         |
|   |   | 0  | 000000h | 000FFFh |

## 8. DEVICE OPERATION

1. Before a command is issued, status register should be checked to ensure device is ready for the intended operation.
2. When incorrect command is inputted to this device, this device becomes standby mode and keeps the standby mode until next CS# falling edge. In standby mode, SO pin of this device should be High-Z.
3. When correct command is inputted to this device, this device becomes active mode and keeps the active mode until next CS# rising edge.
4. Input data is latched on the rising edge of Serial Clock (SCLK) and data shifts out on the falling edge of SCLK. The difference of Serial mode 0 and mode 3 is shown as "Serial Modes Supported".
5. For the following instructions: RDID, RDSR, RDSCUR, READ, FAST\_READ, 2READ, DREAD, 4READ, QREAD, RDSFDP, RES, REMS, RDCR the shifted-in instruction sequence is followed by a data-out sequence. After any bit of data being shifted out, the CS# can be high. For the following instructions: WREN, WRDI, WRSR, SE, BE32K, BE, CE, PP, 4PP, DP, ENSO, EXSO, WRSCUR, SUSPEND, RESUME, NOP, RSTEN, RST the CS# must go high exactly at the byte boundary; otherwise, the instruction will be rejected and not executed.
6. During the progress of Write Status Register, Program, Erase operation, to access the memory array is neglected and not affect the current operation of Write Status Register, Program, Erase.

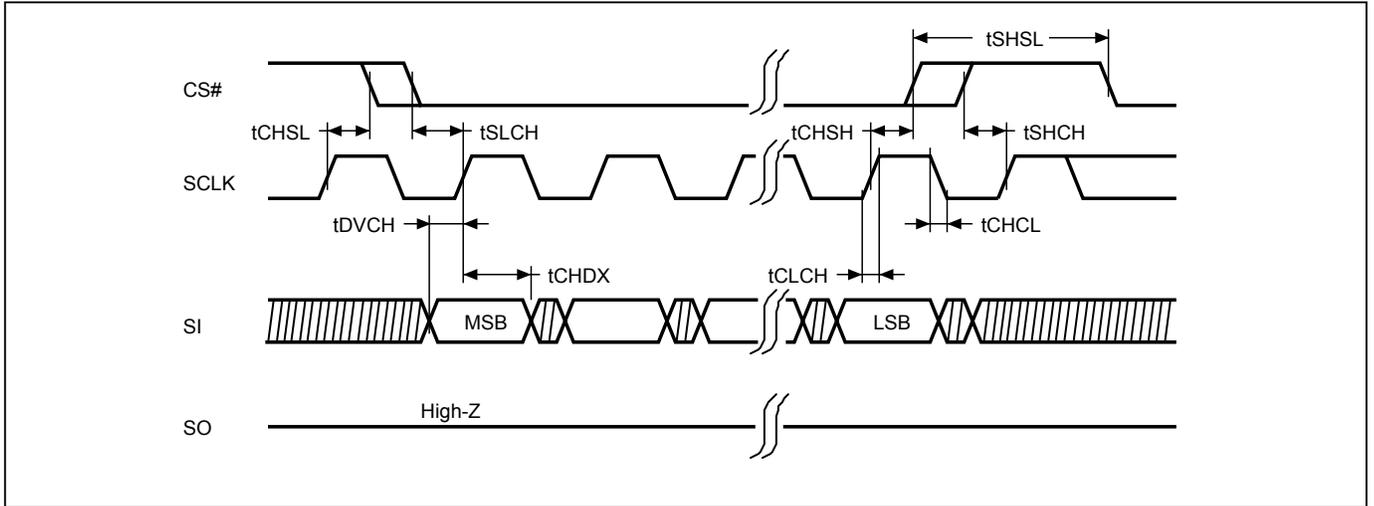
**Figure 1. Serial Modes Supported**



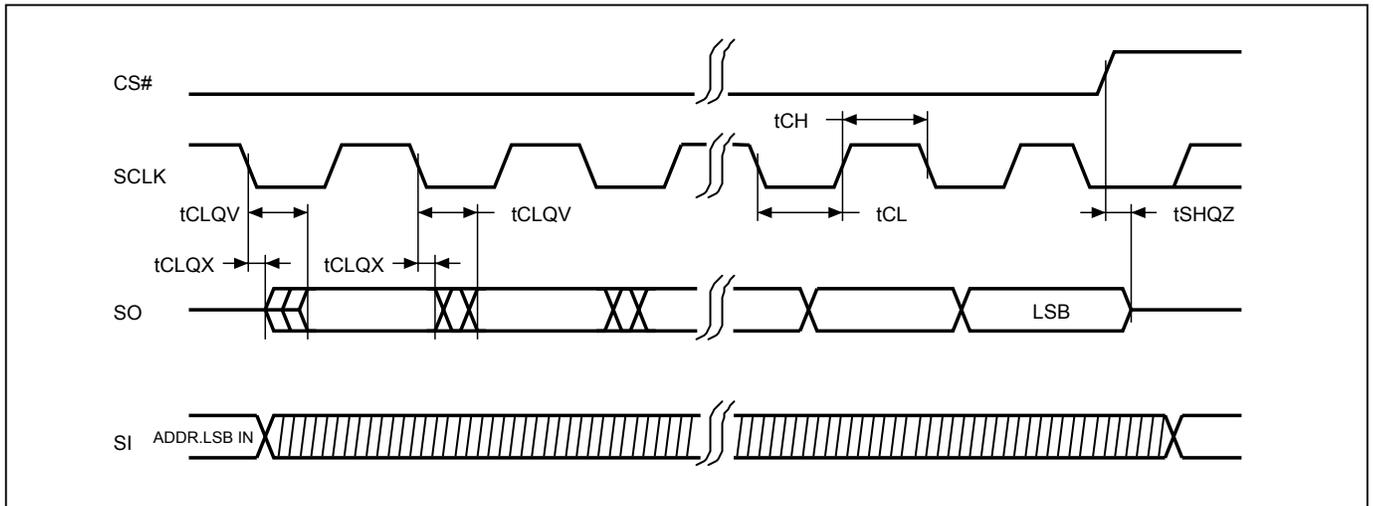
**Note:**

CPOL indicates clock polarity of Serial master, CPOL=1 for SCLK high while idle, CPOL=0 for SCLK low while not transmitting. CPHA indicates clock phase. The combination of CPOL bit and CPHA bit decides which Serial mode is supported.

**Figure 2. Serial Input Timing**



**Figure 3. Output Timing**



## 9. COMMAND DESCRIPTION

**Table 4. Command Set**

### Read/Write Array Commands

| Command (byte) | READ (normal read)                   | FAST READ (fast read data)           | 2READ (2 x I/O read command)                    | DREAD (1I 2O read)                                  | 4READ (4 I/O read)                              | QREAD (1I 4O read)                                  |
|----------------|--------------------------------------|--------------------------------------|---|---|---|---|
| Address Bytes  | 3                                    | 3                                    | 3   | 3   | 3   | 3   |
| 1st byte       | 03 (hex)                             | 0B (hex)                             | BB (hex)  | 3B (hex)  | EB (hex)  | 6B (hex)  |
| 2nd byte       | ADD1                                 | ADD1                                 | ADD1  | ADD1  | ADD1  | ADD1  |
| 3rd byte       | ADD2                                 | ADD2                                 | ADD2  | ADD2  | ADD2  | ADD2  |
| 4th byte       | ADD3                                 | ADD3                                 | ADD3  | ADD3  | ADD3  | ADD3  |
| 5th byte       |                                      | Dummy (8)                            | Dummy (4)                                       | Dummy (8)   | Dummy (6)                                       | Dummy (8)   |
| Data Cycles    |                                      |                                      |   |   |   |   |
| Action         | n bytes read out until CS# goes high | n bytes read out until CS# goes high | n bytes read out by 2 x I/O until CS# goes high | n bytes read out by Dual output until CS# goes high | n bytes read out by 4 x I/O until CS# goes high | n bytes read out by Quad output until CS# goes high |

| Command (byte) | PP (page program)            | 4PP (quad page program)                 | SE (sector erase)            | BE 32K (block erase 32KB)       | BE (block erase 64KB)       | CE (chip erase)     |
|----------------|------------------------------|---|------------------------------|---------------------------------|-----------------------------|---------------------|
| Address Bytes  | 3                            | 3                                       | 3                            | 3                               | 3                           | 0                   |
| 1st byte       | 02 (hex)                     | 38 (hex)                                | 20 (hex)                     | 52 (hex)                        | D8 (hex)                    | 60 or C7 (hex)      |
| 2nd byte       |                              | ADD1                                    | ADD1                         | ADD1                            | ADD1                        |                     |
| 3rd byte       |                              | ADD2                                    | ADD2                         | ADD2                            | ADD2                        |                     |
| 4th byte       |                              | ADD3                                    | ADD3                         | ADD3                            | ADD3                        |                     |
| 5th byte       |                              |   |                              |                                 |                             |                     |
| Data Cycles    | 1-256                        | 1-256                                   |                              |                                 |                             |                     |
| Action         | to program the selected page | quad input to program the selected page | to erase the selected sector | to erase the selected 32K block | to erase the selected block | to erase whole chip |



**Register/Setting Commands**

| Command (byte) | WREN (write enable)                   | WRDI (write disable)                    | RDSR (read status register)                   | RDCR (read configuration register)                   | WRSR (write status/ configuration register)               | PGM/ERS Suspend (Suspends Program/ Erase) | PGM/ERS Resume (Resumes Program/ Erase) |
|----------------|---------------------------------------|---|---|--|---|---|---|
| 1st byte       | 06 (hex)                              | 04 (hex)                                | 05 (hex)                                      | 15 (hex)   | 01 (hex)  | B0 (hex)                                  | 30 (hex)                                |
| 2nd byte       |                                       |   |   |  | Values  |   |   |
| 3rd byte       |                                       |   |   |  | Values  |   |   |
| 4th byte       |                                       |   |   |  |   |   |   |
| 5th byte       |                                       |   |   |  |   |   |   |
| Data Cycles    |                                       |   |   |  | 1-2   |   |   |
| Action         | sets the (WEL) write enable latch bit | resets the (WEL) write enable latch bit | to read out the values of the status register | to read out the values of the configuration register | to write new values of the status/ configuration register |   |   |

| Command (byte) | DP (Deep power down)        | RDP (Release from deep power down) |
|----------------|-----------------------------|------------------------------------|
| 1st byte       | B9 (hex)                    | AB (hex)                           |
| 2nd byte       |                             |                                    |
| 3rd byte       |                             |                                    |
| 4th byte       |                             |                                    |
| 5th byte       |                             |                                    |
| Data Cycles    |                             |                                    |
| Action         | enters deep power down mode | release from deep power down mode  |

## ID/Security Commands

| Command (byte) | RDID (read identification)                                  | RES (read electronic ID)     | REMS (read electronic manufacturer & device ID) | RDSFDP         | ENSO (enter secured OTP)             | EXSO (exit secured OTP)             | RDSCUR (read security register)    |
|----------------|---|------------------------------|---|----------------|--------------------------------------|-------------------------------------|------------------------------------|
| Address Bytes  | 0   | 0                            | 0   | 3              | 0                                    | 0                                   | 0                                  |
| 1st byte       | 9F (hex)  | AB (hex)                     | 90 (hex)  | 5A (hex)       | B1 (hex)                             | C1 (hex)                            | 2B (hex)                           |
| 2nd byte       |   | x                            | x   | ADD1           |                                      |                                     |                                    |
| 3rd byte       |   | x                            | x   | ADD2           |                                      |                                     |                                    |
| 4th byte       |   | x                            | ADD1 <small>(Note 1)</small>                    | ADD3           |                                      |                                     |                                    |
| 5th byte       |   |                              |   | Dummy (8)      |                                      |                                     |                                    |
| Action         | outputs JEDEC ID: 1-byte Manufacturer ID & 2-byte Device ID | to read out 1-byte Device ID | output the Manufacturer ID & Device ID          | Read SFDP mode | to enter the 4K-bit secured OTP mode | to exit the 4K-bit secured OTP mode | to read value of security register |

| Command (byte) | WRSCUR (write security register)                                    |
|----------------|---|
| Address Bytes  | 0   |
| 1st byte       | 2F (hex)  |
| 2nd byte       |   |
| 3rd byte       |   |
| 4th byte       |   |
| 5th byte       |   |
| Data Cycles    |   |
| Action         | to set the lock-down bit as "1" (once lock-down, cannot be updated) |

**Reset Commands**

| Command (byte) | NOP (No Operation) | RSTEN (Reset Enable) | RST (Reset Memory) |
|----------------|--------------------|----------------------|--------------------|
| 1st byte       | 00 (hex)           | 66 (hex)             | 99 (hex)           |
| 2nd byte       |                    |                      |                    |
| 3rd byte       |                    |                      |                    |
| 4th byte       |                    |                      |                    |
| 5th byte       |                    |                      |                    |
| Action         |                    |                      |                    |

Note 1: The count base is 4-bit for ADD(2) and Dummy(2) because of 2 x I/O. And the MSB is on SO/SIO1 which is different from 1 x I/O condition.

Note 2: ADD=00H will output the manufacturer ID first and AD=01H will output device ID first.

Note 3: It is not recommended to adopt any other code not in the command definition table, which will potentially enter the hidden mode.

Note 4: Before executing RST command, RSTEN command must be executed. If there is any other command to interfere, the reset operation will be disabled.

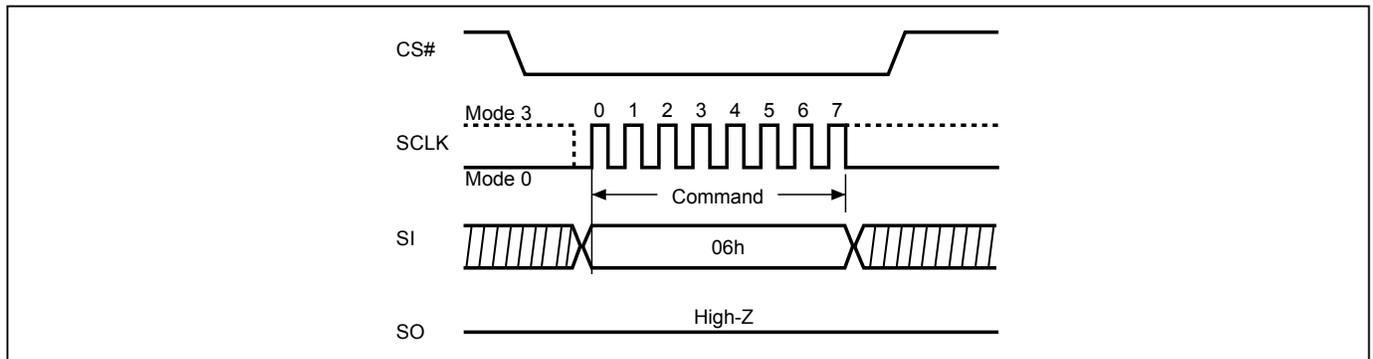
Note 5: The number in parentheses after "ADD" or "Data" stands for how many clock cycles it has. For example, "Data(8)" represents there are 8 clock cycles for the data in.

### 9-1. Write Enable (WREN)

The Write Enable (WREN) instruction is for setting Write Enable Latch (WEL) bit. For those instructions like PP, 4PP, SE, BE32K, BE, CE, WRSCUR and WRSR, which are intended to change the device content WEL bit should be set every time after the WREN instruction setting the WEL bit.

The sequence of issuing WREN instruction is: CS# goes low→sending WREN instruction code→ CS# goes high.

**Figure 4. Write Enable (WREN) Sequence**



## 9-2. Write Disable (WRDI)

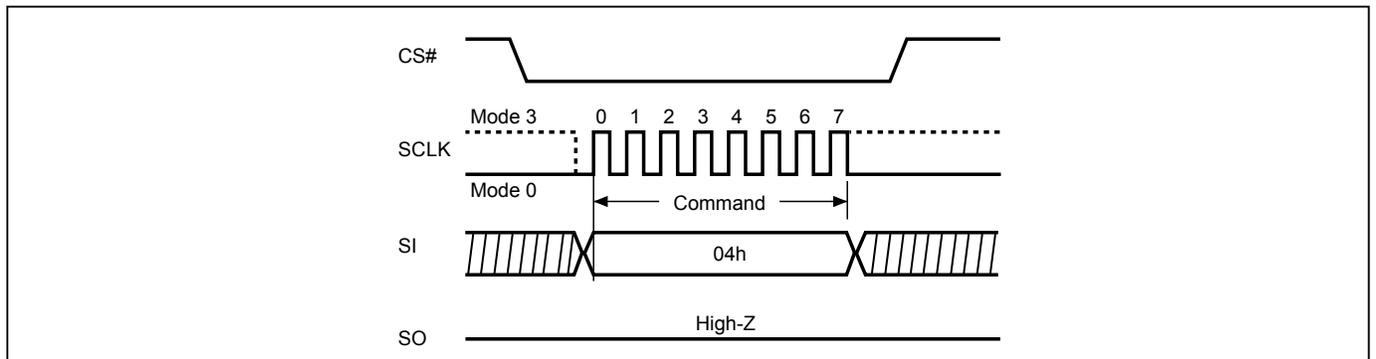
The Write Disable (WRDI) instruction is to reset Write Enable Latch (WEL) bit.

The sequence of issuing WRDI instruction is: CS# goes low→sending WRDI instruction code→CS# goes high.

The WEL bit is reset by following situations:

- Power-up
- WRDI command completion
- WRSR command completion
- PP command completion
- 4PP command completion
- SE command completion
- BE32K command completion
- BE command completion
- CE command completion
- PGM/ERS Suspend command completion
- Reset command completion
- WRSCUR command completion

**Figure 5. Write Disable (WRDI) Sequence**



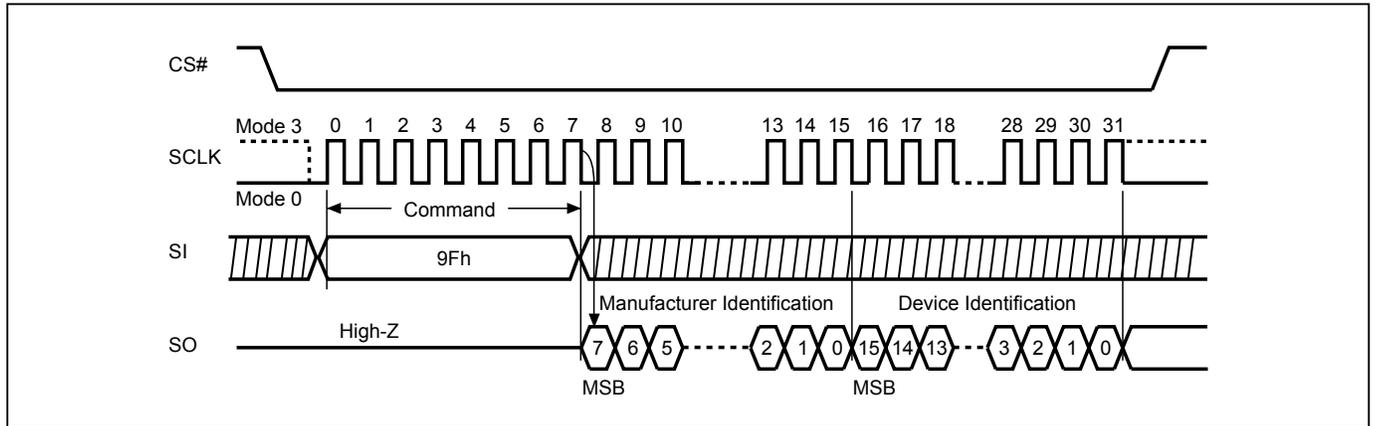
**9-3. Read Identification (RDID)**

The RDID instruction is for reading the manufacturer ID of 1-byte and followed by Device ID of 2-byte. The Macro-nix Manufacturer ID and Device ID are listed as "Table 5. ID Definitions".

The sequence of issuing RDID instruction is: CS# goes low→ sending RDID instruction code→24-bits ID data out on SO→ to end RDID operation can drive CS# to high at any time during data out.

While Program/Erase operation is in progress, it will not decode the RDID instruction, therefore there's no effect on the cycle of program/erase operation which is currently in progress. When CS# goes high, the device is at standby stage.

**Figure 6. Read Identification (RDID) Sequence**



**Table 5. ID Definitions**

| Command Type |     | MX25L12850F    |             |                |
|--------------|-----|----------------|-------------|----------------|
| RDID         | 9Fh | Manufactory ID | Memory type | Memory density |
|              |     | C2             | 20          | 18             |
| RES          | ABh | Electronic ID  |             |                |
|              |     | 17             |             |                |
| REMS         | 90h | Manufactory ID | Device ID   |                |
|              |     | C2             | 17          |                |

**9-4. Release from Deep Power-down (RDP), Read Electronic Signature (RES)**

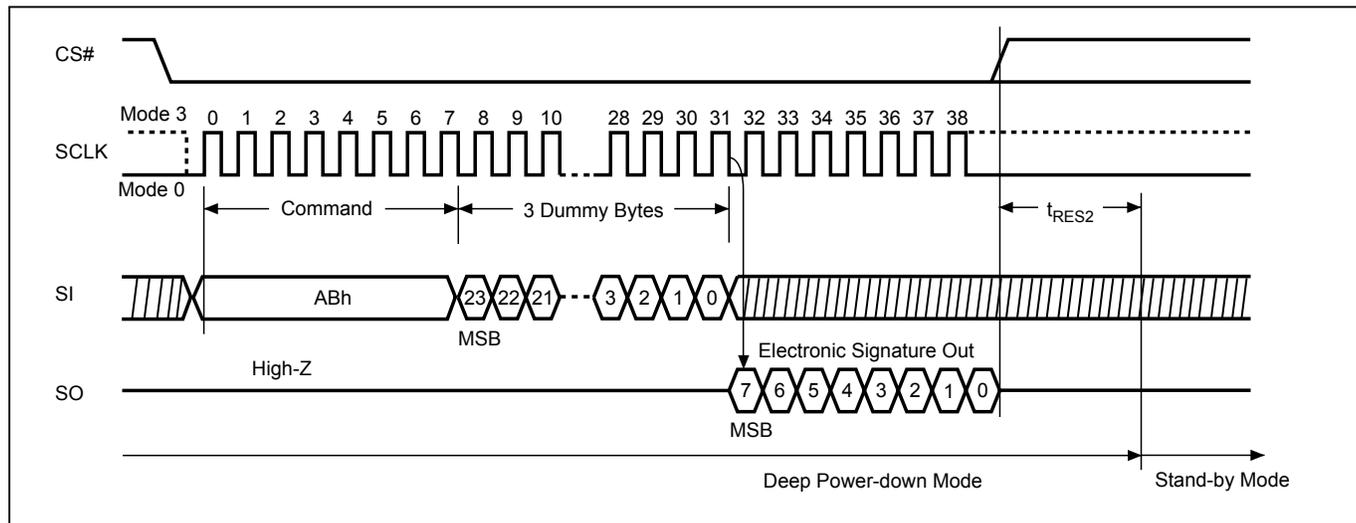
The Release from Deep Power-down (RDP) instruction is completed by driving Chip Select (CS#) High. When Chip Select (CS#) is driven High, the device is put in the Stand-by Power mode. If the device was not previously in the Deep Power-down mode, the transition to the Stand-by Power mode is immediate. If the device was previously in the Deep Power-down mode, though, the transition to the Stand-by Power mode is delayed by  $t_{RES1}$ , and Chip Select (CS#) must remain High for at least  $t_{RES1(max)}$ , as specified in "Table 16. AC CHARACTERISTICS". Once in the Stand-by Power mode, the device waits to be selected, so that it can receive, decode and execute instructions. The RDP instruction is only for releasing from Deep Power Down Mode.

RES instruction is for reading out the old style of 8-bit Electronic Signature, whose values are shown as "Table 5. ID Definitions". This is not the same as RDID instruction. It is not recommended to use for new design. For new design, please use RDID instruction.

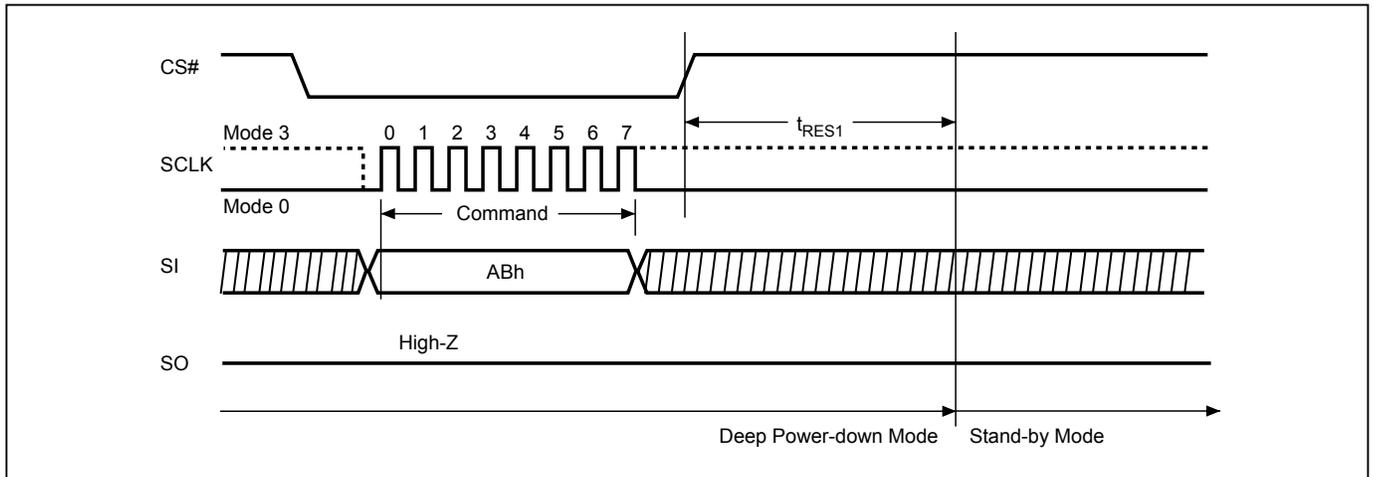
Even in Deep power-down mode, the RDP and RES are also allowed to be executed, only except the device is in progress of program/erase/write cycle; there's no effect on the current program/erase/write cycle in progress.

The RES instruction is ended by CS# goes high after the ID been read out at least once. The ID outputs repeatedly if continuously send the additional clock cycles on SCLK while CS# is at low. If the device was not previously in Deep Power-down mode, the device transition to standby mode is immediate. If the device was previously in Deep Power-down mode, there's a delay of  $t_{RES2}$  to transit to standby mode, and CS# must remain to high at least  $t_{RES2(max)}$ . Once in the standby mode, the device waits to be selected, so it can be receive, decode, and execute instruction.

**Figure 7. Read Electronic Signature (RES) Sequence**



**Figure 8. Release from Deep Power-down (RDP) Sequence**

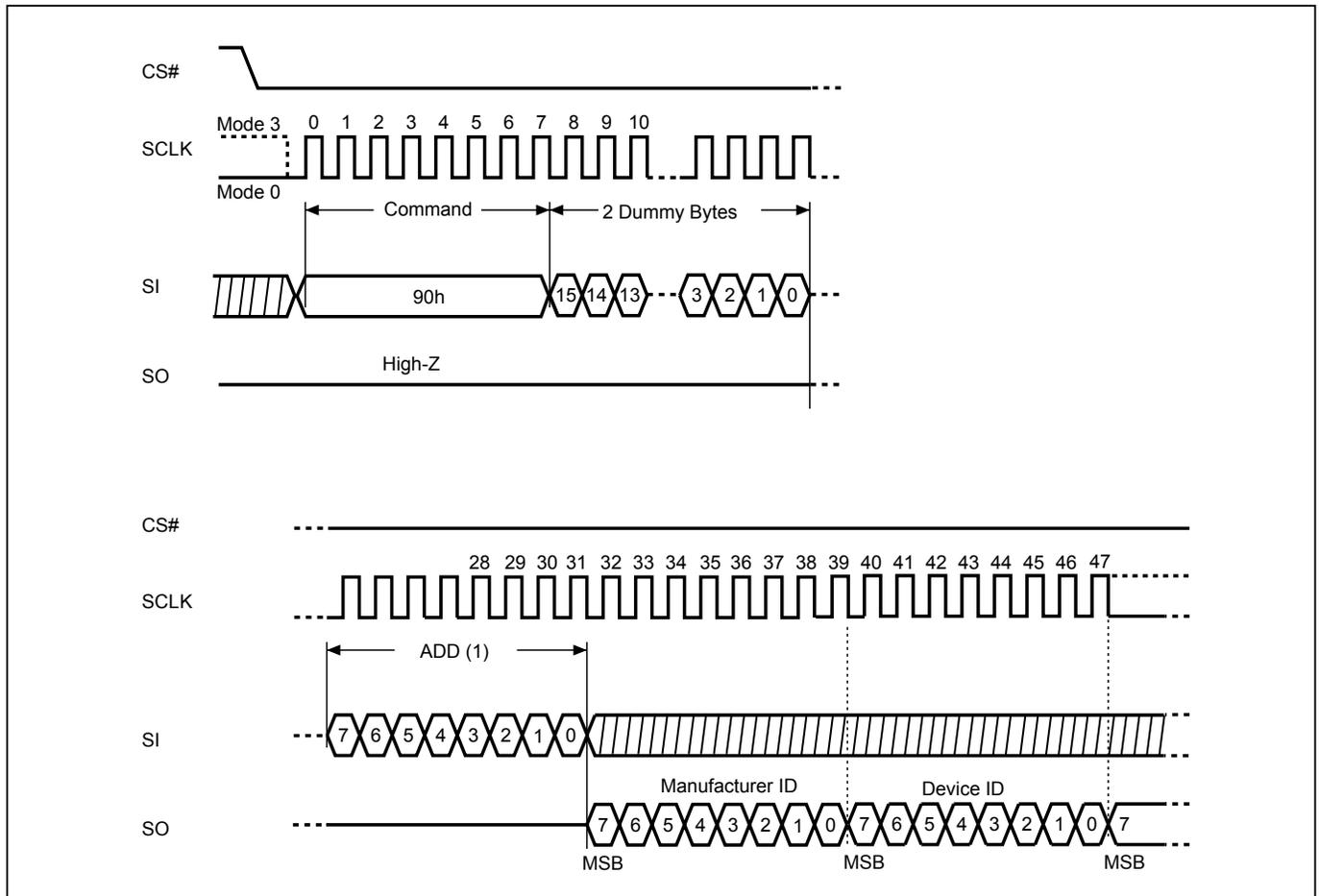


**9-5. Read Electronic Manufacturer ID & Device ID (REMS)**

The REMS instruction is an alternative to the Release from Power-down/Device ID instruction that provides both the JEDEC assigned manufacturer ID and the specific device ID.

The REMS instruction is very similar to the Release from Power-down/Device ID instruction. The instruction is initiated by driving the CS# pin low and shift the instruction code "90h" followed by two dummy bytes and one bytes address. After which, the Manufacturer ID for Macronix (C2h) and the Device ID are shifted out on the falling edge of SCLK with most significant bit (MSB) first. The Device ID values are listed in "Table 5. ID Definitions". If the one-byte address is initially set to 01h, then the device ID will be read first and then followed by the Manufacturer ID. The Manufacturer and Device IDs can be read continuously, alternating from one to the other. The instruction is completed by driving CS# high.

**Figure 9. Read Electronic Manufacturer & Device ID (REMS) Sequence**



**Notes:**

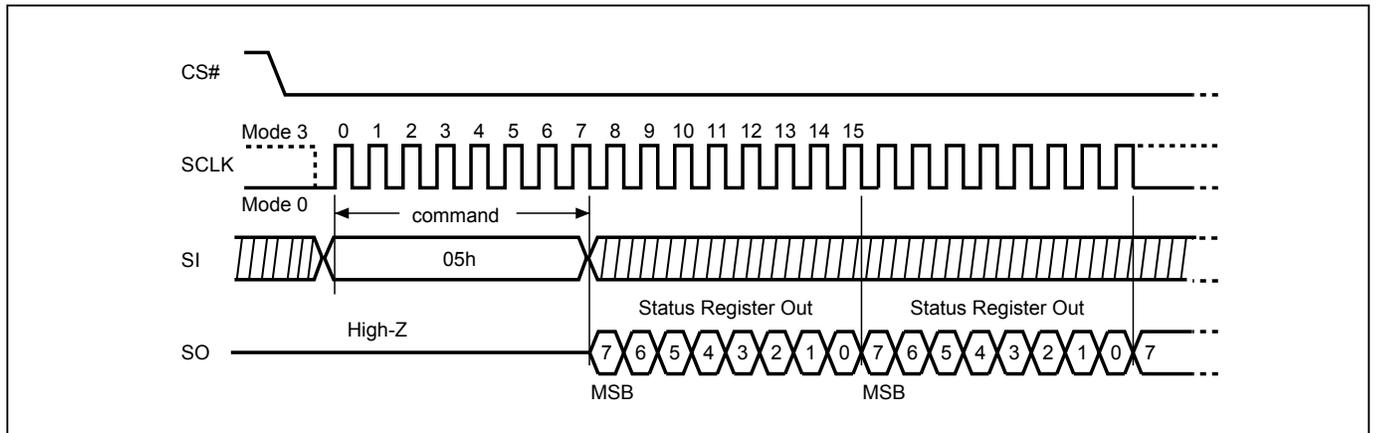
(1) ADD=00H will output the manufacturer's ID first and ADD=01H will output device ID first.

**9-6. Read Status Register (RDSR)**

The RDSR instruction is for reading Status Register Bits. The Read Status Register can be read at any time (even in program/erase/write status register condition). It is recommended to check the Write in Progress (WIP) bit before sending a new instruction when a program, erase, or write status register operation is in progress.

The sequence of issuing RDSR instruction is: CS# goes low→ sending RDSR instruction code→ Status Register data out on SO.

**Figure 10. Read Status Register (RDSR) Sequence**

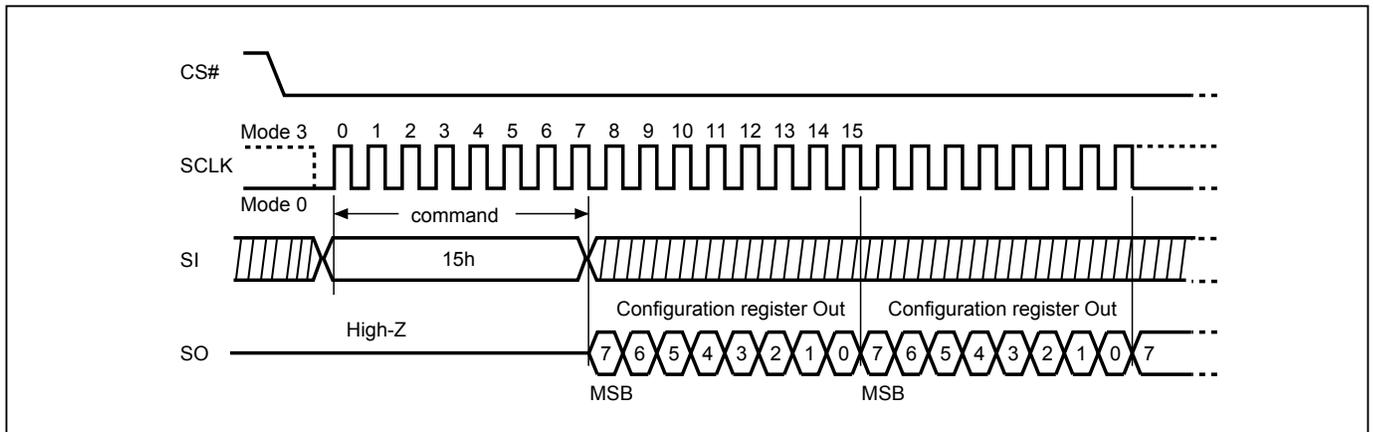


### 9-7. Read Configuration Register (RDCR)

The RDCR instruction is for reading Configuration Register Bits. The Read Configuration Register can be read at any time (even in program/erase/write configuration register condition). It is recommended to check the Write in Progress (WIP) bit before sending a new instruction when a program, erase, or write configuration register operation is in progress.

The sequence of issuing RDCR instruction is: CS# goes low→ sending RDCR instruction code→ Configuration Register data out on SO.

**Figure 11. Read Configuration Register (RDCR) Sequence**



For user to check if Program/Erase operation is finished or not, RDSR instruction flow are shown as follows:

**Figure 12. Program/Erase flow with read array data**

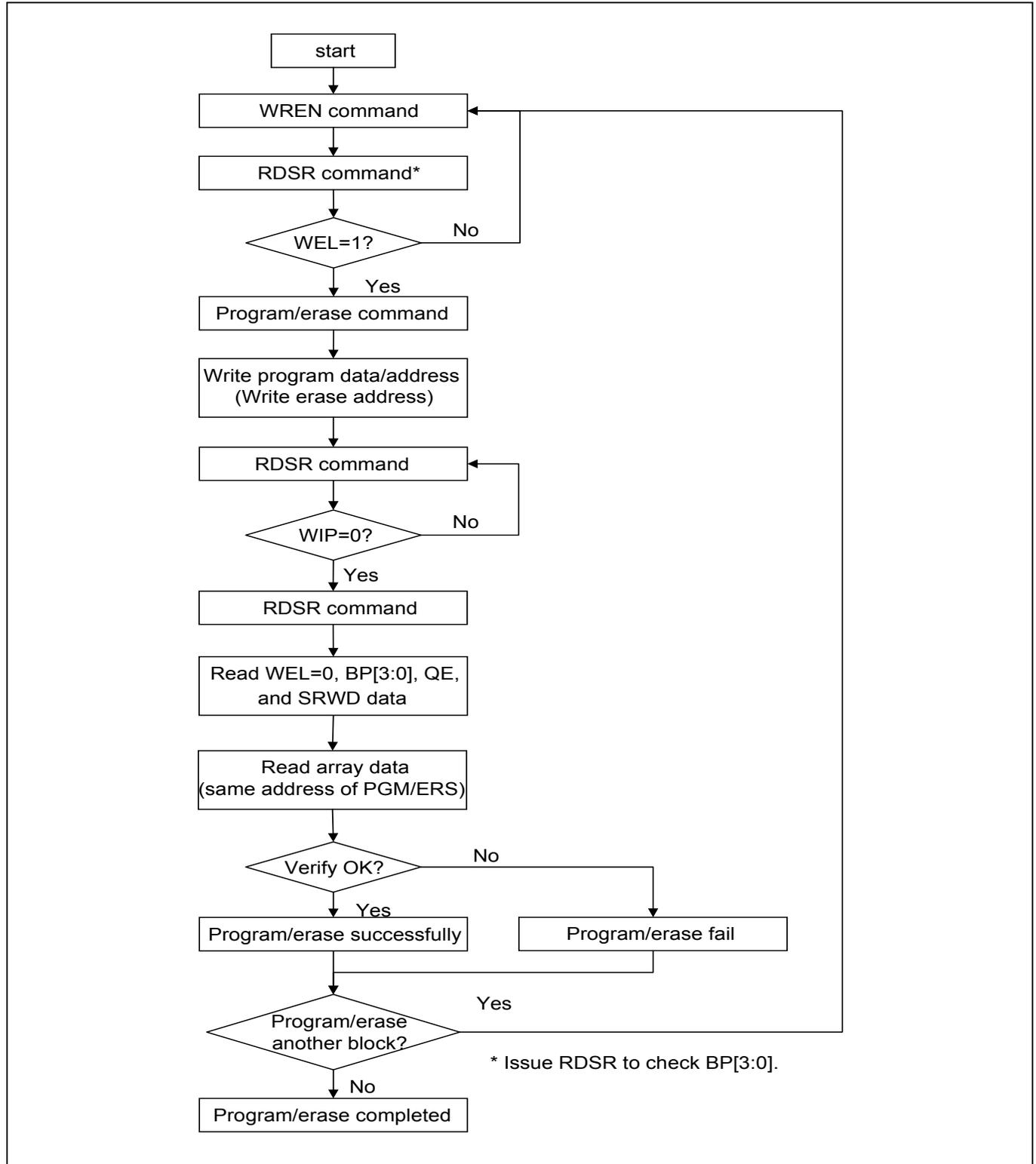
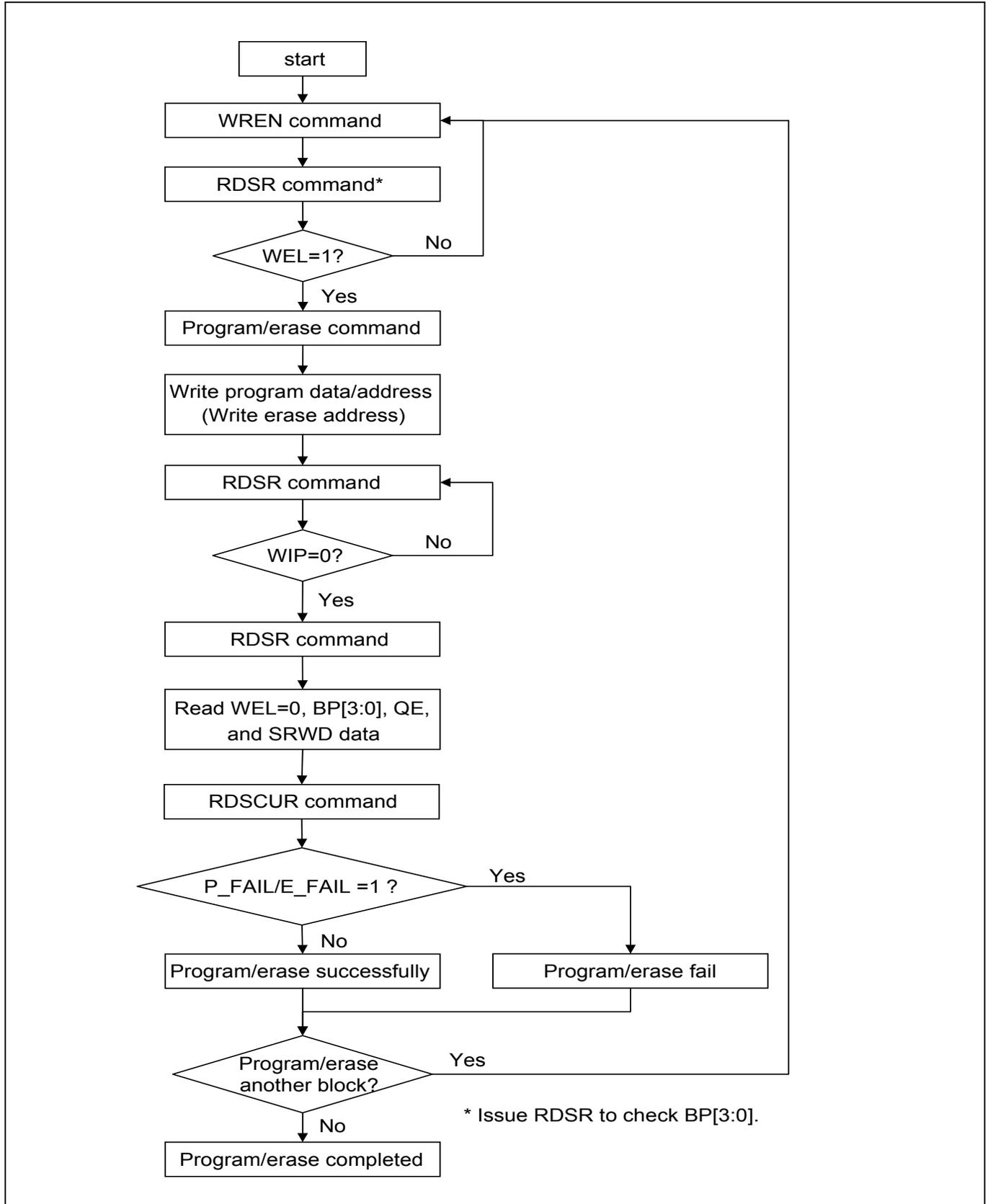


Figure 13. Program/Erase flow without read array data (read P\_FAIL/E\_FAIL flag)



## Status Register

The definition of the status register bits is as below:

**WIP bit.** The Write in Progress (WIP) bit, a volatile bit, indicates whether the device is busy in program/erase/write status register progress. When WIP bit sets to 1, which means the device is busy in program/erase/write status register progress. When WIP bit sets to 0, which means the device is not in progress of program/erase/write status register cycle.

**WEL bit.** The Write Enable Latch (WEL) bit, a volatile bit, indicates whether the device is set to internal write enable latch. When WEL bit sets to 1, which means the internal write enable latch is set, the device can accept program/erase/write status register instruction. When WEL bit sets to 0, which means no internal write enable latch; the device will not accept program/erase/write status register instruction. The program/erase command will be ignored if it is applied to a protected memory area. To ensure both WIP bit & WEL bit are both set to 0 and available for next program/erase/operations, WIP bit needs to be confirm to be 0 before polling WEL bit. After WIP bit confirmed, WEL bit needs to be confirm to be 0.

**BP3, BP2, BP1, BP0 bits.** The Block Protect (BP3, BP2, BP1, BP0) bits, non-volatile bits, indicate the protected area (as defined in "[Table 1. Protected Area Sizes](#)") of the device to against the program/erase instruction without hardware protection mode being set. To write the Block Protect (BP3, BP2, BP1, BP0) bits requires the Write Status Register (WRSR) instruction to be executed. Those bits define the protected area of the memory to against Page Program (PP), Sector Erase (SE), Block Erase 32KB (BE32K), Block Erase (BE) and Chip Erase (CE) instructions (only if Block Protect bits (BP3:BP0) set to 0, the CE instruction can be executed). The BP3, BP2, BP1, BP0 bits are "0" as default. Which is un-protected.

**QE bit.** The Quad Enable (QE) bit, a non-volatile OTP bit which is permanently set to "1". The flash always performs Quad I/O mode.

**SRWD bit.** The Status Register Write Disable (SRWD) bit, non-volatile bit, default value is "0".

## Status Register

| bit7                                 | bit6                   | bit5                           | bit4                           | bit3                           | bit2                           | bit1                                 | bit0  |
|--------------------------------------|------------------------|--------------------------------|--------------------------------|--------------------------------|--------------------------------|--------------------------------------|---|
| SRWD (status register write protect) | QE (Quad Enable)       | BP3 (level of protected block) | BP2 (level of protected block) | BP1 (level of protected block) | BP0 (level of protected block) | WEL (write enable latch)             | WIP (write in progress bit)                   |
| 1=status register write disable      | 1=Quad Enable (note 2) | (note 1)                       | (note 1)                       | (note 1)                       | (note 1)                       | 1=write enable<br>0=not write enable | 1=write operation<br>0=not in write operation |
| Non-volatile bit                     | OTP                    | Non-volatile bit               | Non-volatile bit               | Non-volatile bit               | Non-volatile bit               | volatile bit                         | volatile bit                                  |

Notes:

1. See the "[Table 1. Protected Area Sizes](#)".
2. The QE bit is set by factory default, and can not be changed permanently.

**Configuration Register**

The Configuration Register is able to change the default status of Flash memory. Flash memory will be configured after the CR bit is set.

**TB bit**

The Top/Bottom (TB) bit is a non-volatile OTP bit. The Top/Bottom (TB) bit is used to configure the Block Protect area by BP bit (BP3, BP2, BP1, BP0), starting from TOP or Bottom of the memory array. The TB bit is defaulted as "0", which means Top area protect. When it is set as "1", the protect area will change to Bottom area of the memory device. To write the TB bits requires the Write Status Register (WRSR) instruction to be executed.

**Table 6. Configuration Register Table**

| bit7     | bit6     | bit5     | bit4     | bit3   | bit2     | bit1     | bit0     |
|----------|----------|----------|----------|--|----------|----------|----------|
| Reserved | Reserved | Reserved | Reserved | TB<br>(top/bottom<br>selected)                                   | Reserved | Reserved | Reserved |
| x        | x        | x        | x        | 0=Top area<br>protect<br>1=Bottom<br>area protect<br>(Default=0) | x        | x        | x        |
| x        | x        | x        | x        | OTP  | x        | x        | x        |

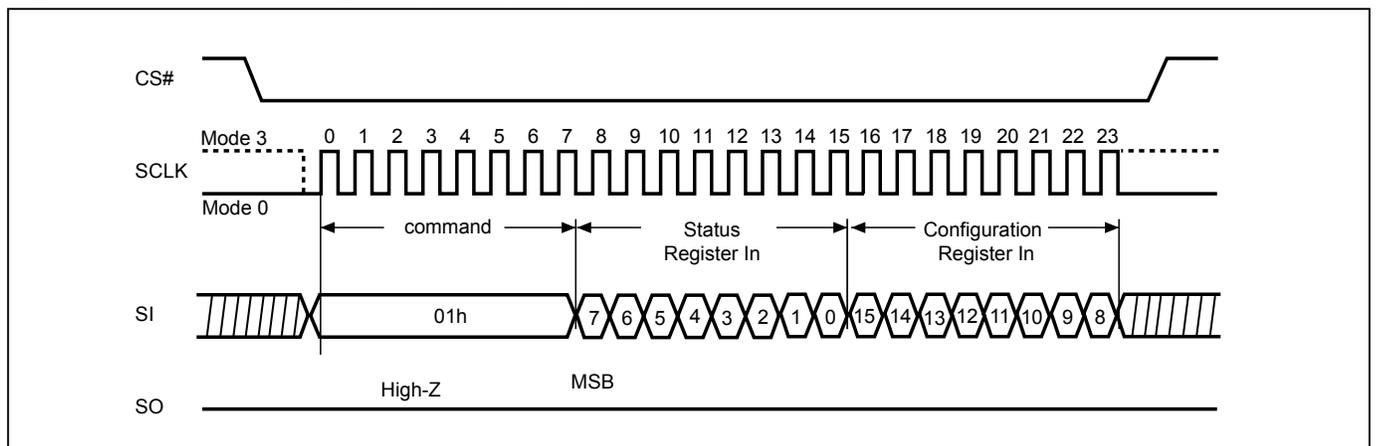
**9-8. Write Status Register (WRSR)**

The WRSR instruction is for changing the values of Status Register Bits and Configuration Register Bits. Before sending WRSR instruction, the Write Enable (WREN) instruction must be decoded and executed to set the Write Enable Latch (WEL) bit in advance. The WRSR instruction can change the value of Block Protect (BP3, BP2, BP1, BP0) bits to define the protected area of memory (as shown in "Table 1. Protected Area Sizes"), but has no effect on bit1(WEL) and bit0 (WIP) of the status register.

The sequence of issuing WRSR instruction is: CS# goes low→ sending WRSR instruction code→ Status Register data on SI→CS# goes high.

The CS# must go high exactly at the 8 bits or 16 bits data boundary; otherwise, the instruction will be rejected and not executed. The self-timed Write Status Register cycle time (tW) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be check out during the Write Status Register cycle is in progress. The WIP sets 1 during the tW timing, and sets 0 when Write Status Register Cycle is completed, and the Write Enable Latch (WEL) bit is reset.

**Figure 14. Write Status Register (WRSR) Sequence**



Note : The CS# must go high exactly at 8 bits or 16 bits data boundary to completed the write register command.

**Software Protected Mode (SPM):**

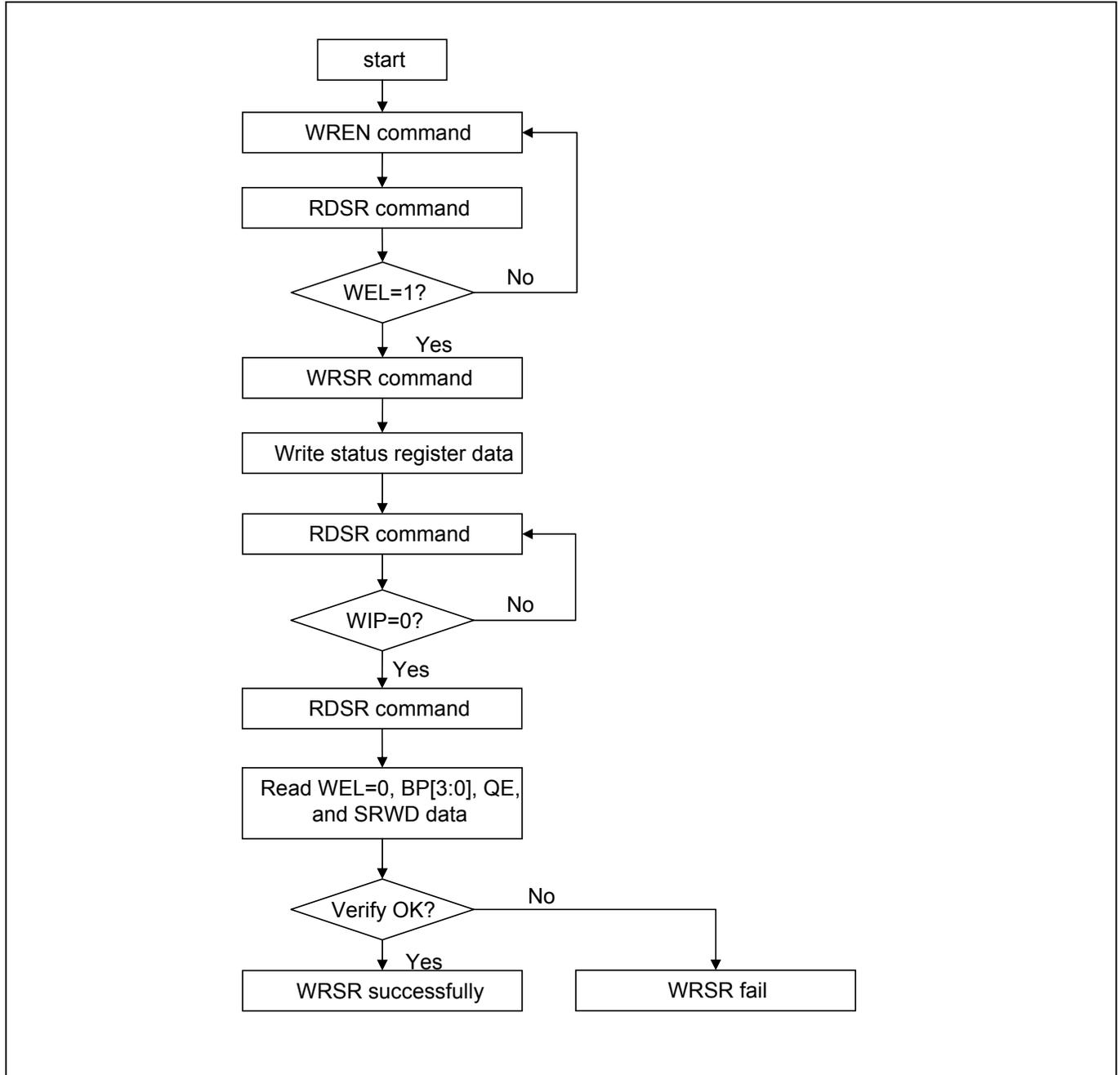
- When SRWD bit=0, the WREN instruction may set the WEL bit and can change the values of SRWD, BP3, BP2, BP1, BP0. The protected area, which is defined by BP3, BP2, BP1, BP0 and T/B bit, is at software protected mode (SPM).

**Table 7. Protection Modes**

| Mode                           | Status register condition   | SRWD bit status | Memory   |
|--------------------------------|---|-----------------|--|
| Software protection mode (SPM) | Status register can be written in (WEL bit is set to "1") and the SRWD, BP0-BP3 bits can be changed | SRWD bit=0      | The protected area cannot be program or erase. |

## Note:

1. As defined by the values in the Block Protect (BP3, BP2, BP1, BP0) bits of the Status Register, as shown in ["Table 1. Protected Area Sizes"](#).

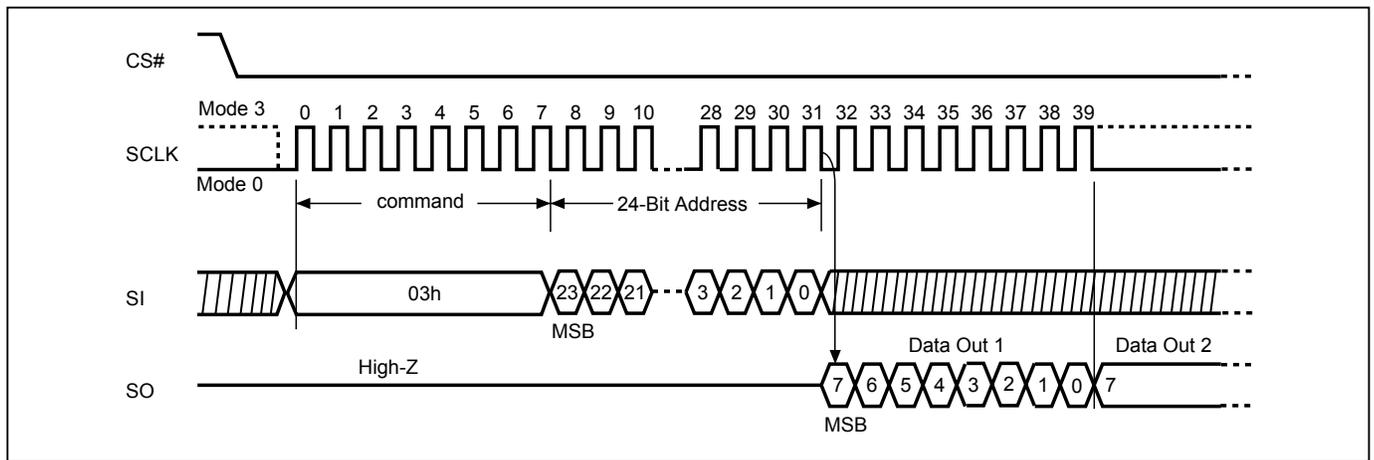
**Figure 15. WRSR flow**

**9-9. Read Data Bytes (READ)**

The read instruction is for reading data out. The address is latched on rising edge of SCLK, and data shifts out on the falling edge of SCLK at a maximum frequency  $f_R$ . The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single READ instruction. The address counter rolls over to 0 when the highest address has been reached.

The sequence of issuing READ instruction is: CS# goes low→sending READ instruction code→ 3-byte address on SI→ data out on SO→to end READ operation can use CS# to high at any time during data out.

**Figure 16. Read Data Bytes (READ) Sequence**



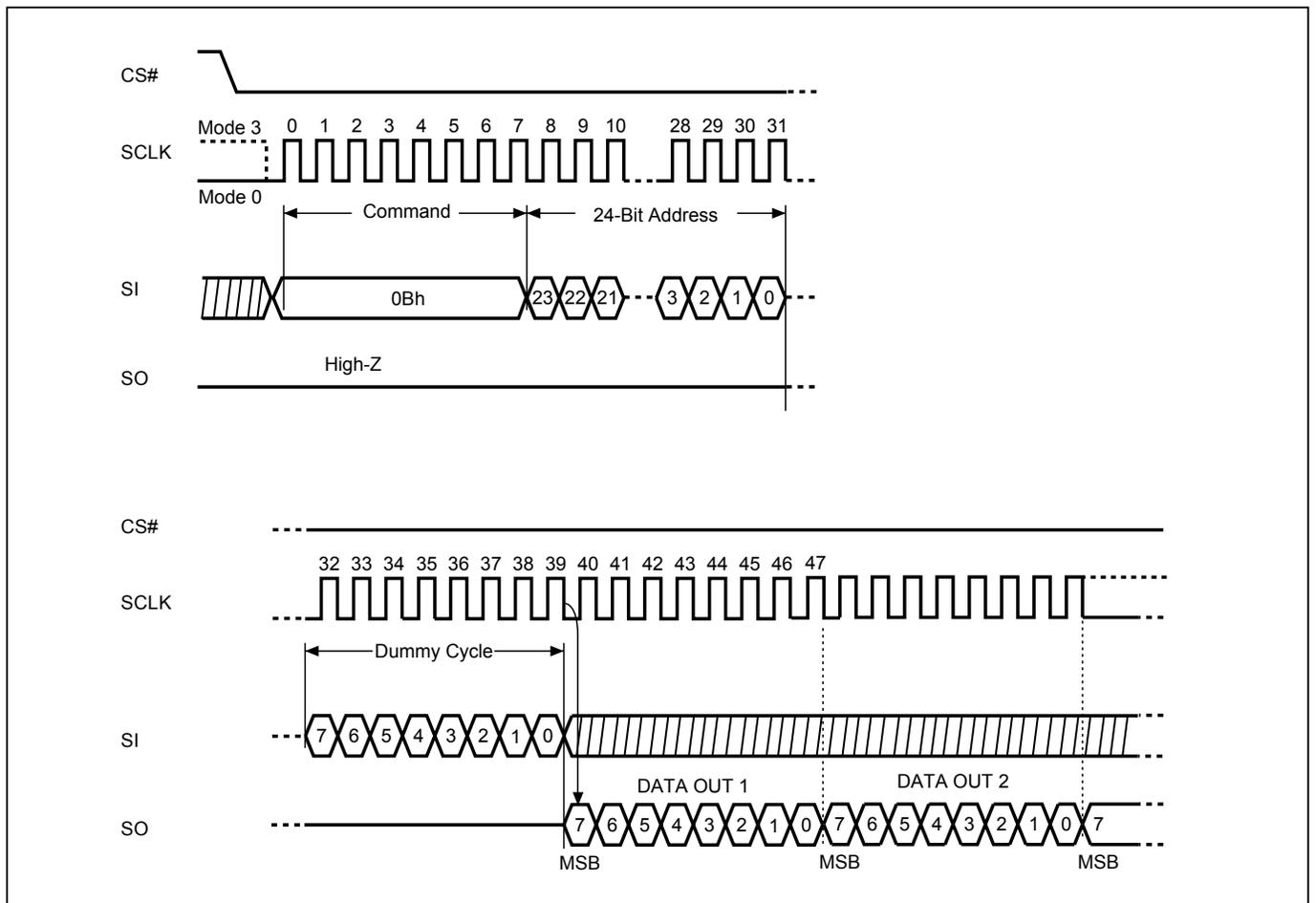
**9-10. Read Data Bytes at Higher Speed (FAST\_READ)**

The FAST\_READ instruction is for quickly reading data out. The address is latched on rising edge of SCLK, and data of each bit shifts out on the falling edge of SCLK at a maximum frequency  $f_C$ . The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single FAST\_READ instruction. The address counter rolls over to 0 when the highest address has been reached.

The sequence of issuing FAST\_READ instruction is: CS# goes low → sending FAST\_READ instruction code → 3-byte address on SI → 8 dummy cycles → data out on SO → to end FAST\_READ operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, FAST\_READ instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

**Figure 17. Read at Higher Speed (FAST\_READ) Sequence**



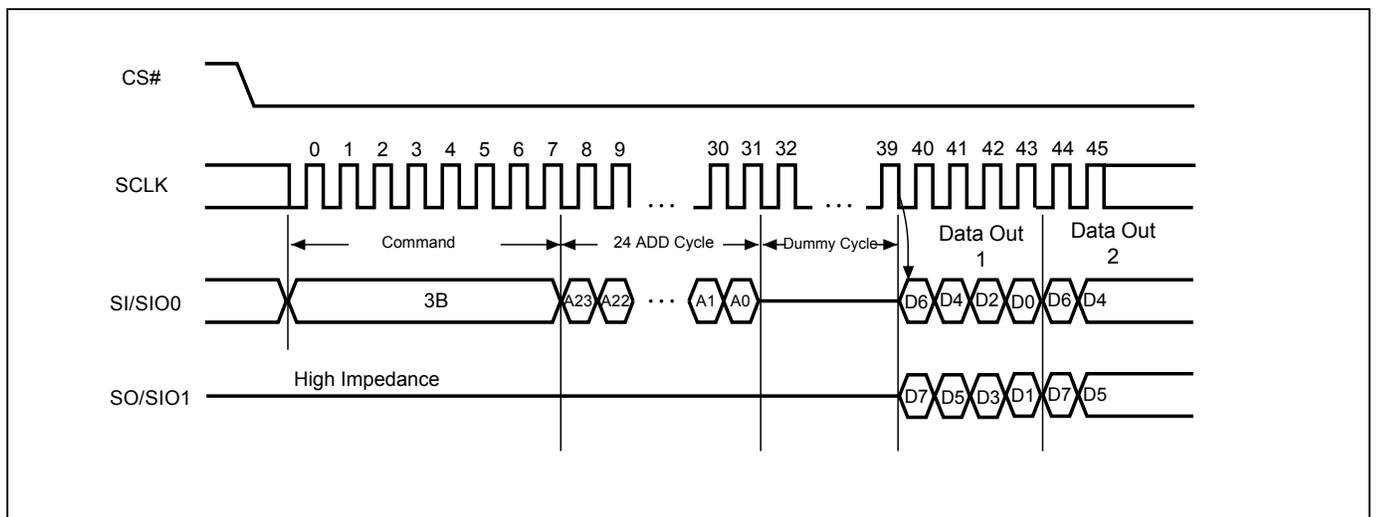
### 9-11. Dual Output Read Mode (DREAD)

The DREAD instruction enable double throughput of Serial Flash in read mode. The address is latched on rising edge of SCLK, and data of every two bits (interleave on 2 I/O pins) shift out on the falling edge of SCLK at a maximum frequency  $f_T$ . The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single DREAD instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing DREAD instruction, the following data out will perform as 2-bit instead of previous 1-bit.

The sequence of issuing DREAD instruction is: CS# goes low → sending DREAD instruction → 3-byte address on SIO0 → 8 dummy cycles on SIO0 → data out interleave on SIO1 & SIO0 → to end DREAD operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, DREAD instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

**Figure 18. Dual Read Mode Sequence**



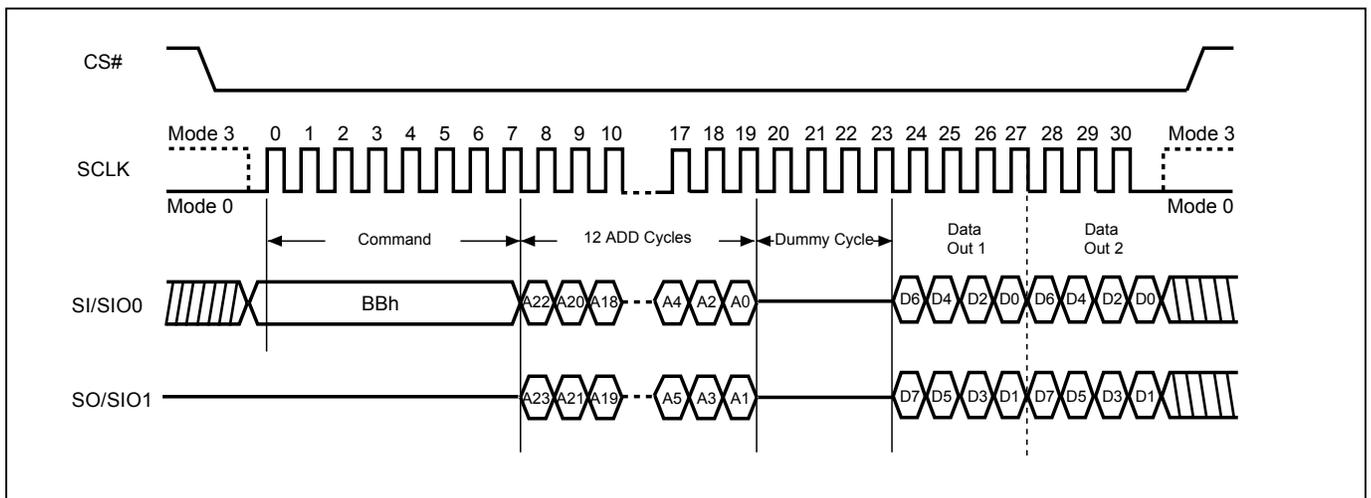
**9-12. 2 x I/O Read Mode (2READ)**

The 2READ instruction enable double throughput of Serial Flash in read mode. The address is latched on rising edge of SCLK, and data of every two bits (interleave on 2 I/O pins) shift out on the falling edge of SCLK at a maximum frequency  $f_T$ . The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single 2READ instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing 2READ instruction, the following address/dummy/data out will perform as 2-bit instead of previous 1-bit.

The sequence of issuing 2READ instruction is: CS# goes low→ sending 2READ instruction→ 3-byte address interleave on SIO1 & SIO0→ 4 dummy cycles on SIO1 & SIO0→ data out interleave on SIO1 & SIO0→ to end 2READ operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, 2READ instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

**Figure 19. 2 x I/O Read Mode Sequence**



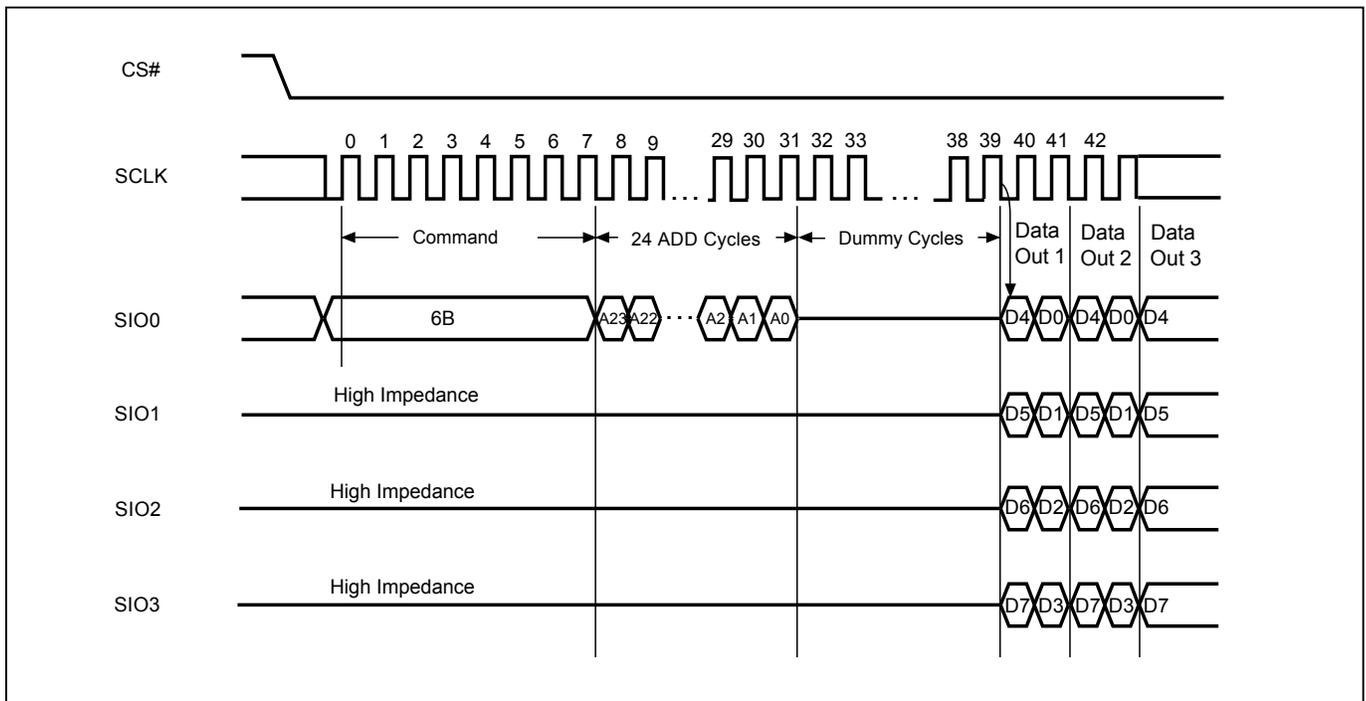
**9-13. Quad Read Mode (QREAD)**

The QREAD instruction enable quad throughput of Serial Flash in read mode. The address is latched on rising edge of SCLK, and data of every four bits (interleave on 4 I/O pins) shift out on the falling edge of SCLK at a maximum frequency fQ. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single QREAD instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing QREAD instruction, the following data out will perform as 4-bit instead of previous 1-bit.

The sequence of issuing QREAD instruction is: CS# goes low → sending QREAD instruction → 3-byte address on SI → 8 dummy cycle → data out interleave on SIO3, SIO2, SIO1 & SIO0 → to end QREAD operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, QREAD instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

**Figure 20. Quad Read Mode Sequence**



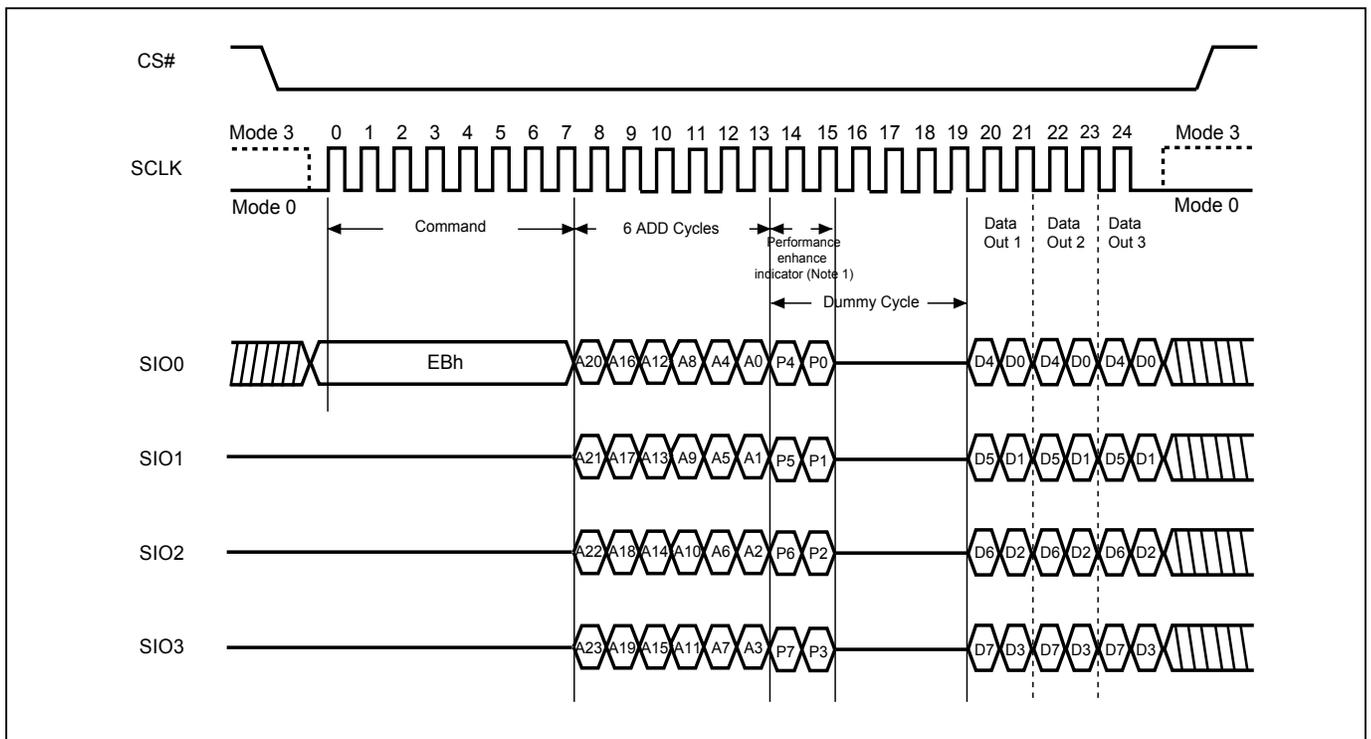
**9-14. 4 x I/O Read Mode (4READ)**

The 4READ instruction enable quad throughput of Serial Flash in read mode. The address is latched on rising edge of SCLK, and data of every four bits (interleave on 4 I/O pins) shift out on the falling edge of SCLK at a maximum frequency fQ. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single 4READ instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing 4READ instruction, the following address/dummy/data out will perform as 4-bit instead of previous 1-bit.

The sequence of issuing 4READ instruction is: CS# goes low→ sending 4READ instruction→ 3-byte address interleave on SIO3, SIO2, SIO1 & SIO0→ 6 dummy cycles →data out interleave on SIO3, SIO2, SIO1 & SIO0→ to end 4READ operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, 4READ instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

**Figure 21. 4 x I/O Read Mode Sequence**



**Notes:**

1. Hi-impedance is inhibited for the two clock cycles.
2. P7#P3, P6#P2, P5#P1 & P4#P0 (Toggling) is inhibited.

**9-15. Performance Enhance Mode**

The device could waive the command cycle bits if the two cycle bits after address cycle toggles.

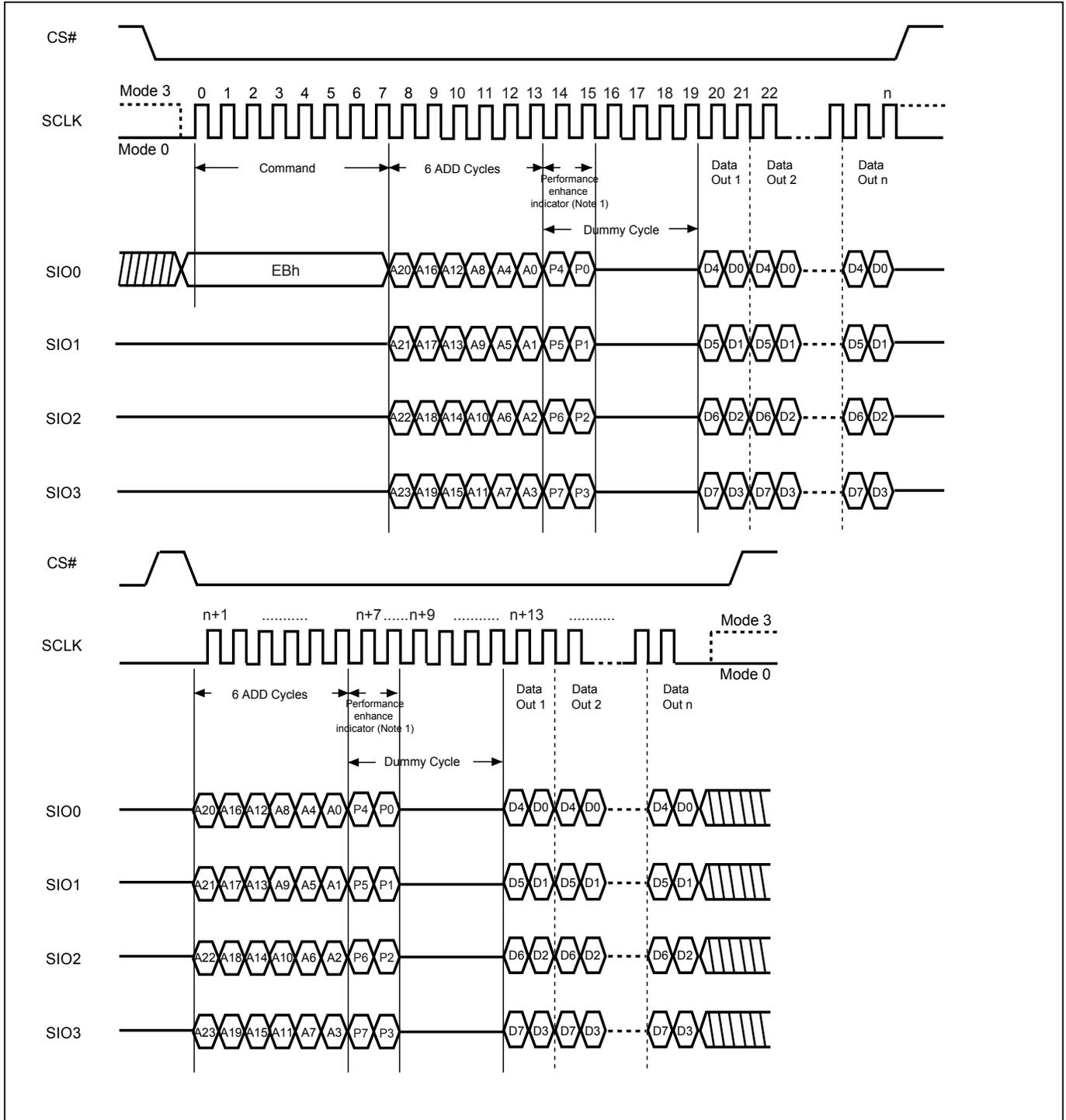
The “EBh” commands support enhance mode. The performance enhance mode is not supported in dual I/O mode.

To enter performance-enhancing mode, P[7:4] must be toggling with P[3:0]; likewise P[7:0]=A5h, 5Ah, F0h or 0Fh can make this mode continue and skip the next 4READ instruction. To leave enhance mode, P[7:4] is no longer toggling with P[3:0]; likewise P[7:0]=FFh, 00h, AAh or 55h along with CS# is afterwards raised and then lowered. Issuing “FFh” command can also exit enhance mode. The system then will leave performance enhance mode and return to normal operation.

After entering enhance mode, following CS# go high, the device will stay in the read mode and treat CS# go low of the first clock as address instead of command cycle.

Another sequence of issuing 4READ instruction especially useful in random access is : CS# goes low→sending 4 READ instruction→3-bytes address interleave on SIO3, SIO2, SIO1 & SIO0 →performance enhance toggling bit P[7:0]→ 4 dummy cycles →data out still CS# goes high → CS# goes low (reduce 4 Read instruction) → 3-bytes random access address.

**Figure 22. 4 x I/O Read enhance performance Mode Sequence**



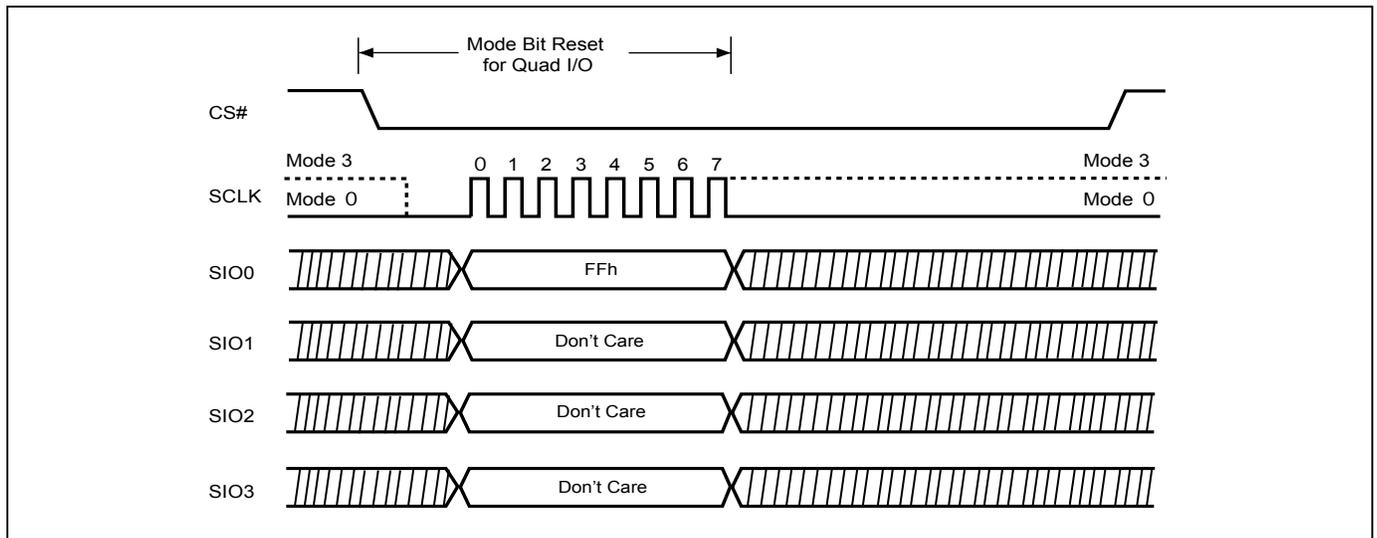
**Notes:**

1. If not using performance enhance recommend to keep 1 or 0 in performance enhance indicator.

**9-16. Performance Enhance Mode Reset**

To conduct the Performance Enhance Mode Reset operation in SPI mode, FFh data cycle, 8 clocks, should be issued in I/O sequence.

If the system controller is being Reset during operation, the flash device will return to the standard SPI operation.

**Figure 23. Performance Enhance Mode Reset for Fast Read Quad I/O**

### 9-17. Sector Erase (SE)

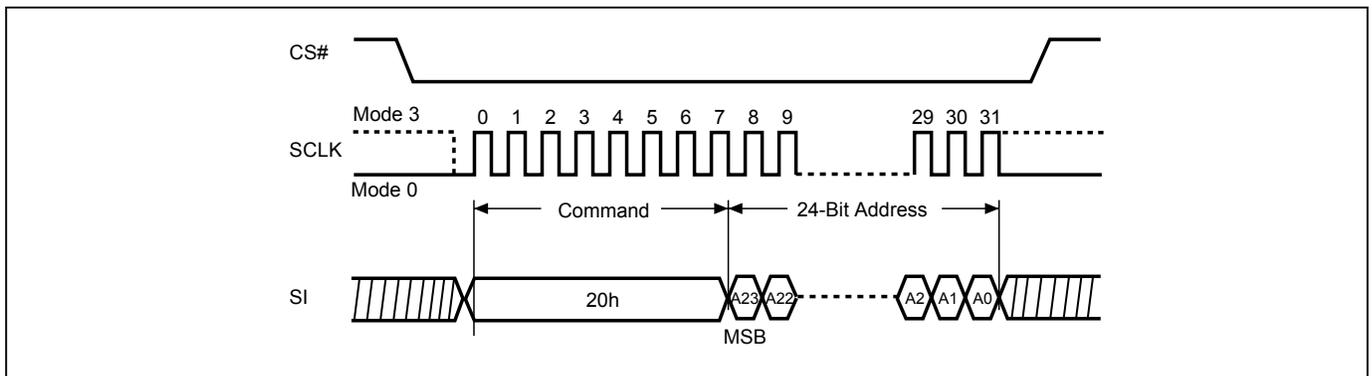
The Sector Erase (SE) instruction is for erasing the data of the chosen sector to be "1". The instruction is used for any 4K-byte sector. A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Sector Erase (SE). Any address of the sector (see "Table 3. Memory Organization") is a valid address for Sector Erase (SE) instruction. The CS# must go high exactly at the byte boundary (the least significant bit of the address byte been latched-in); otherwise, the instruction will be rejected and not executed.

Address bits [Am-A12] (Am is the most significant address) select the sector address.

The sequence of issuing SE instruction is: CS# goes low → sending SE instruction code → 3-byte address on SI → CS# goes high.

The self-timed Sector Erase Cycle time (tSE) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked while the Sector Erase cycle is in progress. The WIP sets 1 during the tSE timing, and clears when Sector Erase Cycle is completed, and the Write Enable Latch (WEL) bit is cleared. If the Block is protected by BP bits (Block Protect Mode), the Sector Erase (SE) instruction will not be executed on the block.

**Figure 24. Sector Erase (SE) Sequence**



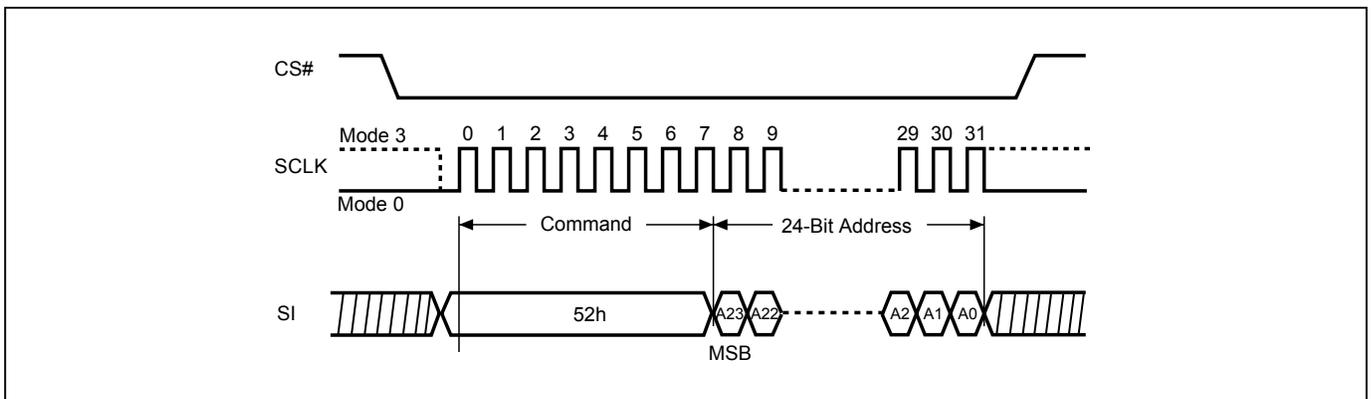
### 9-18. Block Erase (BE32K)

The Block Erase (BE32K) instruction is for erasing the data of the chosen block to be "1". The instruction is used for 32K-byte block erase operation. A Write Enable (WREN) instruction be executed to set the Write Enable Latch (WEL) bit before sending the Block Erase (BE32K). Any address of the block (see "Table 3. Memory Organization") is a valid address for Block Erase (BE32K) instruction. The CS# must go high exactly at the byte boundary (the least significant bit of address byte been latched-in); otherwise, the instruction will be rejected and not executed.

The sequence of issuing BE32K instruction is: CS# goes low→ sending BE32K instruction code→ 3-byte address on SI→CS# goes high.

The self-timed Block Erase Cycle time (tBE32K) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked while during the Block Erase cycle is in progress. The WIP sets during the tBE32K timing, and clears when Block Erase Cycle is completed, and the Write Enable Latch (WEL) bit is cleared. If the Block is protected by BP bits (Block Protect Mode), the Block Erase (BE32K) instruction will not be executed on the block.

**Figure 25. Block Erase 32KB (BE32K) Sequence**



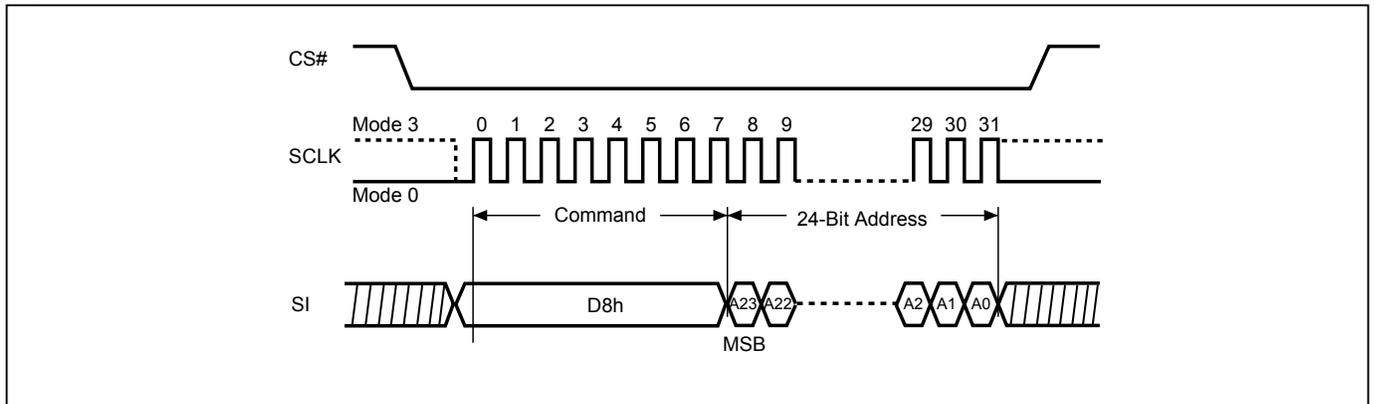
**9-19. Block Erase (BE)**

The Block Erase (BE) instruction is for erasing the data of the chosen block to be "1". The instruction is used for 64K-byte block erase operation. A Write Enable (WREN) instruction must be executed to set the Write Enable Latch (WEL) bit before sending the Block Erase (BE). Any address of the block (Please refer to "Table 3. Memory Organization") is a valid address for Block Erase (BE) instruction. The CS# must go high exactly at the byte boundary (the least significant bit of address byte been latched-in); otherwise, the instruction will be rejected and not executed.

The sequence of issuing BE instruction is: CS# goes low → sending BE instruction code → 3-byte address on SI → CS# goes high.

The self-timed Block Erase Cycle time (tBE) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked while the Block Erase cycle is in progress. The WIP sets during the tBE timing, and clears when Block Erase Cycle is completed, and the Write Enable Latch (WEL) bit is reset. If the Block is protected by BP bits (Block Protect Mode), the Block Erase (BE) instruction will not be executed on the block.

**Figure 26. Block Erase (BE) Sequence**



**9-20. Chip Erase (CE)**

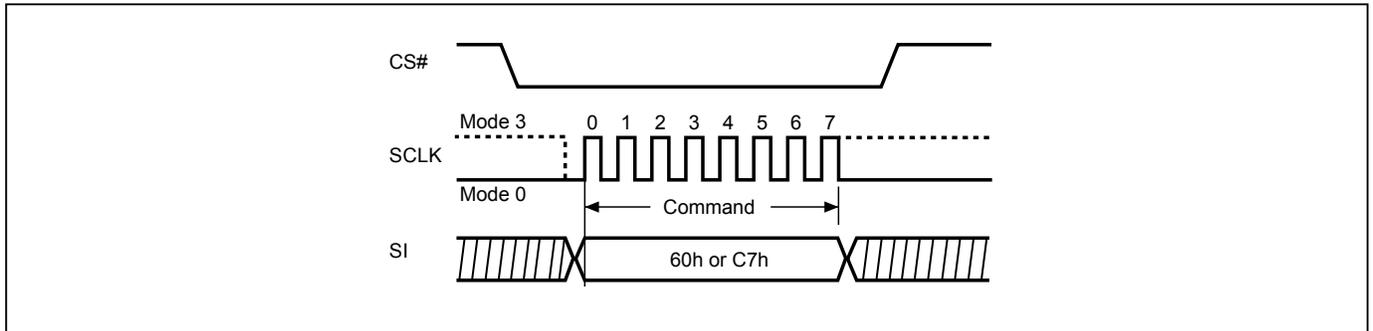
The Chip Erase (CE) instruction is for erasing the data of the whole chip to be "1". A Write Enable (WREN) instruction must be executed to set the Write Enable Latch (WEL) bit before sending the Chip Erase (CE). The CS# must go high exactly at the byte boundary, otherwise the instruction will be rejected and not executed.

The sequence of issuing CE instruction is: CS# goes low→sending CE instruction code→CS# goes high.

The self-timed Chip Erase Cycle time (tCE) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked while the Chip Erase cycle is in progress. The WIP sets during the tCE timing, and clears when Chip Erase Cycle is completed, and the Write Enable Latch (WEL) bit is cleared.

When the chip is under "Block protect (BP) Mode". The Chip Erase(CE) instruction will not be executed, if one (or more) sector is protected by BP3-BP0 bits. It will be only executed when BP3-BP0 all set to "0".

**Figure 27. Chip Erase (CE) Sequence**



**9-21. Page Program (PP)**

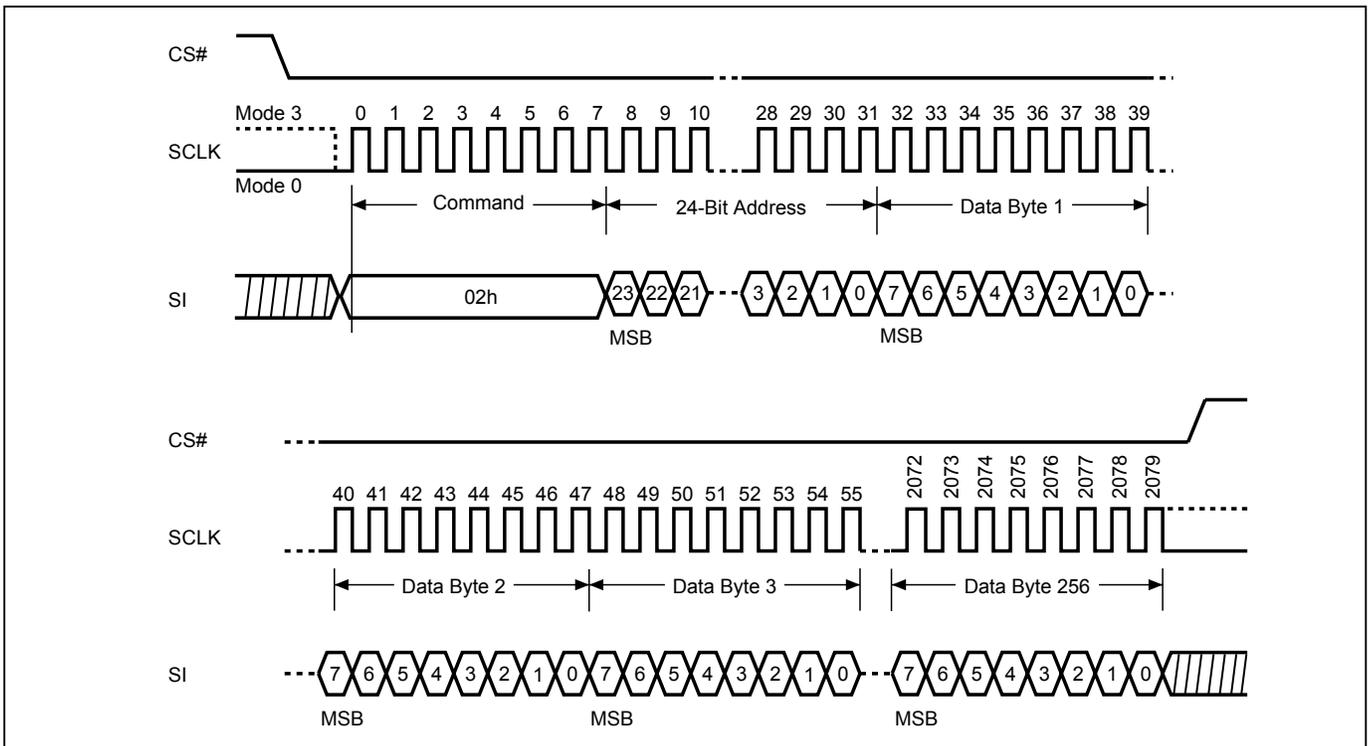
The Page Program (PP) instruction is for programming the memory to be "0". A Write Enable (WREN) instruction must be executed to set the Write Enable Latch (WEL) bit before sending the Page Program (PP). The device programs only the last 256 data bytes sent to the device. If the entire 256 data bytes are going to be programmed, A7-A0 (The eight least significant address bits) should be set to 0. The last address byte (the 8 least significant address bits, A7-A0) should be set to 0 for 256 bytes page program. If A7-A0 are not all zero, transmitted data that exceed page length are programmed from the starting address (24-bit address that last 8 bit are all 0) of currently selected page. If the data bytes sent to the device exceeds 256, the last 256 data byte is programmed at the request page and previous data will be disregarded. If the data bytes sent to the device has not exceeded 256, the data will be programmed at the request address of the page. There will be no effort on the other data bytes of the same page.

The sequence of issuing PP instruction is: CS# goes low → sending PP instruction code → 3-byte address on SI → at least 1-byte on data on SI → CS# goes high.

The CS# must be kept to low during the whole Page Program cycle; The CS# must go high exactly at the byte boundary (the latest eighth bit of data being latched in), otherwise the instruction will be rejected and will not be executed.

The self-timed Page Program Cycle time (t<sub>PP</sub>) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked while the Page Program cycle is in progress. The WIP sets during the t<sub>PP</sub> timing, and clears when Page Program Cycle is completed, and the Write Enable Latch (WEL) bit is cleared. If the Block is protected by BP bits (Block Protect Mode), the Page Program (PP) instruction will not be executed.

**Figure 28. Page Program (PP) Sequence**



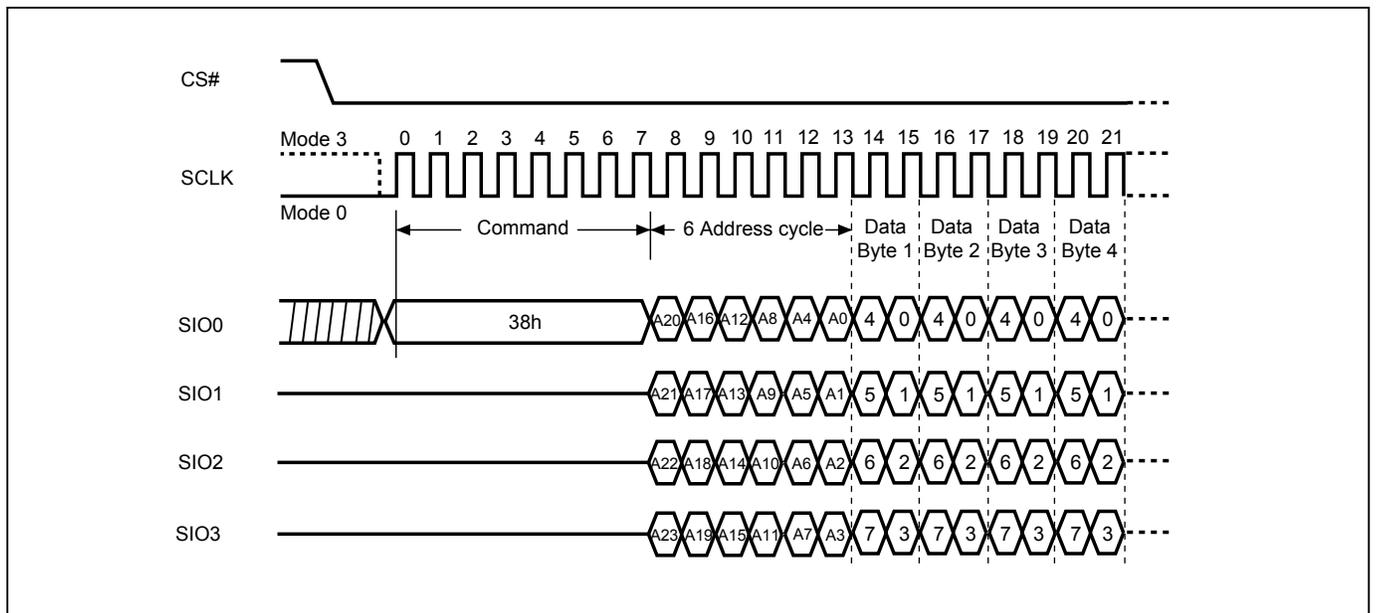
**9-22. 4 x I/O Page Program (4PP)**

The Quad Page Program (4PP) instruction is for programming the memory to be "0". The Quad Page Programming takes four pins: SIO0, SIO1, SIO2, and SIO3 as address and data input, which can improve programmer performance and the effectiveness of application. The other function descriptions are as same as standard page program.

The sequence of issuing 4PP instruction is: CS# goes low → sending 4PP instruction code → 3-byte address on SIO[3:0] → at least 1-byte on data on SIO[3:0] → CS# goes high.

If the page is protected by BP bits (Block Protect Mode), the Quad Page Program (4PP) instruction will not be executed.

**Figure 29. 4 x I/O Page Program (4PP) Sequence**



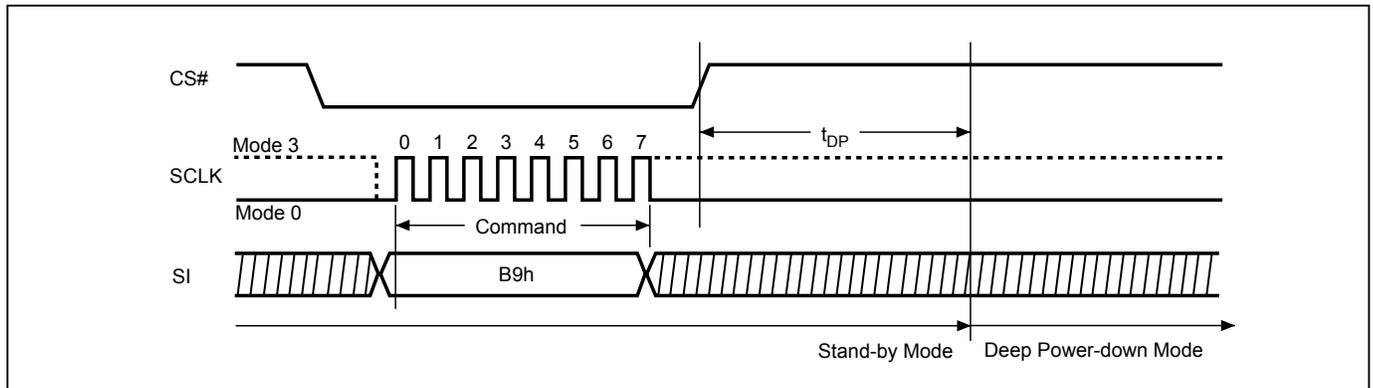
### 9-23. Deep Power-down (DP)

The Deep Power-down (DP) instruction is for setting the device to minimum power consumption (the standby current is reduced from ISB1 to ISB2). The Deep Power-down mode requires the Deep Power-down (DP) instruction to enter, during the Deep Power-down mode, the device is not active and all Write/Program/Erase instruction are ignored. When CS# goes high, it's only in deep power-down mode not standby mode. It's different from Standby mode.

The sequence of issuing DP instruction is: CS# goes low→sending DP instruction code→CS# goes high.

Once the DP instruction is set, all instruction will be ignored except the Release from Deep Power-down mode (RDP) and Read Electronic Signature (RES) instruction and softreset command. (those instructions allow the ID being reading out). When Power-down, or software reset command the deep power-down mode automatically stops, and when power-up, the device automatically is in standby mode. For DP instruction the CS# must go high exactly at the byte boundary (the latest eighth bit of instruction code been latched-in); otherwise, the instruction will not executed. As soon as Chip Select (CS#) goes high, a delay of  $t_{DP}$  is required before entering the Deep Power-down mode.

**Figure 30. Deep Power-down (DP) Sequence**



**9-24. Enter Secured OTP (ENSO)**

The ENSO instruction is for entering the additional 4K-bit secured OTP mode. While device is in 4K-bit secured OTP mode, main array access is not available. The additional 4K-bit secured OTP is independent from main array and may be used to store unique serial number for system identifier. After entering the Secured OTP mode, follow standard read or program procedure to read out the data or update data. The Secured OTP data cannot be updated again once it is lock-down.

The sequence of issuing ENSO instruction is: CS# goes low→ sending ENSO instruction to enter Secured OTP mode→ CS# goes high.

Please note that after issuing ENSO command user can only access secure OTP region with standard read or program procedure. Furthermore, once security OTP is lock down, only read related commands are valid.

**9-25. Exit Secured OTP (EXSO)**

The EXSO instruction is for exiting the additional 4K-bit secured OTP mode.

The sequence of issuing EXSO instruction is: CS# goes low→ sending EXSO instruction to exit Secured OTP mode→ CS# goes high.

**9-26. Read Security Register (RDSCUR)**

The RDSCUR instruction is for reading the value of Security Register bits. The Read Security Register can be read at any time (even in program/erase/write status register/write security register condition) and continuously.

The sequence of issuing RDSCUR instruction is : CS# goes low→sending RDSCUR instruction→Security Register data out on SO→ CS# goes high.

**9-27. Write Security Register (WRSCUR)**

The WRSCUR instruction is for changing the values of Security Register Bits. The WREN (Write Enable) instruction is required before issuing WRSCUR instruction. The WRSCUR instruction may change the values of bit1 (LDSO bit) for customer to lock-down the 4K-bit Secured OTP area. Once the LDSO bit is set to "1", the Secured OTP area cannot be updated any more.

The sequence of issuing WRSCUR instruction is :CS# goes low→ sending WRSCUR instruction → CS# goes high.

The CS# must go high exactly at the boundary; otherwise, the instruction will be rejected and not executed.

## Security Register

The definition of the Security Register bits is as below:

**Erase Fail bit.** The Erase Fail bit is a status flag, which shows the status of last Erase operation. It will be set to "1", if the erase operation fails. It will be set to "0", if the last operation is success. Please note that it will not interrupt or stop any operation in the flash memory.

**Program Fail bit.** The Program Fail bit is a status flag, which shows the status of last Program operation. It will be set to "1", if the program operation fails or the program region is protected. It will be set to "0", if the last operation is success. Please note that it will not interrupt or stop any operation in the flash memory.

**Erase Suspend bit.** Erase Suspend Bit (ESB) indicates the status of Erase Suspend operation. Users may use ESB to identify the state of flash memory. After the flash memory is suspended by Erase Suspend command, ESB is set to "1". ESB is cleared to "0" after erase operation resumes.

**Program Suspend bit.** Program Suspend Bit (PSB) indicates the status of Program Suspend operation. Users may use PSB to identify the state of flash memory. After the flash memory is suspended by Program Suspend command, PSB is set to "1". PSB is cleared to "0" after program operation resumes.

**Secured OTP Indicator bit.** The Secured OTP indicator bit shows the chip is locked by factory or not. When it is "0", it indicates non-factory lock; "1" indicates factory-lock.

**Lock-down Secured OTP (LDSO) bit.** By writing WRSCUR instruction, the LDSO bit may be set to "1" for customer lock-down purpose. However, once the bit is set to "1" (lock-down), the LDSO bit and the 4K-bit Secured OTP area cannot be updated any more. While it is in 4K-bit secured OTP mode, main array access is not allowed.

**Table 8. Security Register Definition**

| bit7     | bit6  | bit5   | bit4     | bit3   | bit2   | bit1   | bit0   |
|----------|---|--|----------|--|--|--|--|
| Reserved | E_FAIL  | P_FAIL   | Reserved | ESB<br>(Erase<br>Suspend bit)  | PSB<br>(Program<br>Suspend bit)  | LDSO<br>(indicate if<br>lock-down)   | Secured OTP<br>indicator bit                       |
| -        | 0=normal<br>Erase<br>succeed<br>1=indicate<br>Erase failed<br>(default=0) | 0=normal<br>Program<br>succeed<br>1=indicate<br>Program<br>failed<br>(default=0) | -        | 0=Erase<br>is not<br>suspended<br>1= Erase<br>suspended<br>(default=0) | 0=Program<br>is not<br>suspended<br>1= Program<br>suspended<br>(default=0) | 0 = not lock-<br>down<br>1 = lock-down<br>(cannot<br>program/<br>erase<br>OTP) | 0 = non-<br>factory<br>lock<br>1 = factory<br>lock |
| Reserved | Volatile bit  | Volatile bit   | Reserved | Volatile bit   | Volatile bit   | Non-volatile<br>bit<br>(OTP)   | Non-volatile<br>bit (OTP)                          |

### 9-28. Program/Erase Suspend/Resume

The device allow the interruption of Sector-Erase, Block-Erase or Page-Program operations and conduct other operations.

After issue suspend command, the system can determine if the device has entered the Erase-Suspended mode through Bit2 (PSB) and Bit3 (ESB) of security register. (please refer to "[Table 8. Security Register Definition](#)")

For "Suspend to Read", "Resume to Read", "Resume to Suspend" timing specification please note "[Figure 31. Suspend to Read Latency](#)", "[Figure 32. Resume to Read Latency](#)" and "[Figure 33. Resume to Suspend Latency](#)".

### 9-29. Erase Suspend

Erase suspend allow the interruption of all erase operations. After the device has entered Erase-Suspended mode, the system can read any sector(s) or Block(s) except those being erased by the suspended erase operation. Reading the sector or Block being erase suspended is invalid.

After erase suspend, WEL bit will be clear, only read related, resume and reset command can be accepted. (including: 03h, 0Bh, 3Bh, 6Bh, BBh, EBh, 5Ah, 06h, 04h, 2Bh, 9Fh, 05h, ABh, 90h, B1h, C1h, B0h, 30h, 66h, 99h, 00h, 15h)

If the system issues an Erase Suspend command after the sector erase operation has already begun, the device will not enter Erase-Suspended mode until 20us time has elapsed.

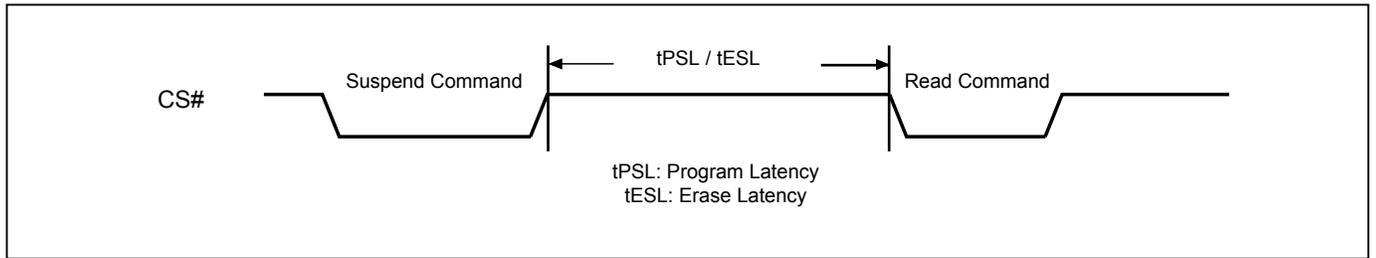
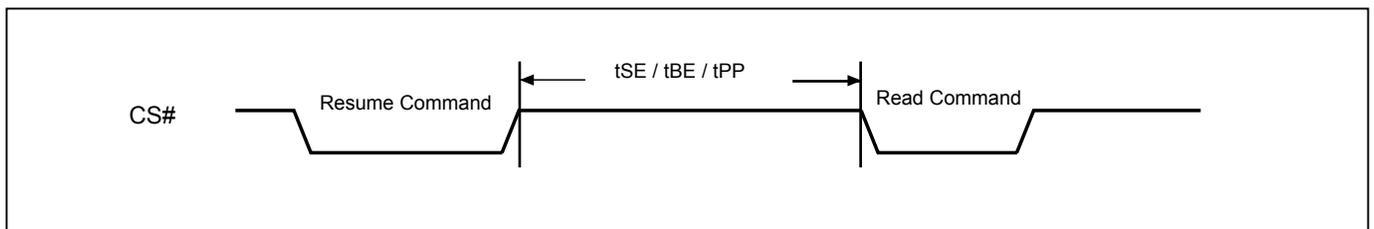
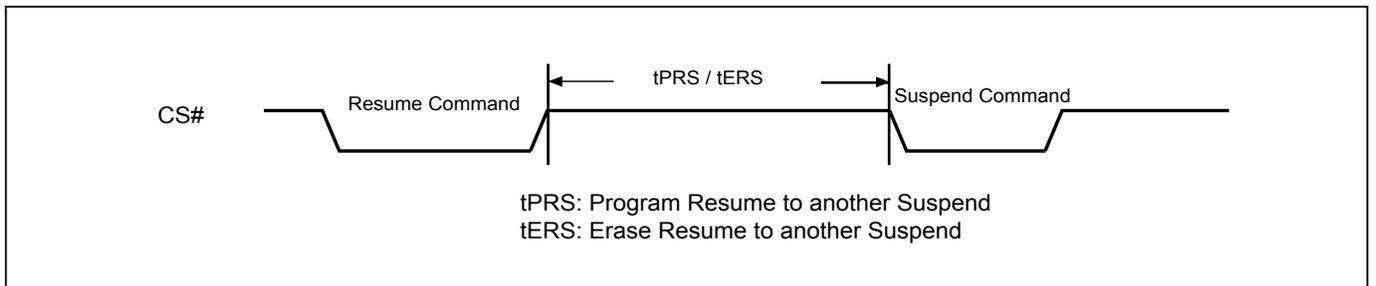
Erase Suspend Bit (ESB) indicates the status of Erase Suspend operation. Users may use ESB to identify the state of flash memory. After the flash memory is suspended by Erase Suspend command, ESB is set to "1". ESB is cleared to "0" after erase operation resumes.

### 9-30. Program Suspend

Program suspend allows the interruption of all program operations. After the device has entered Program-Suspended mode, the system can read any sector(s) or Block(s) except those being programmed by the suspended program operation. Reading the sector or Block being program suspended is invalid.

After program suspend, WEL bit will be cleared, only read related, resume and reset command can be accepted. (including: 03h, 0Bh, 3Bh, 6Bh, BBh, EBh, 5Ah, 06h, 04h, 2Bh, 9Fh, 05h, ABh, 90h, B1h, C1h, B0h, 30h, 66h, 99h, 00h, 15h)

Program Suspend Bit (PSB) indicates the status of Program Suspend operation. Users may use PSB to identify the state of flash memory. After the flash memory is suspended by Program Suspend command, PSB is set to "1". PSB is cleared to "0" after program operation resumes.

**Figure 31. Suspend to Read Latency****Figure 32. Resume to Read Latency****Figure 33. Resume to Suspend Latency**

### 9-31. Write-Resume

The Write operation is being resumed when Write-Resume instruction issued. ESB or PSB (suspend status bit) in Status register will be changed back to "0".

The operation of Write-Resume is as follows: CS# drives low → send write resume command cycle (30H) → drive CS# high. By polling Busy Bit in status register, the internal write operation status could be checked to be completed or not. The user may also wait the time lag of tSE, tBE, tPP for Sector-erase, Block-erase or Page-programming. WREN (command "06") is not required to issue before resume. Resume to another suspend operation requires latency time of 1ms.

Please note that, if "performance enhance mode" is executed during suspend operation, the device can not be resume. To restart the write command, disable the "performance enhance mode" is required. After the "performance enhance mode" is disable, the write-resume command is effective.

### 9-32. No Operation (NOP)

The "No Operation" command is only able to terminate the Reset Enable (RSTEN) command and will not affect any other command.

### 9-33. Software Reset (Reset-Enable (RSTEN) and Reset (RST))

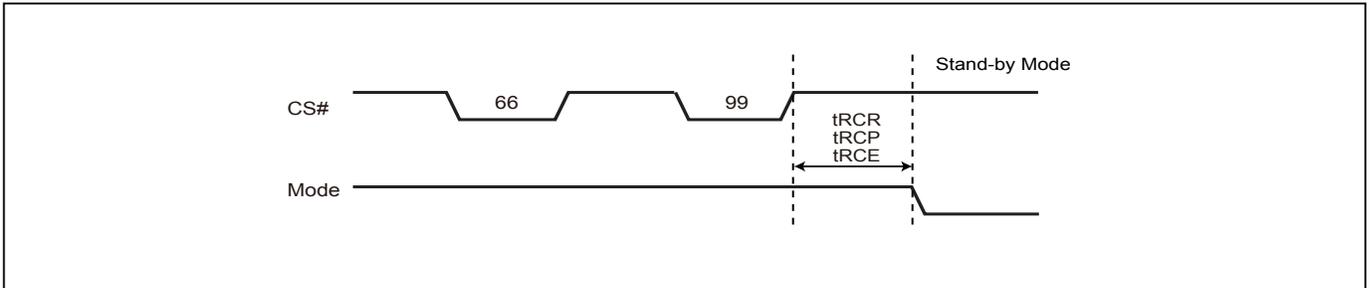
The Software Reset operation combines two instructions: Reset-Enable (RSTEN) command following a Reset (RST) command. It returns the device to a standby mode. All the volatile bits and settings will be cleared then, which makes the device return to the default status as power on.

To execute Reset command (RST), the Reset-Enable (RSTEN) command must be executed first to perform the Reset operation. If there is any other command to interrupt after the Reset-Enable command, the Reset-Enable will be invalid.

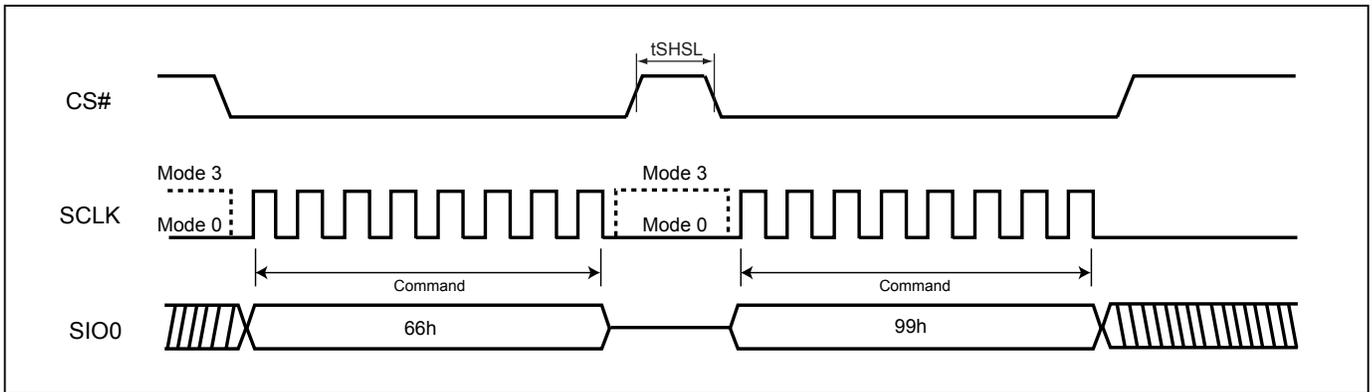
If the Reset command is executed during program or erase operation, the operation will be disabled, the data under processing could be damaged or lost.

The reset time is different depending on the last operation. For details, please refer to "[Table 16. AC CHARACTERISTICS](#)" for tREADY.

**Figure 34. Software Reset Recovery**



**Figure 35. Reset Sequence**



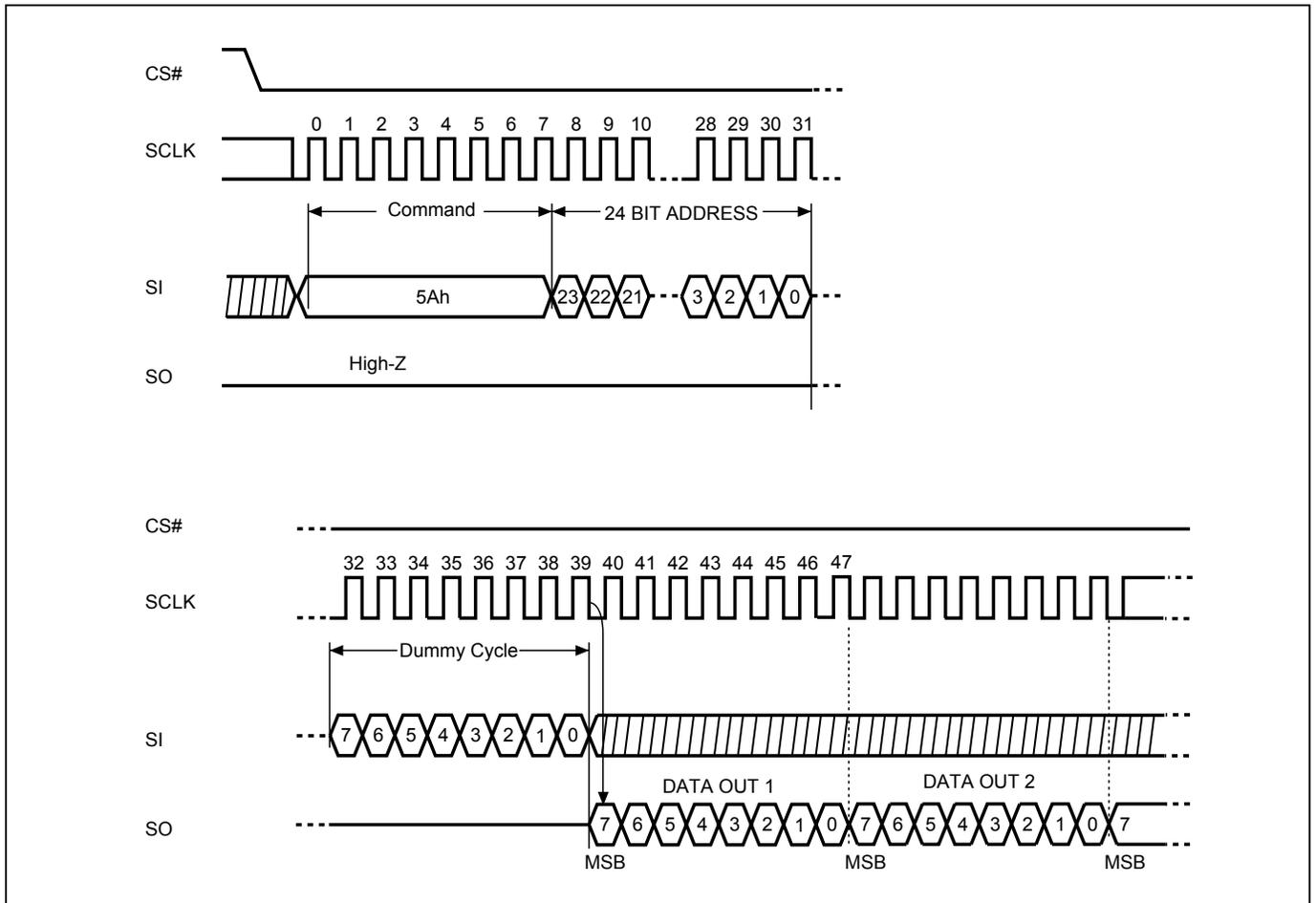
**9-34. Read SFDP Mode (RDSFDP)**

The Serial Flash Discoverable Parameter (SFDP) standard provides a consistent method of describing the functional and feature capabilities of serial flash devices in a standard set of internal parameter tables. These parameter tables can be interrogated by host system software to enable adjustments needed to accommodate divergent features from multiple vendors. The concept is similar to the one found in the Introduction of JEDEC Standard, JESD68 on CFI.

The sequence of issuing RDSFDP instruction is CS# goes low→send RDSFDP instruction (5Ah)→send 3 address bytes on SI pin→send 1 dummy byte on SI pin→read SFDP code on SO→to end RDSFDP operation can use CS# to high at any time during data out.

SFDP is a JEDEC Standard, JESD216A.

**Figure 36. Read Serial Flash Discoverable Parameter (RDSFDP) Sequence**



**Table 9. Signature and Parameter Identification Data Values**

| Description                             | Comment  | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |
|---|--|-------------------|-----------------|-----------------------|-------------|
| SFDP Signature                          | Fixed: 50444653h   | 00h               | 07:00           | 53h                   | 53h         |
|   |  | 01h               | 15:08           | 46h                   | 46h         |
|   |  | 02h               | 23:16           | 44h                   | 44h         |
|   |  | 03h               | 31:24           | 50h                   | 50h         |
| SFDP Minor Revision Number              | Start from 00h   | 04h               | 07:00           | 05h                   | 05h         |
| SFDP Major Revision Number              | Start from 01h   | 05h               | 15:08           | 01h                   | 01h         |
| Number of Parameter Headers             | This number is 0-based. Therefore, 0 indicates 1 parameter header. | 06h               | 23:16           | 02h                   | 02h         |
| Reserved                                |  | 07h               | 31:24           | FFh                   | FFh         |
| ID number (JEDEC)                       | 00h: it indicates a JEDEC specified header.                        | 08h               | 07:00           | 00h                   | 00h         |
| Parameter Table Minor Revision Number   | Start from 00h   | 09h               | 15:08           | 05h                   | 05h         |
| Parameter Table Major Revision Number   | Start from 01h   | 0Ah               | 23:16           | 01h                   | 01h         |
| Parameter Table Length (in double word) | How many DWORDs in the Parameter table                             | 0Bh               | 31:24           | 10h                   | 10h         |
| Parameter Table Pointer (PTP)           | First address of JEDEC Flash Parameter table                       | 0Ch               | 07:00           | 30h                   | 30h         |
|   |  | 0Dh               | 15:08           | 00h                   | 00h         |
|   |  | 0Eh               | 23:16           | 00h                   | 00h         |
| Reserved                                |  | 0Fh               | 31:24           | FFh                   | FFh         |
| ID number (Macronix manufacturer ID)    | it indicates Macronix manufacturer ID                              | 10h               | 07:00           | C2h                   | C2h         |
| Parameter Table Minor Revision Number   | Start from 00h   | 11h               | 15:08           | 00h                   | 00h         |
| Parameter Table Major Revision Number   | Start from 01h   | 12h               | 23:16           | 01h                   | 01h         |
| Parameter Table Length (in double word) | How many DWORDs in the Parameter table                             | 13h               | 31:24           | 04h                   | 04h         |
| Parameter Table Pointer (PTP)           | First address of Macronix Flash Parameter table                    | 14h               | 07:00           | 10h                   | 10h         |
|   |  | 15h               | 15:08           | 01h                   | 01h         |
|   |  | 16h               | 23:16           | 00h                   | 00h         |
| Reserved                                |  | 17h               | 31:24           | FFh                   | FFh         |
| ID number (RPMC)                        | RPMC parameter ID  | 18h               | 07:00           | 03h                   | 03h         |
| Parameter Table Minor Revision Number   | Start from 00h   | 19h               | 15:08           | 00h                   | 00h         |
| Parameter Table Major Revision Number   | Start from 01h   | 1Ah               | 23:16           | 01h                   | 01h         |
| Parameter Table Length (in double word) | How many DWORDs in the Parameter table                             | 1Bh               | 31:24           | 02h                   | 02h         |
| Parameter Table Pointer (PTP)           | First address of RPMC table  | 1Ch               | 07:00           | 00h                   | 00h         |
|   |  | 1Dh               | 15:08           | 01h                   | 01h         |
|   |  | 1Eh               | 23:16           | 00h                   | 00h         |
| Reserved                                |  | 1Fh               | 31:24           | FFh                   | FFh         |

**Table 10. Parameter Table (0): JEDEC Flash Parameter Tables**

| Description  | Comment   | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |
|--|---|-------------------|-----------------|-----------------------|-------------|
| Block/Sector Erase sizes   | 00: Reserved, 01: 4KB erase,<br>10: Reserved,<br>11: not support 4KB erase  | 30h               | 01:00           | 01b                   | E5h         |
| Write Granularity  | 0: 1Byte, 1: 64Byte or larger   |                   | 02              | 1b                    |             |
| Write Enable Instruction<br>Required for Writing to Volatile<br>Status Registers | 0: not required<br>1: required 00h to be written to the<br>status register  |                   | 03              | 0b                    |             |
| Write Enable Opcode Select for<br>Writing to Volatile Status Registers           | 0: use 50h opcode,<br>Note: If target flash status register<br>is nonvolatile, then bits 3 and 4<br>must be set to 00b. |                   | 04              | 0b                    |             |
| Reserved   | Contains 111b and can never be<br>changed   |                   | 07:05           | 111b                  |             |
| 4KB Erase Opcode   |   | 31h               | 15:08           | 20h                   | 20h         |
| (1-1-2) Fast Read (Note2)  | 0=not support 1=support   | 32h               | 16              | 1b                    | F1h         |
| Address Bytes Number used in<br>addressing flash array                           | 00: 3Byte only, 01: 3 or 4Byte,<br>10: 4Byte only, 11: Reserved   |                   | 18:17           | 00b                   |             |
| Double Transfer Rate (DTR)<br>Clocking   | 0=not support 1=support   |                   | 19              | 0b                    |             |
| (1-2-2) Fast Read  | 0=not support 1=support   |                   | 20              | 1b                    |             |
| (1-4-4) Fast Read  | 0=not support 1=support   |                   | 21              | 1b                    |             |
| (1-1-4) Fast Read  | 0=not support 1=support   |                   | 22              | 1b                    |             |
| Reserved   |   |                   | 23              | 1b                    |             |
| Reserved   |   | 33h               | 31:24           | FFh                   | FFh         |
| Flash Memory Density   |   | 37h:34h           | 31:00           | 07FF FFFFh            |             |
| (1-4-4) Fast Read Number of Wait<br>states (Note3)                               | 0 0110b: 6 dummy clocks   | 38h               | 04:00           | 0 0100b               | 44h         |
| (1-4-4) Fast Read Number of<br>Mode Bits (Note4)                                 | 010b: 2 mode bits   |                   | 07:05           | 010b                  |             |
| (1-4-4) Fast Read Opcode   |   | 39h               | 15:08           | EBh                   | EBh         |
| (1-1-4) Fast Read Number of Wait<br>states                                       | 0 1000b: 8 dummy clocks   | 3Ah               | 20:16           | 0 1000b               | 08h         |
| (1-1-4) Fast Read Number of<br>Mode Bits   | 000b: Mode Bits not support   |                   | 23:21           | 000b                  |             |
| (1-1-4) Fast Read Opcode   |   | 3Bh               | 31:24           | 6Bh                   | 6Bh         |



| Description                             | Comment   | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |
|---|---|-------------------|-----------------|-----------------------|-------------|
| (1-1-2) Fast Read Number of Wait states | 0 1000b: 8 dummy clocks   | 3Ch               | 04:00           | 0 1000b               | 08h         |
| (1-1-2) Fast Read Number of Mode Bits   | 000b: Mode Bits not supported   |                   | 07:05           | 000b                  |             |
| (1-1-2) Fast Read Opcode                |   | 3Dh               | 15:08           | 3Bh                   | 3Bh         |
| (1-2-2) Fast Read Number of Wait states | 0 0100b: 4 dummy clocks   | 3Eh               | 20:16           | 0 0100b               | 04h         |
| (1-2-2) Fast Read Number of Mode Bits   | 000b: Mode Bits not supported   |                   | 23:21           | 000b                  |             |
| (1-2-2) Fast Read Opcode                |   | 3Fh               | 31:24           | BBh                   | BBh         |
| (2-2-2) Fast Read                       | 0=not support 1=support   | 40h               | 00              | 0b                    | EEh         |
| Reserved                                |   |                   | 03:01           | 111b                  |             |
| (4-4-4) Fast Read                       | 0=not support 1=support   |                   | 04              | 0b                    |             |
| Reserved                                |   |                   | 07:05           | 111b                  |             |
| Reserved                                |   | 43h:41h           | 31:08           | FFh                   | FFh         |
| Reserved                                |   | 45h:44h           | 15:00           | FFh                   | FFh         |
| (2-2-2) Fast Read Number of Wait states | 0 0000b: Wait states (Dummy Clocks) not supported                                 | 46h               | 20:16           | 0 0000b               | 00h         |
| (2-2-2) Fast Read Number of Mode Bits   | 000b: Mode Bits not supported   |                   | 23:21           | 000b                  |             |
| (2-2-2) Fast Read Opcode                |   | 47h               | 31:24           | FFh                   | FFh         |
| Reserved                                |   | 49h:48h           | 15:00           | FFh                   | FFh         |
| (4-4-4) Fast Read Number of Wait states | 0 0000b: Wait states (Dummy Clocks) not supported                                 | 4Ah               | 20:16           | 0 0000b               | 00h         |
| (4-4-4) Fast Read Number of Mode Bits   | 000b: Mode Bits not supported   |                   | 23:21           | 000b                  |             |
| (4-4-4) Fast Read Opcode                |   | 4Bh               | 31:24           | FFh                   | FFh         |
| Sector Type 1 Size                      | Sector/block size = 2 <sup>N</sup> bytes (Note5)<br>4KB                           | 4Ch               | 07:00           | 0Ch                   | 0Ch         |
| Sector Type 1 erase Opcode              |   | 4Dh               | 15:08           | 20h                   | 20h         |
| Sector Type 2 Size                      | Sector/block size = 2 <sup>N</sup> bytes<br>32KB                                  | 4Eh               | 23:16           | 0Fh                   | 0Fh         |
| Sector Type 2 erase Opcode              |   | 4Fh               | 31:24           | 52h                   | 52h         |
| Sector Type 3 Size                      | Sector/block size = 2 <sup>N</sup> bytes<br>64KB                                  | 50h               | 07:00           | 10h                   | 10h         |
| Sector Type 3 erase Opcode              |   | 51h               | 15:08           | D8h                   | D8h         |
| Sector Type 4 Size                      | Sector/block size = 2 <sup>N</sup> bytes<br>0x00b: this sector type doesn't exist | 52h               | 23:16           | 00h                   | 00h         |
| Sector Type 4 erase Opcode              |   | 53h               | 31:24           | FFh                   | FFh         |

| Description                                     | Comment  | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |
|---|--|-------------------|-----------------|-----------------------|-------------|
| Multiplier for Sector/Chip Erase Time (Maximum) | Multiplier value: 0h~Fh (0~15)<br>Max. time = 2 * (Multiplier + 1) *<br>Typical Time | 55h:54h           | 03:00           | 0010b                 | 7232h       |
| Sector Type 1 Erase Time (Typical)              | Count value: 00h~1Fh (0~31)<br>Typical Time = (Count + 1) * Units                    |                   | 08:04           | 0 0011b               |             |
|   | Units<br>00: 1ms, 01: 16ms<br>10b: 128ms, 11b: 1s                                    |                   | 10:09           | 01b                   |             |
| Sector Type 2 Erase Time (Typical)              | Count value: 00h~1Fh (0~31)<br>Typical Time = (Count + 1) * Units                    |                   | 15:11           | 0 1110b               |             |
|   | Units<br>00: 1ms, 01: 16ms<br>10b: 128ms, 11b: 1s                                    | 57h:56h           | 17:16           | 01b                   | 00F5h       |
| Sector Type 3 Erase Time (Typical)              | Count value: 00h~1Fh (0~31)<br>Typical Time = (Count + 1) * Units                    |                   | 22:18           | 1 1101b               |             |
|   | Units<br>00: 1 ms, 01: 16 ms<br>10b: 128ms, 11b: 1s                                  |                   | 24:23           | 01b                   |             |
| Sector Type 4 Erase Time (Typical)              | Count value: 00h~1Fh (0~31)<br>Typical Time = (Count + 1) * Units                    |                   | 29:25           | 0 0000b               |             |
|   | Units<br>00: 1ms, 01: 16ms<br>10b: 128 ms, 11b: 1 s                                  | 31:30             | 00b             |                       |             |
| Multiplier for Page/Byte Program Time (Maximum) | Multiplier value: 0h~Fh (0~15)<br>Max. time = 2 * (Multiplier + 1) *<br>Typical Time | 58h               | 03:00           | 0010b                 | 82h         |
| Page Program Size                               | Page size = 2 <sup>N</sup> bytes<br>2 <sup>8</sup> = 256 bytes, 8h = 1000b           |                   | 07:04           | 1000h                 |             |
| Page Program Time (Typical)                     | Count value: 00h~1Fh (0~31)<br>Typical Time = (Count + 1) * Units                    | 5Ah:59h           | 12:08           | 0 0101b               | 4225h       |
|   | Units<br>0: 8us, 1: 64us   |                   | 13              | 1b                    |             |
| Byte Program Time, First Byte (Typical)         | Count value: 0h~Fh (0~15)<br>Typical Time = (Count + 1) * Units                      |                   | 17:14           | 1000b                 |             |
|   | Units<br>0: 1us, 1: 8us  |                   | 18              | 0b                    |             |
| Byte Program Time, Additional Byte (Typical)    | Count value: 0h~Fh (0~15)<br>Typical Time = (Count + 1) * Units                      |                   | 22:19           | 1000b                 |             |
|   | Units<br>0: 1us, 1: 8us  |                   | 23              | 0b                    |             |

| Description                                     | Comment  | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |
|---|--|-------------------|-----------------|-----------------------|-------------|
| Chip Erase Time<br>(Typical)                    | Count value: 00h~1Fh (0~31)<br>Typical Time = (Count + 1) * Units  | 5Bh               | 28:24           | 1 0011b               | D3h         |
|   | Units<br>00: 16ms, 01: 256ms<br>10: 4s, 11: 64s  |                   | 30:29           | 10b                   |             |
| Reserved  | Reserved: 1b   |                   | 31              | 1b                    |             |
| Prohibited Operations During<br>Program Suspend | <ul style="list-style-type: none"> <li>◆ xxx0b: May not initiate a new erase anywhere</li> <li>◆ xx0xb: May not initiate a new page program anywhere</li> <li>◆ x1xxb: May not initiate a read in the program suspended page size</li> <li>◆ 1xxxb: The erase and program restrictions in bits 1:0 are sufficient</li> </ul>                       | 5Ch               | 03:00           | 1100b                 | CCh         |
| Prohibited Operations During<br>Erase Suspend   | <ul style="list-style-type: none"> <li>◆ xxx0b: May not initiate a new erase anywhere</li> <li>◆ xx1xb: May not initiate a page program in the erase suspended sector size</li> <li>◆ x1xxb: May not initiate a read in the erase suspended sector size</li> <li>◆ 1xxxb: The erase and program restrictions in bits 5:4 are sufficient</li> </ul> |                   | 07:04           | 1100b                 |             |
| Reserved  | Reserved: 1b   | 5Eh:5Dh           | 08              | 1b                    | F67Fh       |
| Program Resume to Suspend<br>Interval (Typical) | Count value: 0h~Fh (0~15)<br>Typical Time = (Count + 1) * 64us   |                   | 12:09           | 1111b                 |             |
| Program Suspend Latency<br>(Max.)               | Count value: 00h~1Fh (0~31)<br>Maximum Time = (Count + 1) * Units  |                   | 17:13           | 1 0011b               |             |
|   | Units<br>00: 128ns, 01: 1us<br>10: 8us, 11: 64us   |                   | 19:18           | 01b                   |             |
| Erase Resume to Suspend<br>Interval (Typical)   | Count value: 0h~Fh (0~15)<br>Typical Time = (Count + 1) * 64us   |                   | 23:20           | 1111b                 |             |
| Erase Suspend Latency<br>(Max.)                 | Count value: 00h~1Fh (0~31)<br>Maximum Time = (Count + 1) * Units  | 5Fh               | 28:24           | 1 0011b               | 33h         |
|   | Units<br>00: 128ns, 01: 1us<br>10: 8us, 11: 64us   |                   | 30:29           | 01b                   |             |
| Suspend / Resume supported                      | 0= Support 1= Not supported  |                   | 31              | 0b                    |             |
| Program Resume Instruction                      | Instruction to Resume a Program  | 60h               | 07:00           | 30h                   | 30h         |
| Program Suspend Instruction                     | Instruction to Suspend a Program   | 61h               | 15:08           | B0h                   | B0h         |
| Erase Resume Instruction                        | Instruction to Resume Write/Erase  | 62h               | 23:16           | 30h                   | 30h         |
| Erase Suspend Instruction                       | Instruction to Suspend Write/Erase   | 63h               | 31:24           | B0h                   | B0h         |



| Description   | Comment   | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |
|---|---|-------------------|-----------------|-----------------------|-------------|
| Reserved  | Reserved: 11b   |                   | 01:00           | 11b                   |             |
| Status Register Polling Device Busy                             | <ul style="list-style-type: none"> <li>◆ Bit 2: Read WIP bit [0] by 05h Read instruction</li> <li>◆ Bit 3: Read bit 7 of Status Register by 70h Read instruction (0=not support 1=support)</li> <li>◆ Bit 07:04, Reserved: 1111b</li> </ul> | 64h               | 07:02           | 1111 01b              | F7h         |
| Release from Deep Power-down (RDP) Delay (Max.)                 | Count value: 00h~1Fh (0~31)<br>Maximum Time = (Count + 1) * Units   | 67h:65h           | 12:08           | 0 0011b               | 5CD5C3h     |
|   | Units<br>00: 128ns, 01: 1us<br>10: 8us, 11: 64us  |                   | 14:13           | 10b                   |             |
| Release from Deep Power-down (RDP) Instruction                  | Instruction to Exit Deep Power Down   |                   | 22:15           | 1010 1011b (ABh)      |             |
| Enter Deep Power Down Instruction                               | Instruction to Enter Deep Power Down  |                   | 30:23           | 1011 1001 (B9h)       |             |
| Deep Power Down Supported                                       | 0: Supported 1: Not supported   |                   | 31              | 0b                    |             |
| 4-4-4 Mode Disable Sequences                                    | Supported Methods to Reset QPI Mode<br>◆ xx1xb: issue F5h instruction   | 69h:68h           | 03:00           | 0000b                 | FF00h       |
| 4-4-4 Mode Enable Sequences                                     | Supported methods to enter QPI mode<br>◆ x_x1xxb: issue instruction 35h<br>◆ 1_xxxb: Reserved   |                   | 08:04           | 1 0000b               |             |
| 0-4-4 mode Supported  | Performance Enhance Mode, Continuous Read, Execute in Place<br>0: Not supported 1: Supported  |                   | 09              | 1b                    |             |
| 0-4-4 Mode Exit Method  | Exit Performance Enhance Mode<br>◆ xx_xxx1b: Mode Bits[7:0] = 00h will terminate this mode at the end of the current read operation.<br>◆ xx_x1xxb: Reserved<br>◆ x1_xxxb: Reserved<br>◆ 1x_xxxb: Reserved                                  |                   | 15:10           | 11 1111b              |             |
| 0-4-4 Mode Entry Method   | Enter Performance Enhance Mode<br>◆ xxx1b: Mode Bits[7:0] = A5h Note: QE must be set prior to using this mode<br>◆ x1xxb: Reserved<br>◆ 1xxb: Reserved  | 6Ah               | 19:16           | 1101h                 | 2Dh         |
| Quad Enable (QE) bit Requirements                               | ◆ 010b: QE is bit 6 of Status Register. where 1=Quad Enable or 0=not Quad Enable  |                   | 22:20           | 010b                  |             |
| HOLD and WP Disable by bit 4 of Extended Configuration Register | 0: Not supported  |                   | 23              | 0b                    |             |
| Reserved  |   | 6Bh               | 31:24           | FFh                   | FFh         |

| Description  | Comment   | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |
|--|---|-------------------|-----------------|-----------------------|-------------|
| Volatile or Non-Volatile Register and Write Enable Instruction for Status Register 1 | <ul style="list-style-type: none"> <li>◆ xxx_xxx1b: Non-Volatile Status Register 1, powers-up to last written value, use instruction 06h to enable write</li> <li>◆ x1x_xxxxb: Reserved</li> <li>◆ 1xx_xxxxb: Reserved</li> </ul>   | 6Ch               | 06:00           | 110 0001b             | E1h         |
| Reserved   |   |                   | 07              | 1b                    |             |
| Soft Reset and Rescue Sequence Support   | Return the device to its default power-on state<br><ul style="list-style-type: none"> <li>◆ x1_xxxxb: issue reset enable instruction 66h, then issue reset instruction 99h.</li> </ul>  | 6Dh               | 13:08           | 11 0000b              | 30h         |
|  |   |                   | 15:14           | 00b                   |             |
| Exit 4-Byte Addressing   | <ul style="list-style-type: none"> <li>◆ xx_xxxx_xxx1b: issue instruction E9h to exit 4-Byte address mode (write enable instruction 06h is not required)</li> <li>◆ xx_xxxx_x1xxb: 8-bit volatile extended address register used to define A[31:A24] bits. Read with instruction C8h. Write instruction is C5h, data length is 1 byte. Return to lowest memory segment by setting A[31:24] to 00h and use 3-Byte addressing.</li> <li>◆ xx_xx1x_xxxxb: Hardware reset</li> <li>◆ xx_x1xx_xxxxb: Software reset (see bits 13:8 in this DWORD)</li> <li>◆ xx_1xxx_xxxxb: Power cycle</li> <li>◆ x1_xxxx_xxxxb: Reserved</li> <li>◆ 1x_xxxx_xxxxb: Reserved</li> </ul> | 6Eh               | 23:16           | 1100 0000b            | C0h         |

| Description             | Comment  | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |
|-------------------------|--|-------------------|-----------------|-----------------------|-------------|
| Enter 4-Byte Addressing | <ul style="list-style-type: none"> <li>◆ xxxx_xxx1b: issue instruction B7h (preceding write enable not required)</li> <li>◆ xxxx_x1xxb: 8-bit volatile extended address register used to define A[31:24] bits. Read with instruction C8h. Write instruction is C5h with 1 byte of data. Select the active 128 Mbit memory segment by setting the appropriate A[31:24] bits and use 3-Byte addressing.</li> <li>◆ xx1x_xxxxb: Supports dedicated 4-Byte address instruction set. Consult vendor data sheet for the instruction set definition.</li> <li>◆ 1xxx_xxxxb: Reserved</li> </ul> | 6Fh               | 31:24           | 1000 0000b            | 80h         |

**Table 11. RPMC Parameter**

| Description   | Comment   | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |
|---|---|-------------------|-----------------|-----------------------|-------------|
| Flash_Hardening   | 0=Flash Hardening is supported.<br>1=Flash Hardening is not supported                     | 100h              | 00              | 0b                    | 3Ch         |
| MC_Size   | 0= Monotonic counter size is 32 bit<br>1= Reserved  |                   | 01              | 0b                    |             |
| Busy_Polling_Method :   | 0= Poll for OP1 busy using<br>OP2 Extended Status[0]<br>1= Poll for OP1 busy using Status |                   | 02              | 1b                    |             |
| Reserved  |   |                   | 03              | 1b                    |             |
| Num_Counter-1:  | Number of supported counters-1.   |                   | 07:04           | 0011b                 |             |
| OP1 Opcode  |   | 101h              | 15:08           | 9Bh                   | 9Bh         |
| OP2 Opcode  |   | 102h              | 23:16           | 96h                   | 96h         |
| Update_Rate   | : Rate of Update = $5 * (2^{\text{Update\_Rate}})$ seconds                                | 103h              | 27:24           | 0000b                 | F0h         |
| Reserved  | : Must be 0FH   |                   | 31:28           | Fh                    |             |
| Read Counter Polling Delay<br>Typical case to calculate HMAC<br>two times | 0 : polling delay_read counter  | 104h              | 04:00           | 00101b                | C5h         |
|   | units (00=1us, 01=16us, 10=128us,<br>11=1ms)  |                   | 06:05           | 10b                   |             |
|   | reserved  |                   | 07              | 1b                    |             |
| Write Counter Polling Short Delay   | 0 : polling_short_delay_write_<br>counter   | 105h              | 12:08           | 00100b                | A4h         |
|   | units (00=1us, 01=16us, 10=128us,<br>11=1ms)  |                   | 14:13           | 01b                   |             |
|   | reserved  |                   | 15              | 1b                    |             |
| Write Counter Polling Long Delay  | Bits4:0 : polling_long_delay_write_<br>counter  | 106h              | 20:16           | 00010b                | C2h         |
|   | Bits 6:5 : units (00=1ms,<br>01=16ms,10=128ms, 11= 1s)                                    |                   | 22:21           | 10b                   |             |
|   | Bit 7 : reserved  |                   | 23              | 1b                    |             |
| Reserved  | : Must be FF  | 107h              | 31:24           | FFh                   | FFh         |

**Table 12. Parameter Table (1): Macronix Flash Parameter Tables**

| Description  | Comment   | Add (h)<br>(Byte) | DW Add<br>(Bit) | Data (h/b)<br>(Note1) | Data<br>(h) |     |
|--|---|-------------------|-----------------|-----------------------|-------------|-----|
| Vcc Supply Maximum Voltage   | 2000h=2.000V<br>2700h=2.700V<br>3600h=3.600V  | 111h:110h         | 07:00<br>15:08  | 00h<br>36h            | 00h<br>36h  |     |
| Vcc Supply Minimum Voltage   | 1650h=1.650V<br>2250h=2.250V<br>2350h=2.350V<br>2700h=2.700V                          | 113h: 112h        | 23:16<br>31:24  | 00h<br>27h            | 00h<br>27h  |     |
| H/W Reset# pin   | 0=not support 1=support   | 115h: 114h        | 00              | 0b                    | 799Ch       |     |
| H/W Hold# pin  | 0=not support 1=support   |                   | 01              | 0b                    |             |     |
| Deep Power Down Mode   | 0=not support 1=support   |                   | 02              | 1b                    |             |     |
| S/W Reset  | 0=not support 1=support   |                   | 03              | 1b                    |             |     |
| S/W Reset Opcode   | Reset Enable (66h) should be issued before Reset Opcode                               |                   | 11:04           | 1001 1001b<br>(99h)   |             |     |
| Program Suspend/Resume   | 0=not support 1=support   |                   | 12              | 1b                    |             |     |
| Erase Suspend/Resume   | 0=not support 1=support   |                   | 13              | 1b                    |             |     |
| Reserved   |   |                   | 14              | 1b                    |             |     |
| Wrap-Around Read mode  | 0=not support 1=support   |                   | 15              | 0b                    |             |     |
| Wrap-Around Read mode Opcode   |   |                   | 116h            | 23:16                 |             | FFh |
| Wrap-Around Read data length   | 08h:support 8B wrap-around read<br>16h:8B&16B<br>32h:8B&16B&32B<br>64h:8B&16B&32B&64B | 117h              | 31:24           | FFh                   | FFh         |     |
| Individual block lock  | 0=not support 1=support   | 11Bh: 118h        | 00              | 0b                    | CBFCh       |     |
| Individual block lock bit<br>(Volatile/Nonvolatile)                  | 0=Volatile 1=Nonvolatile  |                   | 01              | 0b                    |             |     |
| Individual block lock Opcode   |   |                   | 09:02           | FFh                   |             |     |
| Individual block lock Volatile<br>protect bit default protect status | 0=protect 1=unprotect   |                   | 10              | 0b                    |             |     |
| Secured OTP  | 0=not support 1=support   |                   | 11              | 1b                    |             |     |
| Read Lock  | 0=not support 1=support   |                   | 12              | 0b                    |             |     |
| Permanent Lock   | 0=not support 1=support   |                   | 13              | 0b                    |             |     |
| Reserved   |   |                   | 15:14           | 11b                   |             |     |
| Reserved   |   |                   | 31:16           | FFh                   |             | FFh |
| Reserved   |   |                   | 11Fh: 11Ch      | 31:00                 |             | FFh |

Note 1: h/b is hexadecimal or binary.

Note 2: **(x-y-z)** means I/O mode nomenclature used to indicate the number of active pins used for the opcode (x), address (y), and data (z). At the present time, the only valid Read SFDP instruction modes are: (1-1-1), (2-2-2), and (4-4-4)

Note 3: **Wait States** is required dummy clock cycles after the address bits or optional mode bits.

Note 4: **Mode Bits** is optional control bits that follow the address bits. These bits are driven by the system controller if they are specified. (eg, read performance enhance toggling bits)

Note 5: 4KB=2<sup>0Ch</sup>, 32KB=2<sup>0Fh</sup>, 64KB=2<sup>10h</sup>

Note 6: All unused and undefined area data is blank FFh for SFDP Tables that are defined in Parameter Identification Header. All other areas beyond defined SFDP Table are reserved by Macronix.

## 10. POWER-ON STATE

The device is at below states when power-up:

- Standby mode (please note it is not deep power-down mode)
- Write Enable Latch (WEL) bit is reset

The device must not be selected during power-up and power-down stage unless the VCC achieves below correct level:

- VCC minimum at power-up stage and then after a delay of tVSL
- GND at power-down

Please note that a pull-up resistor on CS# may ensure a safe and proper power-up/down level.

An internal power-on reset (POR) circuit may protect the device from data corruption and inadvertent data change during power up state. When VCC is lower than VWI (POR threshold voltage value), the internal logic is reset and the flash device has no response to any command.

For further protection on the device, if the VCC does not reach the VCC minimum level, the correct operation is not guaranteed. The read, write, erase, and program command should be sent after the below time delay:

- tVSL after VCC reached VCC minimum level

Please refer to the *"Figure 43. Power-up Timing"*.

Note:

- To stabilize the VCC level, the VCC rail decoupled by a suitable capacitor close to package pins is recommended. (generally around 0.1uF)
- At power-down stage, the VCC drops below VWI level, all operations are disable and device has no response to any command. The data corruption might occur during the stage while a write, program, erase cycle is in progress.

## 11. ELECTRICAL SPECIFICATIONS

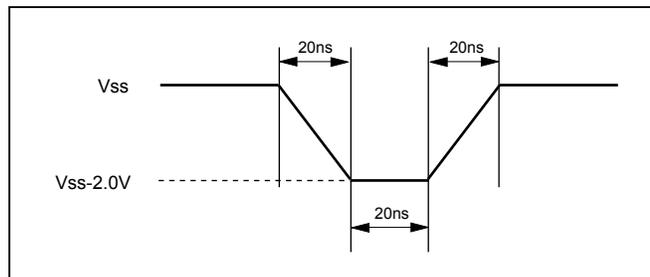
**Table 13. ABSOLUTE MAXIMUM RATINGS**

| RATING                        |                  | VALUE             |
|-------------------------------|------------------|-------------------|
| Ambient Operating Temperature | Industrial grade | -40°C to 85°C     |
| Storage Temperature           |                  | -65°C to 150°C    |
| Applied Input Voltage         |                  | -0.5V to VCC+0.5V |
| Applied Output Voltage        |                  | -0.5V to VCC+0.5V |
| VCC to Ground Potential       |                  | -0.5V to 4.0V     |

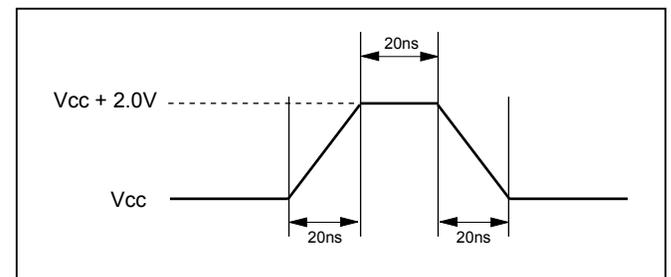
**NOTICE:**

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is stress rating only and functional operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended period may affect reliability.
2. Specifications contained within the following tables are subject to change.
3. During voltage transitions, all pins may overshoot Vss to -2.0V and Vcc to +2.0V for periods up to 20ns, see [Figure 37](#), and [Figure 38](#).

**Figure 37. Maximum Negative Overshoot Waveform**



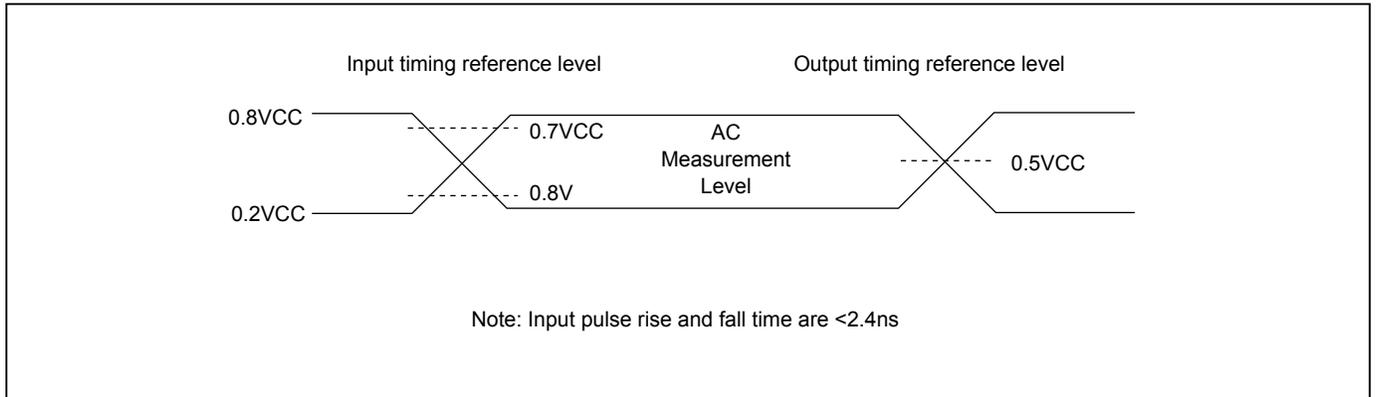
**Figure 38. Maximum Positive Overshoot Waveform**



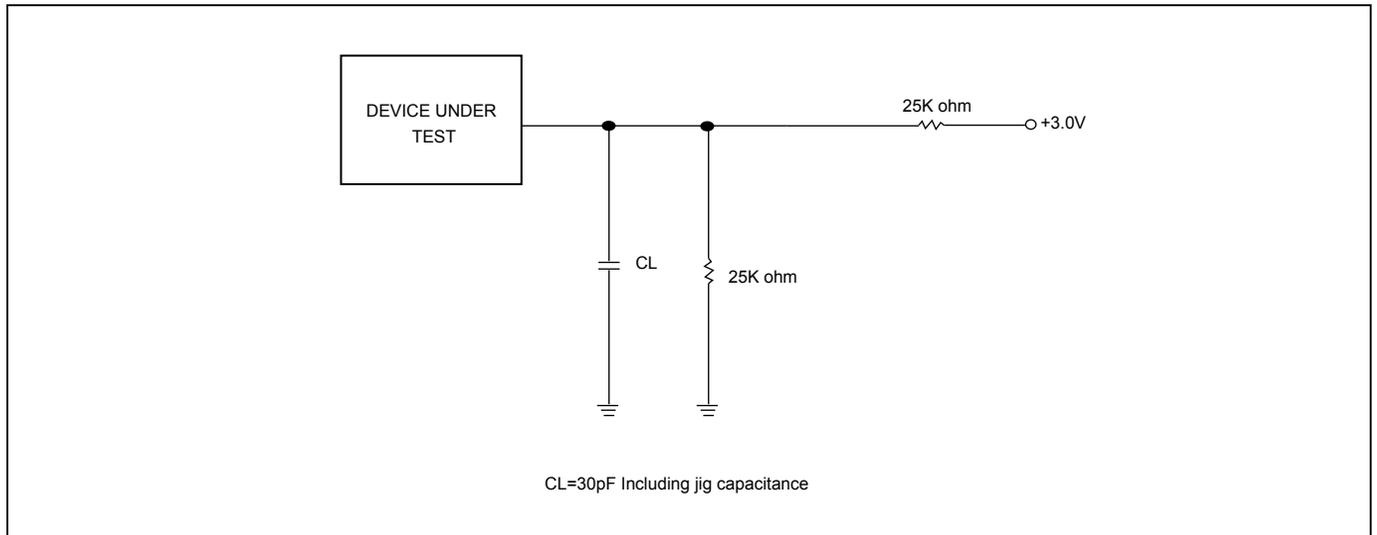
**Table 14. CAPACITANCE TA = 25°C, f = 1.0 MHz**

| Symbol | Parameter          | Min. | Typ. | Max. | Unit | Conditions |
|--------|--------------------|------|------|------|------|------------|
| CIN    | Input Capacitance  |      |      | 6    | pF   | VIN = 0V   |
| COU    | Output Capacitance |      |      | 8    | pF   | VOUT = 0V  |

**Figure 39. INPUT TEST WAVEFORMS AND MEASUREMENT LEVEL**



**Figure 40. OUTPUT LOADING**



**Table 15. DC CHARACTERISTICS**

(Temperature = -40°C to 85°C, VCC = 2.7V ~ 3.6V)

| Symbol | Parameter   | Notes | Min.    | Typ. | Max.    | Units | Test Conditions   |
|--------|---|-------|---------|------|---------|-------|---|
| ILI    | Input Load Current                                      | 1     |         |      | ±2      | μA    | VCC = VCC Max,<br>VIN = VCC or GND                        |
| ILO    | Output Leakage Current                                  | 1     |         |      | ±2      | μA    | VCC = VCC Max,<br>VOUT = VCC or GND                       |
| ISB1   | VCC Standby Current                                     | 1     |         | 10   | 60      | μA    | VIN = VCC or GND,<br>CS# = VCC                            |
| ISB2   | Deep Power-down Current                                 |       |         | 3    | 20      | μA    | VIN = VCC or GND,<br>CS# = VCC                            |
| ICC1   | VCC Read  | 1     |         | 10   | 17      | mA    | f=84MHz, (4 x I/O read)<br>SCLK=0.1VCC/0.9VCC,<br>SO=Open |
| ICC2   | VCC Program Current (PP)                                | 1     |         | 15   | 25      | mA    | Program in Progress,<br>CS# = VCC                         |
| ICC3   | VCC Write Status Register (WRSR) Current                |       |         | 15   | 20      | mA    | Program status register in progress, CS#=VCC              |
| ICC4   | VCC Sector/Block (32K, 64K) Erase Current (SE/BE/BE32K) | 1     |         | 15   | 25      | mA    | Erase in Progress,<br>CS#=VCC                             |
| ICC5   | VCC Chip Erase Current (CE)                             | 1     |         | 15   | 25      | mA    | Erase in Progress,<br>CS#=VCC                             |
| VIL    | Input Low Voltage                                       |       | -0.5    |      | 0.8     | V     |   |
| VIH    | Input High Voltage                                      |       | 0.7VCC  |      | VCC+0.4 | V     |   |
| VOL    | Output Low Voltage                                      |       |         |      | 0.2     | V     | IOL = 100μA   |
| VOH    | Output High Voltage                                     |       | VCC-0.2 |      |         | V     | IOH = -100μA  |

**Notes :**

1. Typical values at VCC = 3.3V, T = 25°C. These currents are valid for all product versions (package and speeds).
2. Typical value is calculated by simulation.

**Table 16. AC CHARACTERISTICS**

(Temperature = -40°C to 85°C, VCC = 2.7V ~ 3.6V)

| Symbol               | Alt. | Parameter  | Min.                 | Typ.                               | Max. | Unit |
|----------------------|------|--|----------------------|------------------------------------|------|------|
| fSCLK                | fC   | Clock Frequency for all commands (FAST_READ, RDSFDP, PP, SE, BE, CE, DP, RES, RDP, WREN, WRDI, RDID, RDSR, WRSR) | D.C.                 |                                    | 104  | MHz  |
| fRSCLK               | fR   | Clock Frequency for READ instructions  |                      |                                    | 54   | MHz  |
| fTCLK                |      | Clock Frequency for DREAD, 2READ, QREAD, 4READ instructions  |                      |                                    | 84   | MHz  |
| tCH <sup>(1)</sup>   | tCLH | Clock High Time  | Others (fSCLK)       | 3.3                                |      | ns   |
|                      |      |  | Normal Read (fRSCLK) | 9                                  |      | ns   |
| tCL <sup>(1)</sup>   | tCLL | Clock Low Time   | Others (fSCLK)       | 3.3                                |      | ns   |
|                      |      |  | Normal Read (fRSCLK) | 9                                  |      | ns   |
| tCLCH <sup>(2)</sup> |      | Clock Rise Time (peak to peak)   | 0.1                  |                                    |      | V/ns |
| tCHCL <sup>(2)</sup> |      | Clock Fall Time (peak to peak)   | 0.1                  |                                    |      | V/ns |
| tSLCH                | tCSS | CS# Active Setup Time (relative to SCLK)   | 5                    |                                    |      | ns   |
| tCHSL                |      | CS# Not Active Hold Time (relative to SCLK)  | 7                    |                                    |      | ns   |
| tDVCH                | tDSU | Data In Setup Time   | 2                    |                                    |      | ns   |
| tCHDX                | tDH  | Data In Hold Time  | 3                    |                                    |      | ns   |
| tCHSH                |      | CS# Active Hold Time (relative to SCLK)  | 5                    |                                    |      | ns   |
| tSHCH                |      | CS# Not Active Setup Time (relative to SCLK)   | 5                    |                                    |      | ns   |
| tSHSL                | tCSH | CS# Deselect Time  | Read                 | 7                                  |      | ns   |
|                      |      |  | Write/Erase/Program  | 30                                 |      | ns   |
| tSHQZ <sup>(2)</sup> | tDIS | Output Disable Time  |                      |                                    | 8    | ns   |
| tCLQV                | tV   | Clock Low to Output Valid<br>Loading: 30pF/15pF  | Loading: 30pF        |                                    | 8    | ns   |
|                      |      |  | Loading: 15pF        |                                    | 6    | ns   |
| tCLQX                | tHO  | Output Hold Time   | 1                    |                                    |      | ns   |
| tDP <sup>(2)</sup>   |      | CS# High to Deep Power-down Mode   |                      |                                    | 10   | us   |
| tRES1 <sup>(2)</sup> |      | CS# High to Standby Mode without Electronic Signature Read   |                      |                                    | 30   | us   |
| tRES2 <sup>(2)</sup> |      | CS# High to Standby Mode with Electronic Signature Read  |                      |                                    | 30   | us   |
| tW                   |      | Write Status/Configuration Register Cycle Time   |                      |                                    | 40   | ms   |
| tBP                  |      | Byte-Program   |                      | 10                                 | 50   | us   |
| tPP                  |      | Page Program Cycle Time  |                      | 0.33                               | 1.2  | ms   |
| tPP <sup>(4)</sup>   |      | Page Program Cycle Time (n bytes)  |                      | 0.008+<br>(nx0.004) <sup>(5)</sup> | 1.2  | ms   |
| tSE                  |      | Sector Erase Cycle Time  |                      | 25                                 | 200  | ms   |
| tBE32                |      | Block Erase (32KB) Cycle Time  |                      | 140                                | 600  | ms   |
| tBE                  |      | Block Erase (64KB) Cycle Time  |                      | 250                                | 1000 | ms   |
| tCE                  |      | Chip Erase Cycle Time  |                      | 40                                 | 120  | s    |
| tWRK                 |      | Write Root Key Time  |                      | 180                                | 510  | us   |
| tUHK                 |      | Update HMAC Key Time   |                      | 315                                | 445  | us   |
| tIMC                 |      | Increment Monotonic Counter Time   |                      | 0.045                              | 300  | ms   |
| tRQMC                |      | Request Monotonic Counter Time   |                      | 65                                 | 105  | us   |
| tRSL                 |      | Suspend during OP1 command to suspend ready time   |                      | 20                                 |      | us   |
| tRSP                 |      | Resume to suspend timing for OP1 command   |                      | 1                                  |      | ms   |
| tESL <sup>(6)</sup>  |      | Erase Suspend Latency  |                      |                                    | 20   | us   |
| tPSL <sup>(6)</sup>  |      | Program Suspend Latency  |                      |                                    | 20   | us   |
| tPRS <sup>(7)</sup>  |      | Latency between Program Resume and next Suspend  | 0.3                  | 1000                               |      | us   |
| tERS <sup>(8)</sup>  |      | Latency between Erase Resume and next Suspend  | 0.3                  | 1000                               |      | us   |

| Symbol | Alt. | Parameter                  | Min. | Typ. | Max. | Unit |
|--------|------|----------------------------|------|------|------|------|
| tRCR   |      | Recovery Time from Read    | 20   |      |      | us   |
| tRCP   |      | Recovery Time from Program | 20   |      |      | us   |
| tRCE   |      | Recovery Time from Erase   | 12   |      |      | ms   |

## Notes:

1. tCH + tCL must be greater than or equal to 1/ Frequency.
2. Typical values given for TA=25°C. Not 100% tested.
3. Test condition is shown as [Figure 39](#) and [Figure 40](#).
4. While programming consecutive bytes, Page Program instruction provides optimized timings by selecting to program the whole 256 bytes or only a few bytes between 1~256 bytes.
5. "n"=how many bytes to program. In the formula, while n=1, byte program time=12us.
6. Latency time required to complete Erase/Program Suspend operation until WIP bit is "0".
7. For tPRS, Min. timing is needed to issue next program suspend command. However, a period of time equal to/or longer than typ. timing is also required to complete the program progress.
8. For tERS, Min. timing is needed to issue next erase suspend command. However, a period of time equal to/or longer than typ. timing is also required to complete the erase progress.

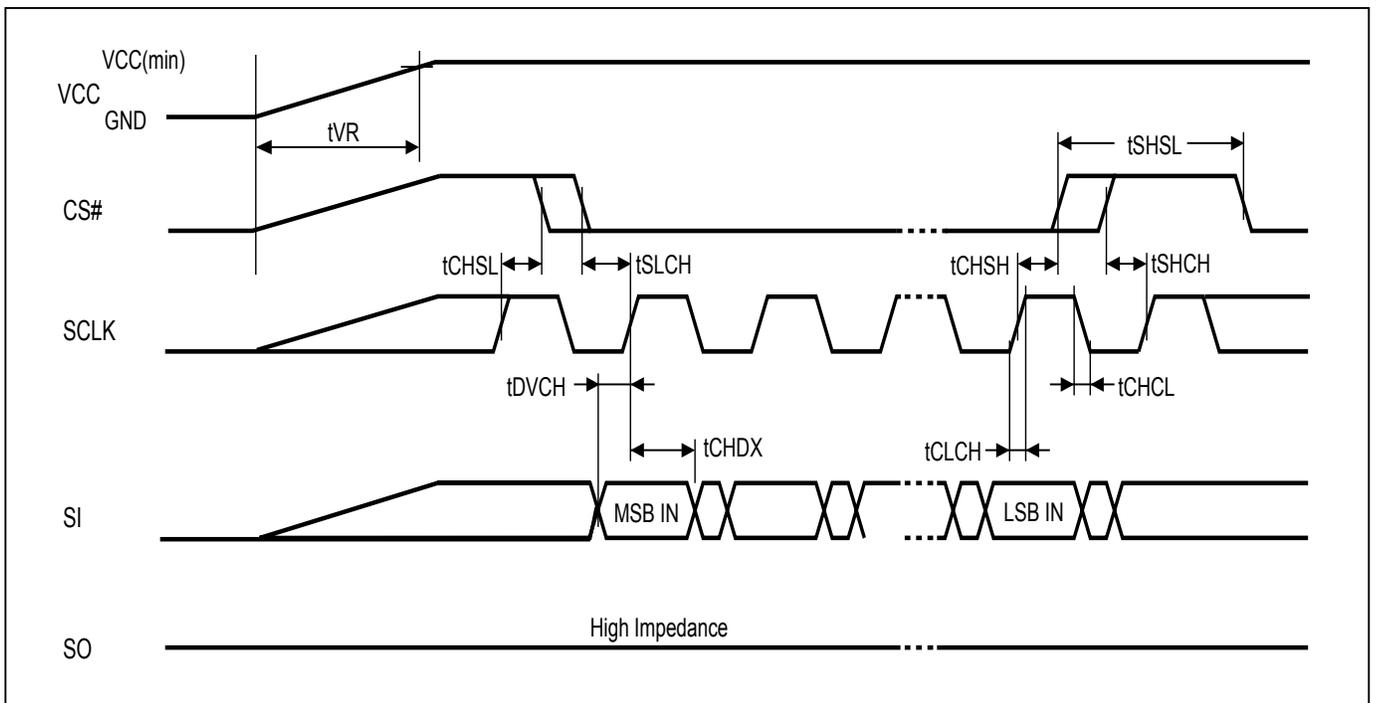
## 12. OPERATING CONDITIONS

### At Device Power-Up and Power-Down

AC timing illustrated in "Figure 41. AC Timing at Device Power-Up" and "Figure 42. Power-Down Sequence" are for the supply voltages and the control signals at device power-up and power-down. If the timing in the figures is ignored, the device will not operate correctly.

During power-up and power-down, CS# needs to follow the voltage applied on VCC to keep the device not to be selected. The CS# can be driven low when VCC reach Vcc(min.) and wait a period of tVSL.

**Figure 41. AC Timing at Device Power-Up**



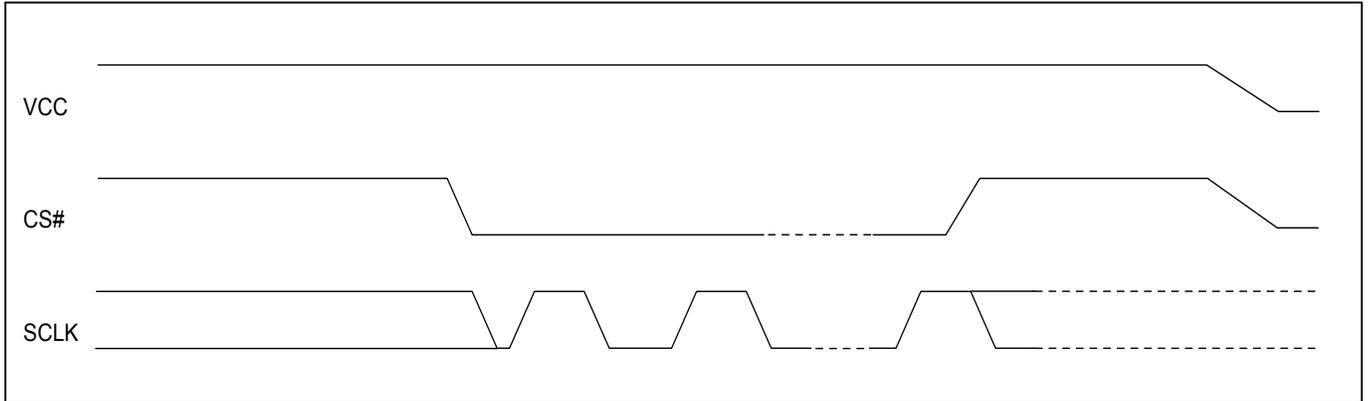
| Symbol | Parameter     | Notes | Min. | Max.   | Unit |
|--------|---------------|-------|------|--------|------|
| tVR    | VCC Rise Time | 1     | 20   | 500000 | us/V |

Notes :

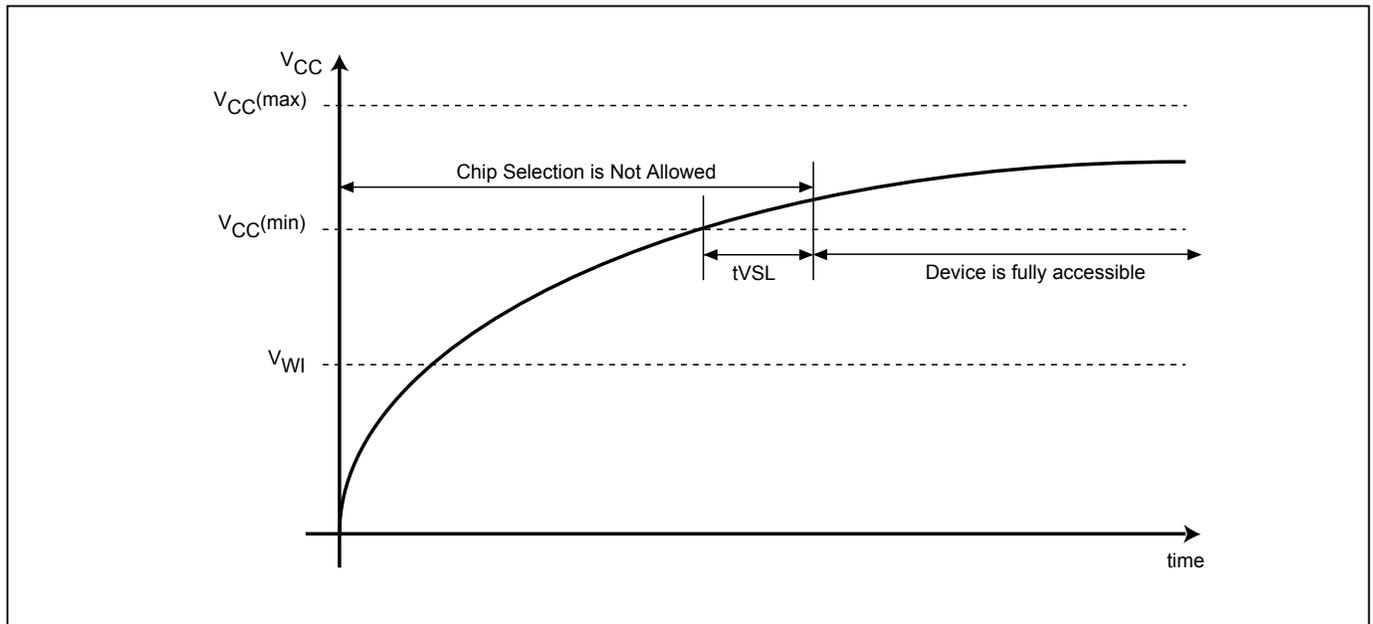
1. Sampled, not 100% tested.
2. For AC spec tCHSL, tSLCH, tDVCH, tCHDX, tSHSL, tCHSH, tSHCH, tCHCL, tCLCH in the figure, please refer to "Table 16. AC CHARACTERISTICS".

**Figure 42. Power-Down Sequence**

During power-down, CS# needs to follow the voltage drop on VCC to avoid mis-operation.

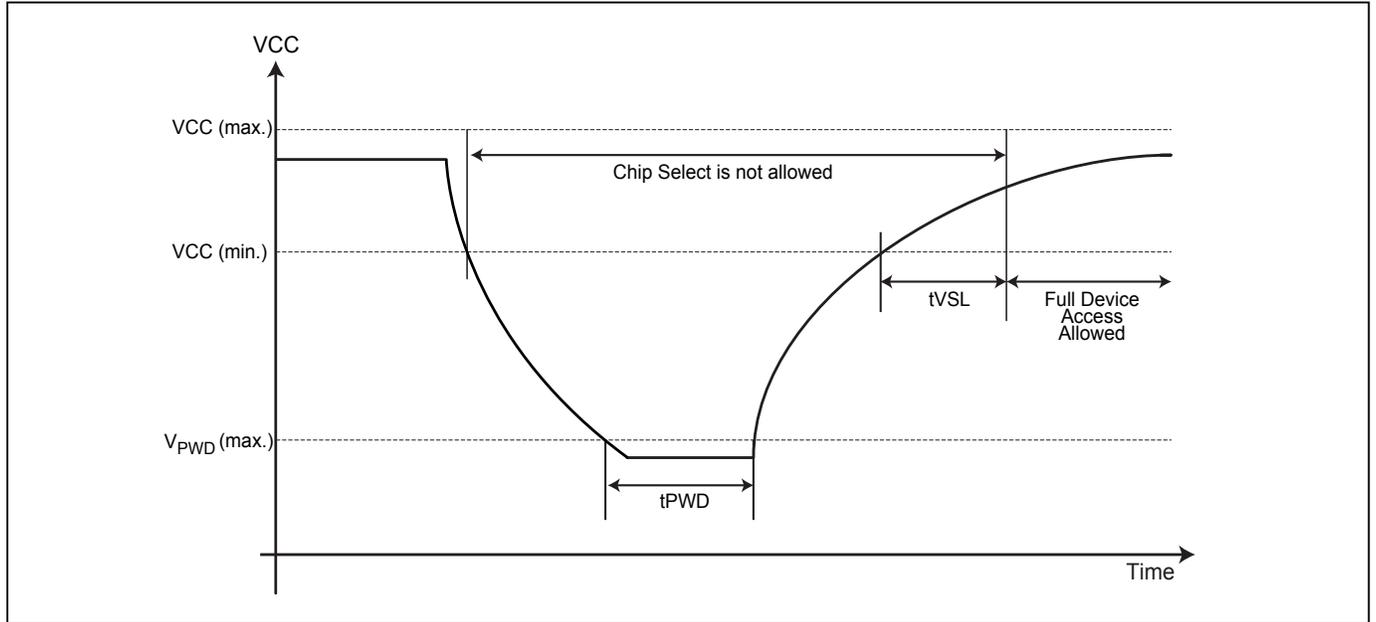


**Figure 43. Power-up Timing**



**Figure 44. Power Up/Down and Voltage Drop**

For Power-down to Power-up operation, the VCC of flash device must below  $V_{PVD}$  for at least  $t_{PVD}$  timing. Please check the table below for more detail.



**Table 17. Power-Up/Down Voltage and Timing**

| Symbol    | Parameter  | Min. | Max.   | Unit |
|-----------|--|------|--------|------|
| $t_{VSL}$ | VCC(min.) to device operation  | 800  |        | us   |
| VWI       | Write Inhibit Voltage  | 1.5  | 2.5    | V    |
| $V_{PVD}$ | VCC voltage needed to below $V_{PVD}$ for ensuring initialization will occur |      | 0.9    | V    |
| $t_{PVD}$ | The minimum duration for ensuring initialization will occur                  | 300  |        | us   |
| $t_{VR}$  | VCC Rise Time  | 20   | 500000 | us/V |
| VCC       | VCC Power Supply   | 2.7  | 3.6    | V    |

Note: These parameters are characterized only.

### 12-1. INITIAL DELIVERY STATE

The device is delivered with the memory array erased: all bits are set to 1 (each byte contains FFh). The Status Register contains 40h (all Status Register bits are 0, except QE bit: QE=1).

### 13. ERASE AND PROGRAMMING PERFORMANCE

| Parameter                                    | Min. | Typ. <sup>(1)</sup> | Max. <sup>(2)</sup> | Unit   |
|--|------|---------------------|---------------------|--------|
| Write Status Register Cycle Time             |      |                     | 40                  | ms     |
| Sector Erase Cycle Time (4KB)                |      | 25                  | 200                 | ms     |
| Block Erase Cycle Time (32KB)                |      | 0.14                | 0.6                 | s      |
| Block Erase Cycle Time (64KB)                |      | 0.25                | 1                   | s      |
| Chip Erase Cycle Time                        |      | 40                  | 120                 | s      |
| Byte Program Time (via page program command) |      | 10                  | 50                  | us     |
| Page Program Time                            |      | 0.33                | 1.2                 | ms     |
| Erase/Program Cycle                          |      | 100,000             |                     | cycles |

Note:

1. Typical program and erase time assumes the following conditions: 25°C, 3.3V, and all zero pattern.
2. Under worst conditions of 85°C and 2.7V.
3. System-level overhead is the time required to execute the first-bus-cycle sequence for the programming command.
4. The maximum chip programming time is evaluated under the worst conditions of 0°C, VCC=3.3V, and 100K cycle with 90% confidence level.

### 14. DATA RETENTION

| Parameter      | Condition | Min. | Max. | Unit  |
|----------------|-----------|------|------|-------|
| Data retention | 55°C      | 20   |      | years |

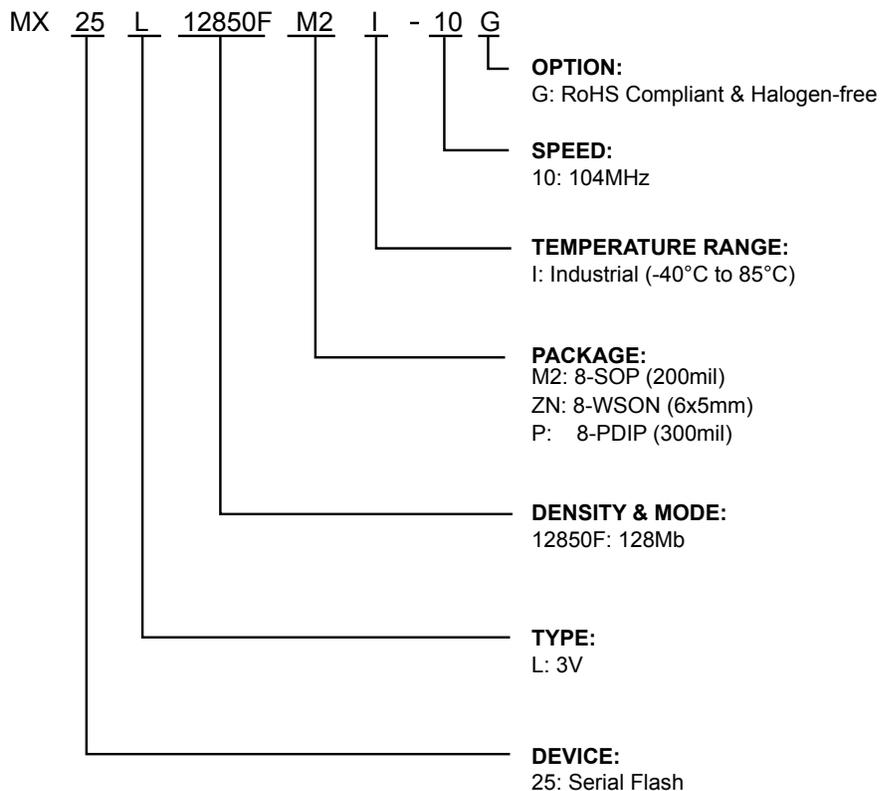
### 15. LATCH-UP CHARACTERISTICS

|   | Min.   | Max.       |
|---|--------|------------|
| Input Voltage with respect to GND on all power pins, SI, CS#                  | -1.0V  | 2 VCCmax   |
| Input Voltage with respect to GND on SO                                       | -1.0V  | VCC + 1.0V |
| Current   | -100mA | +100mA     |
| Includes all pins except VCC. Test conditions: VCC = 3.0V, one pin at a time. |        |            |

**16. ORDERING INFORMATION**

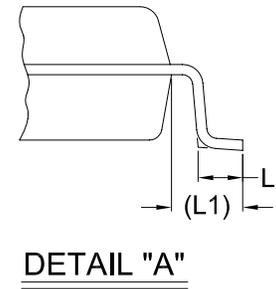
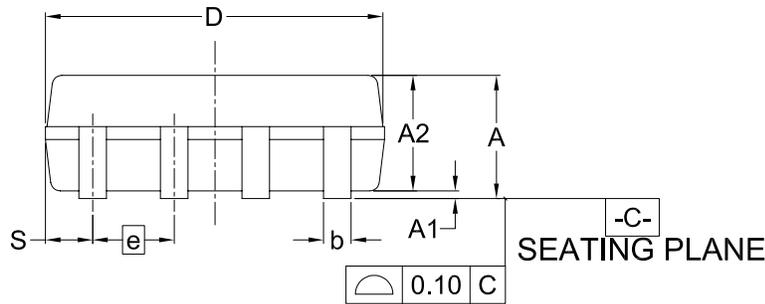
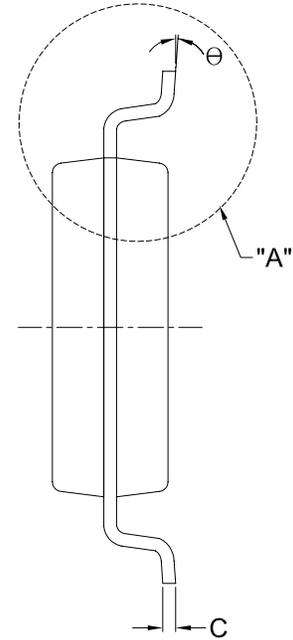
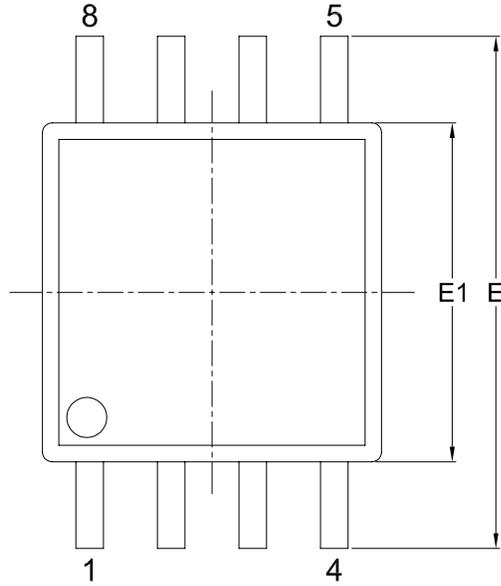
| PART NO.           | CLOCK (MHz) | TEMPERATURE | PACKAGE         | Remark |
|--------------------|-------------|-------------|-----------------|--------|
| MX25L12850FM2I-10G | 104         | -40°C~85°C  | 8-SOP (200mil)  |        |
| MX25L12850FZNI-10G | 104         | -40°C~85°C  | 8-WSON (6x5mm)  |        |
| MX25L12850FPI-10G  | 104         | -40°C~85°C  | 8-PDIP (300mil) |        |

## 17. PART NAME DESCRIPTION



**18. PACKAGE INFORMATION**

Doc. Title: Package Outline for SOP 8L 200MIL (official name - 209MIL)

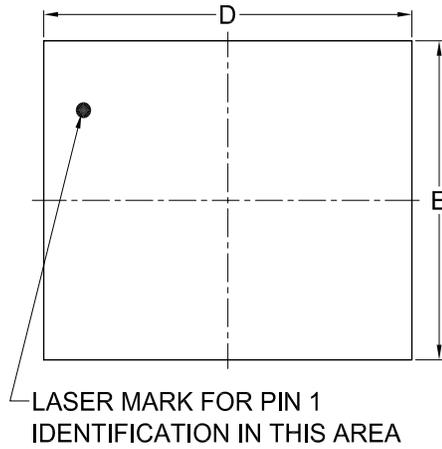


Dimensions (inch dimensions are derived from the original mm dimensions)

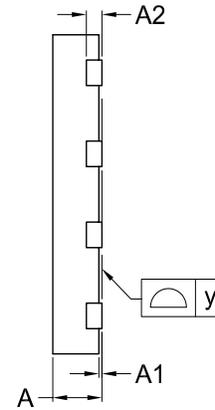
| SYMBOL |      | A     | A1    | A2    | b     | C     | D     | E     | E1    | e     | L     | L1    | S     | $\theta$ |
|--------|------|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|----------|
| UNIT   |      |       |       |       |       |       |       |       |       |       |       |       |       |          |
| mm     | Min. | 1.75  | 0.05  | 1.70  | 0.36  | 0.19  | 5.13  | 7.70  | 5.18  | --    | 0.50  | 1.21  | 0.62  | 0°       |
|        | Nom. | 1.95  | 0.15  | 1.80  | 0.41  | 0.20  | 5.23  | 7.90  | 5.28  | 1.27  | 0.65  | 1.31  | 0.74  | 5°       |
|        | Max. | 2.16  | 0.20  | 1.91  | 0.51  | 0.25  | 5.33  | 8.10  | 5.38  | --    | 0.80  | 1.41  | 0.88  | 8°       |
| Inch   | Min. | 0.069 | 0.002 | 0.067 | 0.014 | 0.007 | 0.202 | 0.303 | 0.204 | --    | 0.020 | 0.048 | 0.024 | 0°       |
|        | Nom. | 0.077 | 0.006 | 0.071 | 0.016 | 0.008 | 0.206 | 0.311 | 0.208 | 0.050 | 0.026 | 0.052 | 0.029 | 5°       |
|        | Max. | 0.085 | 0.008 | 0.075 | 0.020 | 0.010 | 0.210 | 0.319 | 0.212 | --    | 0.031 | 0.056 | 0.035 | 8°       |

| Dwg. No.  | Revision | Reference |      |  |
|-----------|----------|-----------|------|--|
|           |          | JEDEC     | EIAJ |  |
| 6110-1406 | 5        |           |      |  |

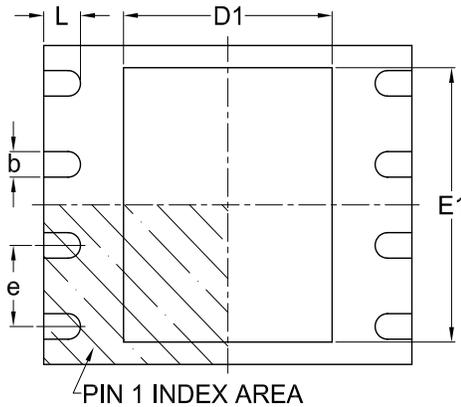
Doc. Title: Package Outline for WSON 8L (6x5x0.8MM, LEAD PITCH 1.27MM)



**TOP VIEW**



**SIDE VIEW**



**BOTTOM VIEW**

Note:

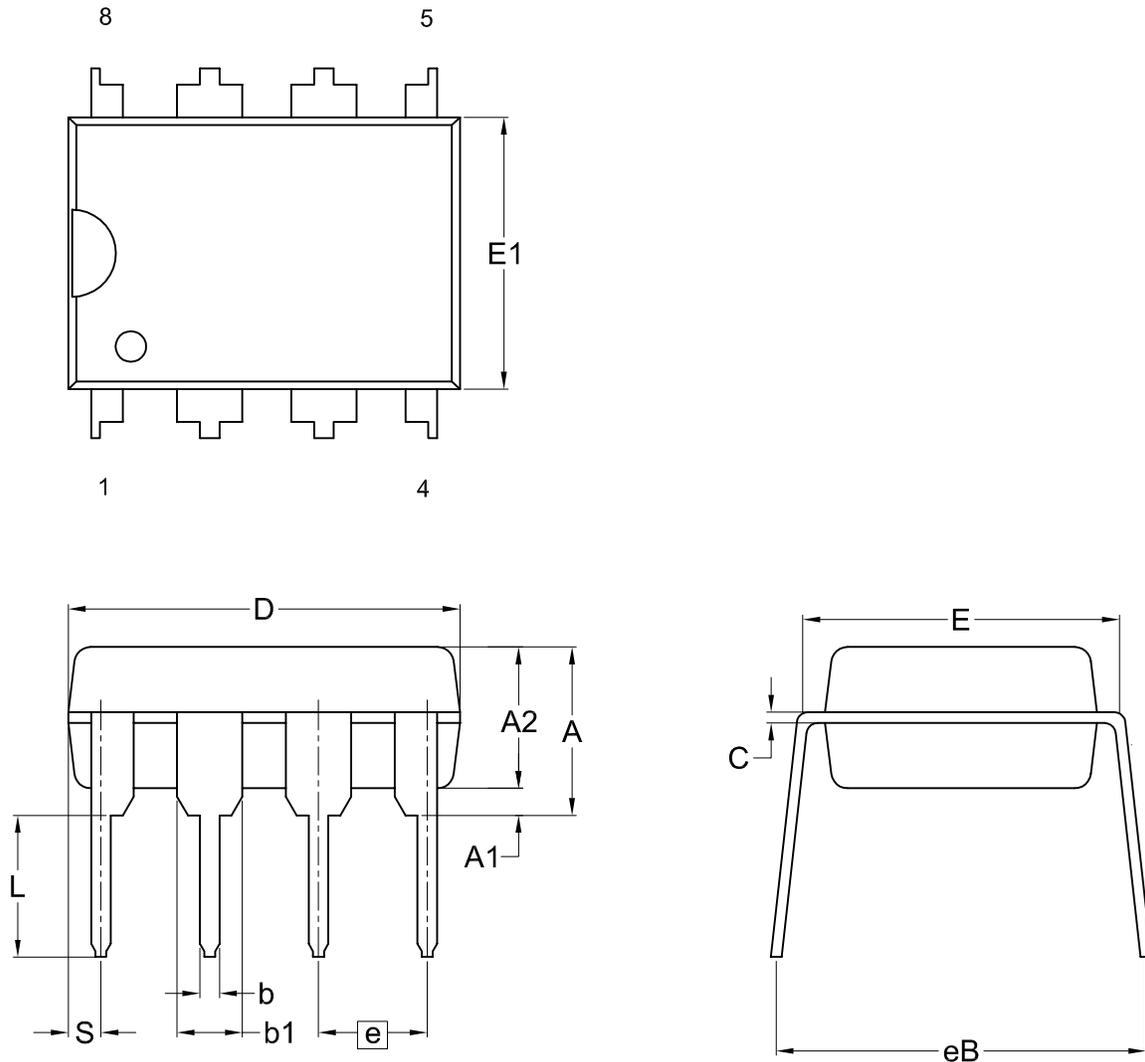
This package has an exposed metal pad underneath the package. It is recommended to leave the metal pad floating or to connect it to the same ground as the GND pin of the package. Do not connect the metal pad to any other voltage or signal line on the PCB. Avoid placing vias or traces underneath the metal pad. Connection of this metal pad to any other voltage or signal line can result in shorts and/or electrical malfunction of the device.

Dimensions (inch dimensions are derived from the original mm dimensions)

| SYMBOL |      | A     | A1    | A2    | b     | D     | D1    | E     | E1    | L     | e    | y     |
|--------|------|-------|-------|-------|-------|-------|-------|-------|-------|-------|------|-------|
| UNIT   |      |       |       |       |       |       |       |       |       |       |      |       |
| mm     | Min. | 0.70  | --    | --    | 0.35  | 5.90  | 3.30  | 4.90  | 3.90  | 0.50  | --   | 0.00  |
|        | Nom. | --    | --    | 0.20  | 0.40  | 6.00  | 3.40  | 5.00  | 4.00  | 0.60  | 1.27 | --    |
|        | Max. | 0.80  | 0.05  | --    | 0.48  | 6.10  | 3.50  | 5.10  | 4.10  | 0.75  | --   | 0.08  |
| Inch   | Min. | 0.028 | ---   | --    | 0.014 | 0.232 | 0.129 | 0.193 | 0.154 | 0.020 | --   | 0.00  |
|        | Nom. | --    | ---   | 0.008 | 0.016 | 0.236 | 0.134 | 0.197 | 0.157 | 0.024 | 0.05 | --    |
|        | Max. | 0.032 | 0.002 | --    | 0.019 | 0.240 | 0.138 | 0.201 | 0.161 | 0.030 | --   | 0.003 |

| Dwg. No.  | Revision | Reference |      |  |  |
|-----------|----------|-----------|------|--|--|
|           |          | JEDEC     | EIAJ |  |  |
| 6110-3401 | 6        | MO-220    |      |  |  |

Doc. Title: Package Outline for PDIP 8L (300MIL)



Dimensions (inch dimensions are derived from the original mm dimensions)

| SYMBOL |      | A     | A1    | A2    | b     | b1    | C     | D     | E     | E1    | e     | eB    | L     | S     |
|--------|------|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|
| UNIT   |      |       |       |       |       |       |       |       |       |       |       |       |       |       |
| mm     | Min. | —     | 0.38  | 3.18  | 0.36  | 1.14  | 0.20  | 9.02  | 7.62  | 6.22  | —     | 7.87  | 2.92  | 0.76  |
|        | Nom. | —     | —     | 3.30  | 0.46  | 1.52  | 0.25  | 9.27  | 7.87  | 6.35  | 2.54  | 8.89  | 3.30  | 1.14  |
|        | Max. | 5.33  | —     | 3.43  | 0.56  | 1.78  | 0.36  | 10.16 | 8.13  | 6.48  | —     | 9.53  | 3.81  | 1.52  |
| Inch   | Min. | ---   | 0.015 | 0.125 | 0.014 | 0.045 | 0.008 | 0.355 | 0.300 | 0.245 | —     | 0.310 | 0.115 | 0.030 |
|        | Nom. | ---   | —     | 0.130 | 0.018 | 0.060 | 0.010 | 0.365 | 0.310 | 0.250 | 0.100 | 0.350 | 0.130 | 0.045 |
|        | Max. | 0.210 | —     | 0.135 | 0.022 | 0.070 | 0.014 | 0.400 | 0.320 | 0.255 | —     | 0.375 | 0.150 | 0.060 |

| Dwg. No.  | Revision | Reference |      |  |
|-----------|----------|-----------|------|--|
|           |          | JEDEC     | EIAJ |  |
| 6110-0201 | 7        | MS-001    |      |  |

**19. REVISION HISTORY**

| <b>Revision No.</b> | <b>Description</b>  | <b>Page</b>  | <b>Date</b> |
|---------------------|---|--------------|-------------|
| 1.0                 | 1. Removed "Advanced Information"   | All          | DEC/08/2014 |
|                     | 2. Modified Support fast clock frequency for read operation                             | P4,72        |             |
|                     | 3. Added parameters name for Suspend/Resume   | P52,53,72,73 |             |
|                     | 4. Updated AC/DC and VWI values (Removed tWREAW)<br>and updated Sector Erase Cycle Time | P71,72,76,77 |             |
|                     | 5. Content correction   | P13,55,70,76 |             |



Except for customized products which has been expressly identified in the applicable agreement, Macronix's products are designed, developed, and/or manufactured for ordinary business, industrial, personal, and/or household applications only, and not for use in any applications which may, directly or indirectly, cause death, personal injury, or severe property damages. In the event Macronix products are used in contradicted to their target usage above, the buyer shall take any and all actions to ensure said Macronix's product qualified for its actual use in accordance with the applicable laws and regulations; and Macronix as well as it's suppliers and/or distributors shall be released from any and all liability arisen therefrom.

Copyright© Macronix International Co., Ltd. 2014. All rights reserved, including the trademarks and tradename thereof, such as Macronix, MXIC, MXIC Logo, MX Logo, Integrated Solutions Provider, NBit, Nbit, NBit, Macronix NBit, eLiteFlash, HybridNVM, HybridFlash, XtraROM, Phines, KH Logo, BE-SONOS, KSMC, Kingtech, MXSMIO, Macronix vEE, Macronix MAP, Rich Audio, Rich Book, Rich TV, and FitCAM. The names and brands of third party referred thereto (if any) are for identification purposes only.

For the contact and order information, please visit Macronix's Web site at: <http://www.macronix.com>